## feATURES

## - 36 Measurement Channels Monitor up to 144 Fuel

 Cells in Series- Channel Measurement Range: $\pm 5 \mathrm{~V}$
- Cell Stack Voltage Range: -80V to 150 V
- Operates from a Single 5V Supply
- Stackable Architecture Supports Large Fuel Cell Stacks
- Built-In isoSPITM Interface
- $1 \mathrm{MB} / \mathrm{s}$ Isolated Serial Communications
- Uses a Single Twisted Pair, Up to 100 Meters
- Low EMI Susceptibility and Emissions
- Bidirectional for Broken Wire Protection
- 15 mV Total Measurement Error
- 6.75 ms to Measure All Cells in a System
- Delta-Sigma Converter with Built-In Noise Filter
- Six General Purpose Digital I/O or Analog Inputs
- Temperature or Other Sensor Inputs
- $12 \mu \mathrm{~A}$ Sleep Mode Supply Current
-64-Lead LOFP Package
- AEC-Q100 Qualified for Automotive Applications


## APPLICATIONS

- Fuel Cell Electric and Hybrid Electric Vehicles
- Backup Power Systems
- High Power Portable Equipment

All registered trademarks and trademarks are the property of their respective owners. Protected by U.S. patents, including 8908779, 9270133.

## DESCRIPTIOn

The LTC®6806 is a fuel cell monitor that measures up to 144 Series Connected Fuel cells with a total measurement error of less than 15 mV . The LTC6806 includes 36 input channels, each with a $\pm 5 \mathrm{~V}$ measurement range allowing each channel to measure from 1 to 4 series-connected fuel cells.

All 36 inputs can be measured within 6.75 ms in fast ADC mode. Lower data acquisition rates can be selected for high noise reduction. In the normal ADC mode, all cells are measured within 10.3 ms , with a total measurement error of less than 15 mV .

Each LTC6806 has an isoSPI interface for high speed, RFimmune, Iong distance communications. Two communication modes are available by pin selection: in daisy-chain mode, multiple devices are connected in a daisy chain with one host processor connection for all devices; in parallel mode, multiple devices are connected in parallel to the host processor, with each device individually addressed.

Multiple LTC6806 devices can be connected in series, permitting simultaneous cell monitoring of very large fuel cell stacks. As shown in the typical application, twelve LTC6806s are connected in series to monitor 432 fuel cells. Alternatively, 432 cells can be monitored using six ICs by monitoring groups of two cells, or four ICs by monitoring groups of three cells.

## TYPICAL APPLICATION

432 Fuel Cells Monitored by 4, 6 or 12 LTC6806 ICs


## TAßLE Of CONTEחTS

Features ..... 1
Applications ..... 1
Typical Application ..... 1
Description ..... 1
Absolute Maximum Ratings ..... 3
Order Information ..... 3
Pin Configuration ..... 3
Electrical Characteristics ..... 4
Typical Performance Characteristics ..... 10
Pin Functions ..... 13
Block Diagram ..... 14
Operation ..... 15
State Diagram ..... 15
LTC6806 Core State Descriptions ..... 15
isoSPI State Descriptions ..... 16
Sleep Timer. ..... 16
Power Consumption ..... 16
ADC Operation ..... 17
Continuous Monitoring (MONITOR State) ..... 22
Data Acquisition System Diagnostics ..... 24
Serial Interface Overview ..... 28
4-Wire Serial Peripheral Interface (SPI) Physical Layer ..... 29
2-Wire Isolated Interface (IsoSPI) Physical Layer ..... 30
Data Link Layer ..... 38
Network Layer. ..... 39
Programming Examples ..... 53
Applications Information ..... 55
Providing DC Power. ..... 55
Digital Communications ..... 56
Configuring isoSPI Hardware ..... 58
Filtering of Cell and GPIO Inputs ..... 68
Enhanced Applications. ..... 70
Package Description ..... 73
Typical Application ..... 74
Related Parts ..... 74

## ABSOLUTE MAXIMUM RATINGS

(Note 1)
Voltage of C Pins Relative to $\mathrm{V}^{-}$:
for $\mathrm{n}=0$ to 12 $.-60 \mathrm{~V}<\mathrm{C}[\mathrm{n}]<75 \mathrm{~V}$
for $n=13$ to 24 $\qquad$ $-60 \mathrm{~V}<\mathrm{C}[\mathrm{n}]<105 \mathrm{~V}$
for $n=25$ to 36 $-80 \mathrm{~V}<\mathrm{C}[\mathrm{n}]<150 \mathrm{~V}$
Operating Temperature Range: $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$
GPIO Pins 49 to 54 Relative
to $\mathrm{V}^{-}$: $\qquad$ $-0.3 \mathrm{~V}<$ Pin Voltage $<\mathrm{V}^{+}+0.3 \mathrm{~V}$
All Other Pins
Relative to $\mathrm{V}^{-}$: $\qquad$ -0.3 V < Pin Voltage < 6.5V

## Current in/out of Pins:

All pins except for IPA, IMA, IPB, and IMB....... $<10 \mathrm{~mA}$
IPA, IMA, IPB, and IMB................................... $<30 \mathrm{~mA}$
Specified Junction Temperature Range
LTC6806I $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$
LTC6806H......................................... $40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$
Maximum Junction Temperature .......................... $150^{\circ} \mathrm{C}$
Storage Temperature Range .................. $65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$
Device HBM ESD Classification Level 3A
Device CDM ESD Classification Level C4A

## pIn COnfiGURATIOn



## ORDER INFORMATION

## AUTOMOTIVE PRODUCTS**

| TRAY (160PC) | TAPE AND REEL (1500PC) | PART MARKING* | PACKAGE DESCRIPTION | MSL RATING | SPECIFIED JUNCTION <br> TEMPERATURE RANGE |
| :--- | :--- | :--- | :--- | :---: | :--- |
| LTC6806ILW\#3ZZPBF | LTC6806ILW\#3ZZTRPBF | LTC6806LW | $64-$ Lead Plastic LQFP | 3 | $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ |
| LTC6806HLW\#3ZZPBF | LTC6806HLW\#3ZZTRPBF | LTC6806LW | $64-$ Lead Plastic LQFP | 3 | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ |

Contact the factory for parts specified with wider operating temperature ranges. *The temperature grade is identified by a label on the shipping container.
Tape and reel specifications. Some packages are available in 500 unit reels through designated sales channels with \#TRMPBF suffix.
**Versions of this part are available with controlled manufacturing to support the quality and reliability requirements of automotive applications. These models are designated with a \#3ZZ suffix. Only the automotive grade products shown are available for use in automotive applications. Contact your local Analog Devices account representative for specific product ordering information and to obtain the specific Automotive Reliability reports for these models.

ELECTRICAL CHARACTERISTICS The o denotes the speciifications which apply over the full speciited temperature range, otherwise specifications are at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$. The test conditions are $\mathrm{V}^{+}=+5.0 \mathrm{~V}$ unless otherwise noted. The ISOMD pin is tied to the $\mathrm{V}^{-}$pin, unless otherwise noted.


## ELECTRICAL CHARACTERISTICS The odenotes the speciifications which apply ver the full specified

 temperature range, otherwise specifications are at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$. The test conditions are $\mathrm{V}^{+}=+5.0 \mathrm{~V}$ unless otherwise noted. The ISOMD pin is tied to the $\mathrm{V}^{-}$pin, unless otherwise noted.| SYMBOL | PARAMETER | CONDITIONS |  | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| TME. 4 | Total Measurement Error (TME) of GPIO in Normal/Alternative/Filtered Modes | $\begin{aligned} & \text { GPIO(n) to } \mathrm{V}^{-}=+1.25 \mathrm{~V} \\ & \text { GPIO(n) to } \mathrm{V}^{-}=+1.25 \mathrm{~V} \end{aligned}$ | $\bullet$ | $\begin{aligned} & \hline-15 \\ & -20 \end{aligned}$ |  | $\begin{aligned} & \hline 15 \\ & 20 \end{aligned}$ | mV mV |
|  |  | $\begin{aligned} & \text { GPIO(n) to } \mathrm{V}^{-}=+2.5 \mathrm{~V} \\ & \text { GPIO(n) to } \mathrm{V}^{-}=+2.5 \mathrm{~V} \end{aligned}$ | $\bullet$ | $\begin{aligned} & \hline-25 \\ & -32 \end{aligned}$ |  | $\begin{aligned} & 25 \\ & 32 \end{aligned}$ | mV mV |
|  |  | $\begin{aligned} & \mathrm{GPIO}(\mathrm{n}) \text { to } \mathrm{V}^{-}=+4.2 \mathrm{~V}, \mathrm{~V}^{+}=4.75 \mathrm{~V} \\ & \mathrm{GPIO}(\mathrm{n}) \text { to } \mathrm{V}^{-}=+4.2 \mathrm{~V}, \mathrm{~V}^{+}=4.75 \mathrm{~V} \end{aligned}$ | $\bullet$ | $\begin{aligned} & \hline-42 \\ & -50 \end{aligned}$ |  | $\begin{aligned} & 42 \\ & 50 \end{aligned}$ | mV mV |
|  |  | $\begin{aligned} & \text { GPIO(n) to } \mathrm{V}^{-}=+5 \mathrm{~V}, \mathrm{~V}^{+}=5.5 \mathrm{~V} \\ & \mathrm{GPIO}(\mathrm{n}) \text { to } \mathrm{V}^{-}=+5 \mathrm{~V}, \mathrm{~V}^{+}=5.5 \mathrm{~V} \end{aligned}$ | $\bullet$ | $\begin{aligned} & \hline-42 \\ & -50 \end{aligned}$ |  | $\begin{aligned} & \hline 42 \\ & 50 \end{aligned}$ | mV mV |
|  | Total Measurement Error (TME) of Sum of Cells Normal/Alternate/Filtered Modes | Sum of Cells, VC36 $=150 \mathrm{~V}$ | $\bullet$ | -1.2 |  | 1.2 | \% |
|  |  | Sum of Cells, VC36 $=25 \mathrm{~V}$ | $\bullet$ | -2 |  | 2 | \% |
|  | Total Measurement Error (TME) of Junction Temperature in Normal/Alternate/Filtered Modes |  |  |  | $\pm 14.5$ |  | ${ }^{\circ} \mathrm{C}$ |
|  | Total Measurement Error (TME) of VREF2 in Normal/Alternative/Filtered Modes |  | $\bullet$ | -30 |  | 30 | mV |
| TME.1F | Total Measurement Error (TME) of Cell Inputs in Fast Mode, with HIRNG $=0$ | $\mathrm{C}(\mathrm{n})$ to $\mathrm{C}(\mathrm{n}-1)= \pm 1.25 \mathrm{~V}, \mathrm{VCx}>0 \mathrm{~V}$ | $\bullet$ | -95 |  | 95 | mV |
|  |  | $\mathrm{C}(\mathrm{n})$ to $\mathrm{C}(\mathrm{n}-1)= \pm 2.5 \mathrm{~V}, \mathrm{VCx}>0 \mathrm{~V}$ | $\bullet$ | -225 |  | 225 | mV |
|  |  | $\mathrm{C}(\mathrm{n})$ to $\mathrm{C}(\mathrm{n}-1)= \pm 2.5 \mathrm{~V}, \mathrm{VCx}>-5 \mathrm{~V}$ | $\bullet$ | -250 |  | 250 | mV |
| TME.3F | Total Measurement Error (TME) of $\mathrm{V}^{+}$ (Relative to $\mathrm{V}^{-}$) in Fast Mode |  | $\bullet$ | -120 |  | 120 | mV |
| TME.4F | Total Measurement Error (TME) of GPIO in Fast Mode | GPIO(n) to $\mathrm{V}^{-}=+1.25 \mathrm{~V}$ | $\bullet$ | -55 |  | 55 | mV |
|  |  | GPIO(n) to $\mathrm{V}^{-}=+2.5 \mathrm{~V}$ | $\bullet$ | -60 |  | 60 | mV |
|  |  | GPIO(n) to $\mathrm{V}^{-}=+4.2 \mathrm{~V}, \mathrm{~V}^{+}=4.75 \mathrm{~V}$ | $\bullet$ | -90 |  | 90 | mV |
|  | Total Measurement Error (TME) of Sum of Cells Fast Mode | Sum of Cells, VC36 $=150 \mathrm{~V}$ | $\bullet$ | -2.5 |  | 2.5 | \% |
|  | Total Measurement Error (TME) of Junction Temperature in Fast Mode |  |  |  | $\pm 20$ |  | ${ }^{\circ} \mathrm{C}$ |
|  | Total Measurement Error (TME) of VREF2 in Fast Mode |  |  |  | $\pm 75$ |  | mV |
|  | Input Voltage Range | $\mathrm{CO}-\mathrm{C13}$ to $\mathrm{V}^{-}$ | $\bullet$ | -5 |  | 60 | V |
|  |  | C14-C24 to $\mathrm{V}^{-}$ | $\bullet$ | -5 |  | 95 | V |
|  |  | C25-C36 to $\mathrm{V}^{-}$ | $\bullet$ | -5 |  | 140 | V |
|  |  | GPIO(n) $=1$ to $6, \mathrm{~V}^{+} \leq 5 \mathrm{~V}$ | $\bullet$ | 0 |  | $\mathrm{V}^{+}$ | V |
|  |  | GPIO(n) $=1$ to $6, \mathrm{~V}^{+}>5 \mathrm{~V}$ | $\bullet$ | 0 |  | 5 | V |
| LMM | Input Leakage Current ( $\mathrm{l}_{\mathrm{L}}$ ) when Inputs Are Being Measured | $\begin{aligned} & C(n) n=0 \text { to } 36, V_{C(n)}-V^{-}>5 V \\ & C(n) n=1 \text { to } 36, V_{C(n)}-V^{-}<5 V \\ & G P I O(n) n=1 \text { to } 6 \end{aligned}$ |  | $\begin{gathered} 5 \\ -550 \\ 5 \end{gathered}$ | $\begin{aligned} & 30 \\ & 10 \end{aligned}$ | $\begin{aligned} & 60 \\ & 60 \\ & 30 \end{aligned}$ | $\mu \mathrm{A}$ $\mu \mathrm{A}$ $\mu \mathrm{A}$ |
| lo | Input Leakage Current $\left(l_{L}\right)$ when Inputs Are Not Being Measured, in all modes | $C(n) n=0$ to $36, V_{C(n)}-V^{-}>5 V$ $C(n) n=1$ to $36, V_{C(n)}-V^{-}<5 V$ GPIO(n) $n=1$ to 6 | $\bullet$ | $\begin{aligned} & -1.6 \\ & -550 \end{aligned}$ | 0 | $\begin{gathered} 1.6 \\ 0 \\ 10 \end{gathered}$ | $\mu \mathrm{A}$ $\mu \mathrm{A}$ $\mu \mathrm{A}$ |
| LS | Input Leakage Current ( $\mathrm{l}_{\mathrm{L}}$ ) in SLEEP/ STANDBY mode | $\mathrm{C}(\mathrm{n}) \mathrm{n}=0$ to $36, \mathrm{~V}_{\mathrm{C}(\mathrm{n})}-\mathrm{V}^{-}>0 \mathrm{~V}$ | $\bullet$ | -1.6 | 0 | 1.6 | $\mu \mathrm{A}$ |

ELECTRICAL CHARACTERISTICS The • denotes the speciitications which apply over the full specified temperature range, otherwise specifications are at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$. The test conditions are $\mathrm{V}^{+}=+5.0 \mathrm{~V}$ unless otherwise noted. The ISOMD pin is tied to the $\mathrm{V}^{-}$pin, unless otherwise noted.

| SYMBOL | PARAMETER | CONDITIONS |  |  | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ILOPW | Additional Input Current During Open Wire Detection ( $n=1$ to 36 ) | $\mathrm{C}(\mathrm{n})$ to $\mathrm{V}^{-}=0 \mathrm{~V}, \mathrm{n} \neq 13$ or 24 , pull up current |  |  |  | -20 |  | $\mu \mathrm{A}$ |
|  |  | $\mathrm{C}(\mathrm{n})$ to $\mathrm{V}^{-}=0 \mathrm{~V}, \mathrm{n}=13$ and 24, pull up current |  |  |  | -40 |  | $\mu \mathrm{A}$ |
|  |  | $\mathrm{C}(\mathrm{n})$ to $\mathrm{V}^{-}=2 \mathrm{~V}, \mathrm{n}=13$ or 24 , pull up current |  |  |  | -8 |  | $\mu \mathrm{A}$ |
|  |  | $\mathrm{C}(\mathrm{n})$ to $\mathrm{V}^{-}=2 \mathrm{~V}, \mathrm{n}=13$ and 24 , pull up current |  |  |  | -16 |  | $\mu \mathrm{A}$ |
|  |  | $\mathrm{C}(\mathrm{n})$ to $\mathrm{V}^{-}=2 \mathrm{~V}, \mathrm{n} \neq 13$ or 24 , pull down current |  |  |  | 8 |  | $\mu \mathrm{A}$ |
|  |  | $\mathrm{C}(\mathrm{n})$ to $\mathrm{V}^{-}=2 \mathrm{~V}, \mathrm{n}=13$ and 24, pull down current |  |  |  | 16 |  | $\mu \mathrm{A}$ |
|  |  | $C(n)$ to $\mathrm{V}^{-}=4 \mathrm{~V}, \mathrm{n}=13$ or 24 , pull down current |  |  |  | 18 |  | $\mu \mathrm{A}$ |
|  |  | $\mathrm{C}(\mathrm{n})$ to $\mathrm{V}^{-}=4 \mathrm{~V}, \mathrm{n}=13$ and 24 , pull down current |  |  |  | 36 |  | $\mu \mathrm{A}$ |
|  |  | $\mathrm{C}(\mathrm{n})$ to $\mathrm{V}^{-} \geq 6 \mathrm{~V}, \mathrm{n} \neq 13$ or 24 , pull down current |  | $\bullet$ | 4 | 25 | 50 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{C}(\mathrm{n})$ to $\mathrm{V}^{-} \geq 6 \mathrm{~V}, \mathrm{n}=13$ and 24 , pull down current |  | $\bullet$ | 4 | 50 | 100 | $\mu \mathrm{A}$ |
| Voltage Reference Specifications |  |  |  |  |  |  |  |  |
| $\mathrm{V}_{\text {REF1 }}$ | $1^{\text {st }}$ Reference Voltage | $V_{\text {REF1 }}$ Pin, No Load |  | $\bullet$ | 2.700 | 3.060 | 3.300 | V |
|  | $1^{\text {st }}$ Reference Voltage TC | $V_{\text {REF1 }}$ Pin, No Load |  |  |  | 10 |  | $\mathrm{ppm} /{ }^{\circ} \mathrm{C}$ |
|  | $1^{\text {st }}$ Reference Voltage Hysteresis | $V_{\text {REF1 }}$ Pin, No Load |  |  |  | 100 |  | ppm |
|  | $1^{\text {st }}$ Reference Voltage Long Term Drift | $V_{\text {REF1 }}$ Pin, No Load |  |  |  | 60 |  | $\mathrm{ppm} / \sqrt{\mathrm{khr}}$ |
| $\mathrm{V}_{\text {REF2 }}$ | $2^{\text {nd }}$ Reference Voltage | $V_{\text {REF2 }}$ Pin, No Load <br> $V_{\text {ReF2 }}$ Pin, 1 mA Load to $\mathrm{V}^{-}$ |  | $\bullet$ | $\begin{aligned} & 2.300 \\ & 2.200 \end{aligned}$ | $\begin{aligned} & \hline 2.500 \\ & 2.500 \end{aligned}$ | $\begin{aligned} & 2.700 \\ & 2.700 \end{aligned}$ | V |
|  | $2^{\text {nd }}$ Reference Voltage TC | $V_{\text {REF2 }}$ Pin, No Load |  |  |  | 40 |  | ppm $/{ }^{\circ} \mathrm{C}$ |
|  | $2^{\text {nd }}$ Reference Voltage Hysteresis | $V_{\text {REF2 }}$ Pin, No Load |  |  |  | 500 |  | ppm |
|  | $2{ }^{\text {nd }}$ Reference Voltage Long Term Drift | $V_{\text {REF2 }}$ Pin, No Load |  |  |  | 500 |  | $\mathrm{ppm} / \sqrt{\mathrm{khr}}$ |
| General DC Specifications |  |  |  |  |  |  |  |  |
| $\mathrm{lv}^{+}$ | $\mathrm{V}^{+}$Supply Current (see Figure 1) | SLEEP Mode, Serial = OFF |  | $\bullet$ |  | 12 | 25 | $\mu \mathrm{A}$ |
|  |  | STANDBY Mode, Serial $=$ OFF |  | $\bullet$ |  | 0.5 | 0.85 | mA |
|  |  | REFUP Mode, Serial = OFF |  | $\bullet$ |  | 2.25 | 3.1 | mA |
|  |  | MEASURE/MONITOR Modes, Serial = OFF |  | $\bullet$ |  | 4.25 | 5.75 | mA |
|  | Additional ${ }^{+}$Supply Current if isoSPI in READY/ACTIVE States Note: Active State Current Assumes $\mathrm{t}_{\mathrm{CLK}}=1 \mu \mathrm{~s}$. (Note 3 ) | $\begin{aligned} & \text { LTC6806, DCMD = 0, ISOMD = } 1 \\ & \mathrm{R}_{\mathrm{B} 1}+\mathrm{R}_{\mathrm{B} 2}=2 \mathrm{k} \end{aligned}$ | READY | $\bullet$ | 3.6 | 4.5 | 5.4 | mA |
|  |  |  | ACTIVE | $\bullet$ | 4.6 | 5.8 | 7.0 | mA |
|  |  | $\begin{aligned} & \text { LTC6806, DCMD }=1, \text { ISOMD }=0 \\ & R_{B 1}+R_{B 2}=2 k \end{aligned}$ | READY | $\bullet$ | 3.6 | 4.5 | 5.2 | mA |
|  |  |  | ACTIVE | $\bullet$ | 5.6 | 6.8 | 8.1 | mA |
|  |  | $\begin{aligned} & \mathrm{LTC6806}, \mathrm{DCMD}=1, \mathrm{ISOMD}=1 \\ & \mathrm{R}_{\mathrm{B} 1}+\mathrm{R}_{\mathrm{B} 2}=2 \mathrm{k} \end{aligned}$ | READY | $\bullet$ | 4.0 | 5.2 | 6.5 | mA |
|  |  |  | ACTIVE | $\bullet$ | 7.0 | 8.5 | 10.5 | mA |
|  |  | $\begin{aligned} & \text { LTC6806, DCMD }=0, I S O M D=1 \\ & R_{B 1}+R_{B 2}=20 \mathrm{k} \end{aligned}$ | READY | $\bullet$ | 1.0 | 1.8 | 2.6 | mA |
|  |  |  | ACTIVE | $\bullet$ | 1.2 | 2.2 | 3.2 | mA |
|  |  | $\begin{aligned} & \text { LTC6806, DCMD }=1, \text { ISOMD }=0 \\ & R_{B 1}+R_{B 2}=20 k \end{aligned}$ | READY | $\bullet$ | 1.0 | 1.8 | 2.4 | mA |
|  |  |  | ACTIVE | $\bullet$ | 1.3 | 2.3 | 3.3 | mA |
|  |  | $\begin{aligned} & \text { LTC6806, DCMD }=1, I S O M D=1 \\ & R_{B 1}+R_{B 2}=20 \mathrm{k} \end{aligned}$ | READY | $\bullet$ | 1.6 | 2.5 | 3.5 | mA |
|  |  |  | ACTIVE | $\bullet$ | 1.8 | 3.1 | 4.8 | mA |
| $\overline{\text { V SUP }}$ | $\mathrm{V}^{+}$Supply Voltage Where TME Specifications Are Met |  |  | $\bullet$ | 4.75 | 5 | 5.5 | V |

## ELECTRICAL CHARACTERISTICS The odenotes the speciifications which apply ver the full specified

 temperature range, otherwise specifications are at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$. The test conditions are $\mathrm{V}^{+}=+5.0 \mathrm{~V}$ unless otherwise noted. The ISOMD pin is tied to the $\mathrm{V}^{-}$pin, unless otherwise noted.| SYMBOL | PARAMETER | CONDITIONS |  | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ADC Timing Specifications |  |  |  |  |  |  |  |
| TCYCLE <br> (Figure 4) | Calibration Cycle + Measure Time when Starting from the REFUP State, MD $=00$ (Note 6) | ADCV 1 Cell <br> ADCV/CVST 36 Cells <br> ADAX/ADSTAT 1 Channel <br> ADAX/AXST 7 Channels <br> ADSTAT/STATST/ADAXSC 3 Channels <br> ADCVSC 37 Channels |  |  | $\begin{aligned} & \hline 0.38 \\ & 6.75 \\ & 0.25 \\ & 0.95 \\ & 0.48 \\ & 7.16 \end{aligned}$ |  | ms ms ms ms ms ms |
|  | Calibration Cycle + Measure Time when Starting from the REFUP State, MD = 01 (Note 6) | ADCV 1 Cell <br> ADCV/CVST 36 Cells <br> ADAX/ADSTAT 1 Channel <br> ADAX/AXST 7 Channels <br> ADSTAT/STATST/ADAXSC 3 Channels <br> ADCVSC 37 Channels |  |  | $\begin{gathered} \hline 0.57 \\ 10.30 \\ 0.44 \\ 1.72 \\ 0.87 \\ 11.00 \end{gathered}$ |  | ms ms ms ms ms ms |
|  | Calibration Cycle + Measure Time when Starting from the REFUP State, MD $=10$ (Note 6) | ADCV 1 Cell <br> ADCV/CVST 36 Cells <br> ADAX/ADSTAT 1 Channel <br> ADAX/AXST 7 Channels <br> ADSTAT/STATST/ADAXSC 3 Channels <br> ADCVSC 37 Channels |  |  | $\begin{gathered} \hline 0.83 \\ 15.03 \\ 0.70 \\ 2.75 \\ 1.38 \\ 16.12 \end{gathered}$ |  | ms ms ms ms ms ms |
|  | Calibration Cycle + Measure Time when Starting from the REFUP State, MD $=11$ (Note 6) | ADCV 1 Cell ADCV/CVST 36 Cells ADAX/ADSTAT 1 Channel ADAX/AXST 7 Channels ADSTAT/STATST/ADAXSC 3 Channels ADCVSC 37 Channels |  |  | $\begin{gathered} \hline 2.36 \\ 43.45 \\ 2.23 \\ 8.89 \\ 4.46 \\ 46.84 \end{gathered}$ |  | ms ms ms ms ms ms |
| TMONITOR | Monitor Cycle Time when Starting from the REFUP State (Note 6) | $\begin{aligned} & \text { MM }=01 \\ & M M=10 \\ & M M=11 \end{aligned}$ |  |  | $\begin{aligned} & 11.15 \\ & 16.40 \\ & 47.89 \end{aligned}$ |  | ms ms ms |
| T DIAGNOSE | DIAGN Time when Starting from the REFUP State (Note 6) |  |  |  | 0.60 |  | ms |
| twaKe | Wake Up Time |  | $\bullet$ |  | 100 | 300 | $\mu \mathrm{S}$ |
| tsLEEP | Sleep Timeout |  | $\bullet$ |  | 1.5 |  | S |
| $t_{\text {REFUP }}$ | Reference Wake-Up Time | $\begin{aligned} & \text { State: Core = STANDBY (Note 6) } \\ & \text { State: Core = REFUP } \end{aligned}$ | $\bullet$ | 5.6 | 6.8 | $\begin{aligned} & 8 \\ & 0 \end{aligned}$ | ms ms |
| $\mathrm{f}_{\text {S }}$ | Clock Frequency |  | $\bullet$ | 1.7 | 2.0 | 2.5 | MHz |

Pin DC Specifications

| $\mathrm{V}_{\text {IH }}$ | Digital Input Voltage High | Pins CSB_IMA, SCK_IPA, SDI_ICMP, IBIAS_A0, ICMP_A1, IMB_A2, IPB_A3 when DCMD $=0$ Pins ISOMD, DCMD, GPIO[1:6] | $\bullet$ | 2.0 |  |  | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| VIL | Digital Input Voltage Low | Pins CSB_IMA, SCK_IPA, SDI_ICMP, IBIAS_A0, ICMP_A1, IMB_A2, IPB_A3 when DCMD = 0 Pins ISOMD, DCMD, GPIO[1:6] | $\bullet$ |  |  | 0.8 | V |
| $l_{\text {LEAK(DIG) }}$ | Digital Input Current | Pins CSB_IMA, SCK_IPA, SDI_ICMP, IBIAS_AO, ICMP_A1, IMB_A2, IPB_A3 when DCMD = 0 Pins ISOMD, DCMD, GPIO[1:6] | $\bullet$ |  |  | $\pm 5$ | $\mu \mathrm{A}$ |
| $\mathrm{V}_{\text {OL }}$ | Digital Output Low | Pins SDO, GPIO[1:6] Sinking 1mA | $\bullet$ |  |  | 0.1 | V |
| isoSPI DC Specifications |  |  |  |  |  |  |  |
| $V_{\text {BIAS }}$ | Voltage on IBIAS Pin | READY/ACTIVE State IDLE State | $\bullet$ | 1.9 | $\begin{gathered} 2.0 \\ 0 \end{gathered}$ | 2.1 | V |
| IB | Isolated Interface Bias Current | $\mathrm{R}_{\mathrm{B}}=2 \mathrm{k}$ 的 $20 \mathrm{k} \Omega$ | $\bullet$ | 0.1 |  | 1.0 | mA |

## LTC6806

ELECTRICAL CHARACTERISTICS The • denotes the specifications which apply over the full specified temperature range, otherwise specifications are at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$. The test conditions are $\mathrm{V}^{+}=+5.0 \mathrm{~V}$ unless otherwise noted. The ISOMD pin is tied to the $\mathrm{V}^{-}$pin, unless otherwise noted.

| SYMBOL | PARAMETER | CONDITIONS |  | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $A_{\text {IB }}$ | Isolated Interface Current Gain | $\begin{array}{ll}V_{\text {TCMP }} \leq 1.6 \mathrm{~V} & \\ & \mathrm{I}_{\mathrm{B}}=1 \mathrm{~mA} \\ & \mathrm{I}_{\mathrm{B}}=0.1 \mathrm{~mA}\end{array}$ | $\bullet$ | $\begin{aligned} & 18 \\ & 18 \end{aligned}$ | $\begin{aligned} & 20 \\ & 20 \end{aligned}$ | $\begin{aligned} & 23 \\ & 26 \end{aligned}$ | $\mathrm{mA} / \mathrm{mA}$ $\mathrm{mA} / \mathrm{mA}$ |
| VA | Transmitter Pulse Amplitude | $V A=\left\|V_{\text {IP }}-V_{\text {IM }}\right\|$ | $\bullet$ |  |  | 1.6 | V |
| $V$ ICMP | Threshold-Setting Voltage on ICMP Pin | $\mathrm{V}_{\text {TCMP }}=\mathrm{A}_{\text {TCMP }} \bullet \mathrm{V}_{\text {ICMP }}$ | $\bullet$ | 0.2 |  | 1.5 | V |
| ILEAK(ICMP) | Input Leakage Current on ICMP Pin | $\mathrm{V}_{\text {TCMP }}=0 \mathrm{~V}$ to $\mathrm{V}^{+}$ | $\bullet$ |  |  | $\pm 1$ | $\mu \mathrm{A}$ |
| ILEAK(IP/IM) | Leakage Current on IP and IM Pins | IDLE State, $\mathrm{V}_{\mathrm{IP}}$ or $\mathrm{V}_{\mathrm{IM}}=0 \mathrm{~V}$ to $\mathrm{V}^{+}$ | $\bullet$ |  |  | $\pm 1$ | $\mu \mathrm{A}$ |
| ATCMP $^{\text {den }}$ | Receiver Comparator Threshold Voltage Gain | $\begin{aligned} & \mathrm{V}_{\mathrm{CM}}=\mathrm{V}^{+} / 2 \text { to } \mathrm{V}^{+}-0.2 \mathrm{~V}, \\ & \mathrm{~V}_{\text {ICMP }}=0.2 \mathrm{~V} \text { to } 1.5 \mathrm{~V} \end{aligned}$ | $\bullet$ | 0.4 | 0.5 | 0.6 | V/V |
| $\mathrm{V}_{\text {CM }}$ | Receiver Common Mode Bias | IP/IM Not Driving |  |  | /3 |  | V |
| $\mathrm{R}_{\text {IN }}$ | Receiver Input Resistance | Single-Ended to IPA, IMA, IPB, IMB | $\bullet$ | 26 | 35 | 45 | k $\Omega$ |
| isoSPI Idle/Wake up Specifications |  |  |  |  |  |  |  |
| $V_{\text {WAKE }}$ | Differential Wake-Up Voltage | $\mathrm{t}_{\text {DWELL }}=240 \mathrm{~ns}$ | $\bullet$ | 250 |  |  | mV |
| $t_{\text {DWELL }}$ | Dwell Time at $\mathrm{V}_{\text {waKe }}$ Before Wake Detection |  | $\bullet$ | 240 |  |  | ns |
| $t_{\text {READY }}$ | Start-Up Time After Wake Detection |  | $\bullet$ |  |  | 10 | $\mu \mathrm{S}$ |
| $\mathrm{t}_{\text {IDLE }}$ | Idle Timeout Duration | (Note 6) | $\bullet$ |  | 10 |  | ms |

isoSPI Pulse Timing Specifications

| $\mathrm{t}_{1 / 2 \text { PW(CS }}$ | Chip-Select Half-Pulse Width | Transmitter | $\bullet$ | 120 | 150 | 180 |
| :--- | :--- | :--- | :--- | :---: | :---: | :---: |
| $\mathrm{t}_{\text {FILT(CS }}$ | Chip-Select Signal Filter | Receiver | $\bullet$ | 70 | 90 | 110 |
| $\mathrm{t}_{\text {INV(CS }}$ | Chip-Select Pulse Inversion Delay | Transmitter | $\bullet$ | 120 | 155 | 190 |
| $\mathrm{t}_{\text {WNDW(CS) }}$ | Chip-Select Valid Pulse Window | Receiver | $\bullet$ | 220 | 270 | 330 |
| $\mathrm{t}_{1 / 2 \mathrm{PW}(D)}$ | Data Half-Pulse Width | Transmitter | $\bullet$ | 40 | 50 | 60 |
| $\mathrm{t}_{\text {FIIT(D) }}$ | Data Signal Filter | Receiver | $\bullet$ | 10 | 25 | 35 |
| $\mathrm{t}_{\text {INV(D) }}$ | Data Pulse Inversion Delay | Transmitter | $\bullet$ | 40 | 55 | 65 |
| $\mathrm{t}_{\text {WNDW(D) }}$ | Data Valid Pulse Window | Receiver | $\bullet$ | 70 | 90 | 110 |

## SPI Timing Requirements (See Figure 18)

| $\mathrm{t}_{\text {LLK }}$ | SCK Period | (Note 4) | $\bullet$ | 1 | $\mu \mathrm{~s}$ |
| :--- | :--- | :--- | :--- | :--- | :---: |
| $\mathrm{t}_{1}$ | SDI Setup Time Before SCK Rising Edge |  | $\bullet$ | 25 | ns |
| $\mathrm{t}_{2}$ | SDI Hold Time After SCK Rising Edge |  | $\bullet$ | 25 | ns |
| $\mathrm{t}_{3}$ | SCK Low | $\mathrm{T}_{\text {CLK }=\mathrm{t}_{3}+\mathrm{t}_{4} \geq 1 \mu \mathrm{~s}}$ | ns |  |  |
| $\mathrm{t}_{4}$ | SCK High | $\mathrm{T}_{\text {CLK }=\mathrm{t}_{3}+\mathrm{t}_{4} \geq 1 \mu \mathrm{~s}}$ | $\bullet$ | 200 | ns |
| $\mathrm{t}_{5}$ | CSB Rising Edge to CSB Falling Edge |  | $\bullet$ | 200 | $\mu \mathrm{~s}$ |
| $\mathrm{t}_{6}$ | SCK Rising Edge to CSB Rising Edge | (Note 4) | $\bullet$ | 0.65 | $\mu \mathrm{~s}$ |
| $\mathrm{t}_{7}$ | CSB Falling Edge to SCK Rising Edge | (Note 4) | $\bullet$ | 0.8 | $\mu \mathrm{~s}$ |
| $\mathrm{t}_{8}$ | SCK Falling Edge to SDO Valid | (Note 5) | $\bullet$ | 1 | ns |

## isoSPI Timing Specifications

| $t_{9}$ | SCK Rising Edge to Short $\pm 1$ Transmit |  | $\bullet$ |  | 50 |
| :--- | :--- | :--- | :--- | :--- | :---: |
| $\mathrm{t}_{10}$ | CSB Transition to Long $\pm 1$ Transmit |  | $\bullet$ | ns |  |
| $\mathrm{t}_{11}$ | CSB Rising Edge to SDO Rising | (Note 5) | $\bullet$ | 60 | ns |
| $t_{\text {RTN }}$ | Data Return Delay |  | $\bullet$ | 325 | 375 |
| $t_{\text {DSY(CS) }}$ | Chip-Select Daisy-Chain Delay |  | $\bullet$ | 425 | ns |

ELECTRICAL CHARACTERISTICS The $\bullet$ denotes the speciifications which apply vere the full specified temperature range, otherwise specifications are at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$. The test conditions are $\mathrm{V}^{+}=+5.0 \mathrm{~V}$ unless otherwise noted. The ISOMD pin is tied to the $\mathrm{V}^{-}$pin, unless otherwise noted.

| SYMBOL | PARAMETER | CONDITIONS | MIN | TYP | MAX | UNITS |  |
| :--- | :--- | :--- | :--- | :---: | :---: | :---: | :---: |
| $t_{D S Y(D)}$ | Data Daisy-Chain Delay |  | $\bullet$ | 200 | 250 | 300 | ns |
| $t_{\text {LAG }}$ | Data Daisy-Chain Lag (vs. Chip-Select) |  | $\bullet$ | 0 | 35 | 70 | ns |
| $\mathrm{t}_{5(\mathrm{GOV})}$ | Chip-Select High-to-Low Pulse Governor |  | $\bullet$ | 0.6 | 0.82 | $\mu \mathrm{~S}$ |  |
| $\mathrm{t}_{6(\text { GOV })}$ | Data to Chip-Select Pulse Governor |  | $\bullet$ | 0.8 | 1.05 | $\mu \mathrm{~S}$ |  |
| $\mathrm{t}_{\text {BLOCK }}$ | isoSPI Port Reversal Blocking Window |  | $\bullet$ | 2 | 10 | $\mu \mathrm{~S}$ |  |

Note 1: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime. CO ABS MAX is tested at $\pm 30 \mathrm{~V}$ due to test equipment limitation. It is designed to be the same as C 1 to C 12 .
Note 2: The ADC specifications are guaranteed by the Total Measurement Error specification.
Note 3: The ACTIVE state current is calculated from DC measurements. The ACTIVE state current is the additional supply current into $\mathrm{V}^{+}$when there is continuous communications on the isoSPI ports with $50 \%$ data 1 's and 50\% data 0's. The calculations are based on the test circuits \#1 and \#2 which use 2 isoSPI ports. The ACTIVE state current is $50 \%$ less when using 1 isoSPI port. See Applications Information section for additional details.
Note 4: These timing specifications are dependent on the delay through the cable, and include allowances for 50 ns of delay each direction. 50 ns
corresponds to 10 m of CAT5 cable (which has a velocity of propagation of $66 \%$ the speed of light). Use of longer cables would require derating these specs by the amount of additional delay.
Note 5: These specifications do not include rise or fall time of SDO. While fall time (typically 5 ns due to the internal pull-down transistor) is not a concern, rising-edge transition time $t_{\text {RISE }}$ is dependent on the pull-up resistance and load capacitance on the SDO pin. The time constant must be chosen such that SDO meets the setup time requirements of the MCU.
Note 6: These times vary inversely with $\mathrm{f}_{\mathrm{S}}$.
Note 7: TME is defined as the difference between the voltages at the pins and the cell measurements as reported by the LTC6806.
Note 8: VCx is the common mode voltage with respect to $\mathrm{V}^{-}$at the measured input pins $\mathrm{C}(\mathrm{n})$ or $\mathrm{C}(\mathrm{n}-1)$.
Note 9: A "72V Stack" configuration refers to 36 series fuel cells connected to the LTC6806 with an average cell voltage of 2 V per cell.

## LTC6806

TYPICAL PERFORMANCE CHARACTERISTICS $T_{A}=25^{\circ}$, uness onemwise noted.


## TYPICAL PGRFORMANCE CHARACTERISTICS $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, unless otherwise noted.




TME vs Cell Common Mode
Voltage, HIRNG Mode



Supply Current vs Supply Voltage, MEASURE Mode


Supply Current vs Supply Voltage, REFUP Mode


Supply Current vs Supply Voltage, SLEEP Mode


Supply Current vs Supply Voltage, STANDBY Mode


## LTC6806

TYPICAL PERFORMANCE CHARACTERISTICS $T_{A}=25^{\circ}$, uness onemwise noted.







## PIn functions

CO-C36: Cell input. When using fewer than 36 inputs, it is recommended to populate the highest cell channels first with unused lower C pins shorted to $\mathrm{V}^{+}$. CO must be connected to a supply voltage, and may be connected to any potential within its absolute maximum operating range including the $\mathrm{V}^{+}$and $\mathrm{V}^{-}$pins. It is recommended that CO be connected to $\mathrm{V}^{+}$in order to provide the best accuracy on inputs at lower common mode voltage. If the fuel cell input resistance is larger than 100 ohm, connecting CO to $\mathrm{V}^{+}$will also prevent cell input leakage current from influencing bottom fuel cells' voltages. To allow very negative fuel cell stack voltage (<-80V), minimize cell input leakage current, and maximize cell measurement accuracy, it is recommended to connect a 10 k resistor (or larger depending on application) in parallel with a schottky diode between CO and $\mathrm{V}^{+}$. The anode of the schottky diode is tied to $\mathrm{V}^{+}$.
$\mathbf{V}^{+}$: Positive Power Supply Input. Supply voltage should be between 4.75 V and 5.50 V with a bypass capacitor of at least $1 \mu \mathrm{~F}$ connected to $\mathrm{V}^{-}$, within 1 cm of the supply leads.
$\mathbf{V}^{-}, \mathbf{V}^{-*}$ : Negative supply pins. The $\mathbf{V}^{-*}$ pin mustbe shorted to the $\mathrm{V}^{-}$pin external to the IC.
$\mathbf{V}_{\text {REF2: }}$ Secondary Voltage Reference. Buffered to drive up to 4 thermistors. Bypass with an external $1 \mu \mathrm{~F}$ capacitor.
$\mathbf{V}_{\text {REF1 }}$ : ADC Reference Voltage. Bypass with an external $1 \mu \mathrm{~F}$ capacitor. No DC loads allowed.
GPIO[1:6]: General Purpose I/O. Can be used as digital inputs or digital outputs, or as analog inputs with a measurement range from $\mathrm{V}^{-}$to 5 V . Pin voltage may not exceed the positive supply voltage applied to $\mathrm{V}^{+}$. When used as a digital output, these pins are open-drain outputs and a pull-up resistor of 1 M should be connected between the GPIO pin and $\mathrm{V}^{+}$.
ISOMD: Serial Interface Mode Pin. Connecting ISOMD to $\mathrm{V}^{+}$configures Pins 57 to 60 of the LTC6806 for 2-wire isolated interface (isoSPI) mode. Connecting ISOMD to $\mathrm{V}^{-}$configures the LTC6806 for 4-wire SPI mode.

DCMD: Daisy-Chain Mode Pin. Connecting DCMD to $\mathrm{V}^{+}$ configures the LTC6806 for daisy-chained multiple chip operation. Connecting DCMDto $V^{-}$configures the LTC6806 for parallel multiple chip operation.

Serial Port Pins:The serial port pins are configurable depending on the state of the DCMD and ISOMD pins as outlined in Table 1.
Table 1. Serial Port Pins

|  | DAISY-CHAIN MODE <br> (DCMD $=\mathbf{V}^{+}$) |  | PARALLEL MODE <br> ( $\mathbf{D C M D}=\mathbf{V}^{-}$) |  |
| :--- | :---: | :---: | :---: | :---: |
|  | ISOMD $=\mathbf{V}^{+}$ | ISOMD $=\mathbf{V}^{-}$ | ISOMD $=\mathbf{V}^{+}$ | ISOMD $=\mathbf{V}^{-}$ |
| PORT B <br> (Pins 61 <br> to 64) | IPB | IPB | A3 | A3 |
|  | IMB | IMB | A2 | A2 |
|  | ICMP | ICMP | A1 | A1 |
|  | IBIAS | IBIAS | A0 | A0 |
| PORT A <br> (Pins 57 <br> to 60) | (NC) | SD0 | IBIAS | SD0 |
|  | (NC) | SDI | ICMP | SDI |
|  | IPA | SCK | IPA | SCK |
|  | IMA | CSB | IMA | CSB |

CSB, SCK, SDI, SDO: 4-Wire Serial Peripheral Interface (SPI). Active low chip select (CSB), serial clock (SCK) and serial data in (SDI) are digital inputs. Serial data out (SDO) is an open drain NMOS output pin. SDO requires a pull-up resistor. A less than 5k ohm resistor is recommended.

A0 to A3: Address Pins. These digital inputs must be connected to $\mathrm{V}^{+}$or $\mathrm{V}^{-}$to set the chip address for addressable serial commands

IPA, IMA: Isolated 2-Wire Serial Interface Port A. IPA (plus) and IMA (minus) are a differential input/output pair.

IPB, IMB: Isolated 2-Wire Serial Interface Port B. IPB (plus) and IMB (minus) are a differential input/output pair.
IBIAS: Isolated Interface Current Bias. Tie IBIAS to $\mathrm{V}^{-}$through a resistor divider to set the interface output current level. When the isoSPI interface is enabled, the IBIAS pin voltage is 2 V . The IPA/IMA or IPB/IMB output current drive is set to 20 times the current, $\mathrm{I}_{\mathrm{B}}$, sourced from the IBIAS pin.

ICMP: Isolated Interface Comparator Voltage Threshold Set. Tie this pin to the resistor divider between IBIAS and $\mathrm{V}^{-}$to set the voltage threshold of the isoSPI receiver comparators. The comparator thresholds are set to half the voltage on the ICMP pin.

## LTC6806

## BLOCK DIAGRAM



## OPERATION

## STATE DIAGRAM

The operation of LTC6806 is divided into two separate sections: the core circuit and the isoSPI circuit. Both sections have an independent set of operating states, as well as a shutdown timeout.


Figure 1. LTC6806 Operation State Diagram

## LTC6806 CORE STATE DESCRIPTIONS

## SLEEP State

The reference, oscillator and ADC modulator are off. The sleep timer has timed out. The isoSPI ports will be in the IDLE state. The supply currents are reduced to minimum levels. If a WAKEUP signal is received (see Waking Up the Serial Interface), the LTC6806 will enter the STANDBY state.

## STANDBY State

The oscillator is turned on. The reference and ADC modulator are still off. The sleep timer is running. If the REFON bit is set, or a valid ADC command is received, or monitor mode is enabled, the IC goes to REFUP. Otherwise, if the serial interface remains idle, then the LTC6806 will return to SLEEP after tsLEEP.

## REFUP State

The IC is ready for ADC conversions. The reference is on. The ADC modulator is off. The sleep timer is running. If a
valid ADC command is received, the IC will go to MEASURE to begin the conversion. If monitor mode is enabled, the IC will go to MONITOR to begin monitoring. Otherwise if the serial interface remains idle, then the LTC6806 will return to SLEEP after $\mathrm{t}_{\text {SLEEP }}$.

## MEASURE State

The IC is performing ADC conversions. The reference and ADC modulator are powered up. After the conversions are done, the IC will return to REFUP and if REFON bit is 0 , the IC will then return to STANDBY.

## MONITOR State

The IC is continuously performing ADC conversions and using GPIO[4:6] to indicate fault conditions. The reference and ADC modulator are on. Monitoring will continue until either the Sleep Timeout occurs or the MMD bits in the configuration register group are written to 00 . In the MONITOR state the sleep timer may be disabled by driving GPIO3 to $\mathrm{V}^{-}$.

## LTC6806

## OPERATION

## isoSPI STATE DESCRIPTIONS

## IDLE State

The isoSPI ports are powered down.
When isoSPI Port A or Port B receives a WAKEUP signal (see Waking Up the Serial Interface), the isoSPI enters the READY state. This transition happens quickly (within $t_{\text {READY }}$ ) if the Core is in the STANDBY state. If the Core is in the SLEEP state when the isoSPI receives a WAKEUP signal, then it transitions to the READY state within twake.

## READY State

The isoSPI port(s) are ready for communication. Port B is enabled when DCMD is tied to $\mathrm{V}^{+}$. The serial interface current in this state depends on the status of the DCMD pin, the status of the ISOMD pin and $R_{B I A S}=R_{B 1}+R_{B 2}$ (the external resistors tied to the IBIAS pin).
If there is no activity (i.e. no WAKEUP signal) on Port A or Port B for greater than $\mathrm{I}_{\text {IDLE }}$, the LTC6806 goes to the IDLE state. When the serial interface is transmitting or receiving data, the LTC6806 goes to the ACTIVE state.

## ACTIVE State

The LTC6806 is transmitting/receiving data using one or both of the isoSPI ports. The serial interface consumes maximum power in this state. The supply current increases with clock frequency as the density of isoSPI pulses increases.

## SLEEP TIMER

When there are no WAKEUP signals on the SPI or isoSPI ports formore than 1.5 seconds, the Sleep Timeoutexpires.
The Sleep Timeout initializes the configuration register to its power-up default value. This will initialize the GPIOx pin control bits to logic 1's so that the LTC6806 will not drive the GPIO pins low. It will also clear the REFON, MMD and FCHNL bits. The core will transition to the SLEEP state and the serial ports will be in the IDLE state.

When the core is in the MONITOR state, the sleep timer can be disabled by tying GPI03 to $\mathrm{V}^{-}$. In this way, the device can continue monitoring indefinitely, without requiring serial communication to reset the sleep timer.

## POWER CONSUMPTION

The power consumption varies according to the operational states. Table 2 and Table 3 provide equations to approximate the supply pin currents in each state.
Table 2. Core Supply Current

|  | $\mathbf{I}_{\mathbf{V}+}$ |
| :---: | :---: |
| SLEEP | $12 \mu \mathrm{~A}$ |
| STANDBY | $500 \mu \mathrm{~A}$ |
| REFUP | 2.25 mA |
| MEASURE | 4.25 mA |
| MONITOR | 4.25 mA |

Table 3. isoSPI Supply Current Equations

| $\begin{aligned} & \text { isoSPI } \\ & \text { STATE } \end{aligned}$ | DCMD | ISOMD | $\mathrm{I}_{\text {REG(isoSPI) }}$ |
| :---: | :---: | :---: | :---: |
| IDLE |  |  | 0 mA |
| READY |  | High | $2 \mathrm{~mA}+3 \cdot \mathrm{I}_{\mathrm{B}}$ |
|  |  | Low | $1.5 \mathrm{~mA}+3 \cdot \mathrm{I}_{\mathrm{B}}$ |
|  | Low | High | $1.5 \mathrm{~mA}+3 \cdot \mathrm{I}_{\mathrm{B}}$ |
|  | Low | Low | 0 mA |
| ACTIVE | High | High | Write: $2 \mathrm{~mA}+\left(3+20 \cdot \frac{100 \mathrm{~ns}}{\mathrm{t}_{\mathrm{CLK}}}\right) \cdot \mathrm{I}_{\mathrm{B}}$ Read: $2 \mathrm{~mA}+\left(3+20 \cdot \frac{100 \mathrm{~ns} \cdot 1.5}{\mathrm{t}_{\mathrm{CLK}}}\right) \cdot \mathrm{I}_{\mathrm{B}}$ |
|  |  | Low | $1.5 \mathrm{~mA}+\left(3+20 \cdot \frac{100 \mathrm{~ns}}{\mathrm{t}_{\mathrm{CLK}}}\right) \cdot \mathrm{I}_{\mathrm{B}}$ |
|  | Low | High | Write: $\quad 1.5 \mathrm{~mA}+3 \cdot \mathrm{I}_{\mathrm{B}}$ <br> Read: $1.5 \mathrm{~mA}+\left(3+20 \cdot \frac{100 \mathrm{~ns} \cdot 0.5}{\mathrm{t}_{\mathrm{CLK}}}\right) \cdot \mathrm{I}_{\mathrm{B}}$ |
|  |  | Low | OmA |

## OPERATION

## ADC OPERATION

A single ADC inside the LTC6806 is used to convert all ADC channels.

## ADC Input Stage

The input stage of the LTC6806 consists of a commongate stage with $150 \mathrm{k} \Omega$ series resistance leading to the cell input pins. To accommodate negative common mode measurement, various clamp circuits are implemented at the front end, as shown in Figure 2.

1. When a cell is being measured, all switches in Figure 2 are closed. If the cell common mode voltage is above $\mathrm{V}^{+}$, all diodes are reverse biased and the cell input sinks approximately $35 \mu \mathrm{~A}$ bias current. If the cell common
mode drops below $\mathrm{V}^{+}$, additional current is sourced into the cell input as diode paths to $\mathrm{V}^{+}$turn on.
2. When a cell is not being measured, and the part is in MEASURE/MONITOR/REFUP mode, switch NOT SLEEP is closed but all other switches are open. The cell input current is typically zero, unless the cell common mode voltage drops below $\mathrm{V}^{+}$, causing additional current to be sourced through diodes D10, D11, D20, and D21. If the cell common mode voltage drops below $\mathrm{V}^{-}$, additional current can be sourced through diode D12 and D22.
3. InSLEEP/STANDBY mode, all switches are open. The cell input current is typically zero, unless the cell common mode voltage drops below $\mathrm{V}^{-}$turning on the current path through D12 and D22.


Figure 2. Input Stage Conceptual Block Diagram

## OPERATION

## ADC Modes

The ADC has four modes of operation. The accuracy and timing of these modes are summarized in Table 4. In each mode, the ADC first performs a single calibration measurement and then measures the inputs.

## Normal Mode

In this mode, the ADC has high resolution and low TME (total measurement error) using an oversampling ratio of 128. This is considered the normal operating mode because of the optimum combination of speed and accuracy.

## Alternate Mode

In this mode, the ADC-3dB frequency is lowered to 800 Hz by increasing the oversampling ratio.

## Filtered Mode

In this mode, the ADC -3 dB frequency is lowered to 200 Hz by increasing the oversampling ratio.

## Fast Mode

In this mode, the ADC has maximum throughput.
The increase in speed comes from a reduction in the oversampling ratio with a resulting increase in noise and average TME (total measurement error).

The conversion times for these modes are provided in the Electrical Characteristics table. If the core is in the STANDBY state, an additional $t_{\text {REFUP }}$ time is required to power up the reference before beginning the ADC conversions. The reference can remain powered up between ADC conversions, ifthe REFON bit in the Configuration Register Group is set to 1 . This avoids having to wait for the $t_{\text {REFUP }}$ delay before beginning additional ADC conversions.

Table 4. ADC Modes

| MODE | OVERSAMPLING RATIO <br> (OSR) | $\mathbf{3 6 - C E L L}$ <br> MEASUREMENT TIME | -3 dB <br> FILTER BW | -40 dB <br> FILTER BW | TME SPEC ${ }^{\boldsymbol{1}}$ |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Filtered | 1024 | 43.45 ms | 0.2 kHz | 1.25 kHz | $\pm 20.0 \mathrm{mV}$ |
| Alternate | 256 | 15.04 ms | 0.8 kHz | 5 kHz | $\pm 20.0 \mathrm{mV}$ |
| Normal | 128 | 10.30 ms | 1.6 kHz | 10 kHz | $\pm 20.0 \mathrm{mV}$ |
| Fast | 32 | 6.75 ms | 6.4 kHz | 40 kHz | $\pm 95 \mathrm{mV}$ |

1. TME is the Total Measurement Error, which includes all error sources. This spec is taken from the Electrical Characteristics table for Cell Measurements with HIRNG $=0$, reading +1.25 V .
2. OSR is the oversampling ratio selected.

## operation

## ADC Range and Resolution

Delta-Sigma ADCs have quantization noise which depends on the input voltage, especially at low oversampling ratios (OSR), such as in FAST mode. In some of the ADC modes, the quantization noise increases as the input voltage approaches the upper and lower limits of the ADC range. For example, the quantization noise versus input voltage in normal and fast modes is shown in Figure 3.


Figure 3. Quantization Noise vs Input Voltage

In Table 5, the precision range of the ADC is arbitrarily defined as the range where the quantization noise is relatively constant even in the lower OSR modes (see Figure 3). Table 5 summarizes the total noise in this range for different inputs.

## ADC Range vs Voltage Reference Value

Typical ADCs have a range which is exactly twice the value of the voltage reference, and the ADC measurement error is directly proportional to the error in the voltage reference. The LTC6806 ADC is nottypical. The absolute value of $\mathrm{V}_{\text {REF1 }}$ is trimmed up/down to compensate for gain errors in the ADC. Therefore, the ADC total measurement error (TME) specifications are superior to the $\mathrm{V}_{\text {REF1 }}$ specifications.

## Measuring Cell Voltages (ADCV Command)

The ADCV command initiates the measurement of the cell inputs, pins CO through C36. This command has options to select the channel(s) to measure and the ADC mode. See the section on Commands for the ADCV command format.

Figure 4 illustrates the timing of the ADCV command as it measures all 36 cells. The ADC is calibrated before

Table 5. ADC Range and Resolution

| MEASUREMENT | FULL RANGE | PRECISION RANGE ${ }^{1}$ | LSB | FORMAT | MAX <br> NOISE | EFFECTIVE RESOLUTION |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Cells HIRNG $=1$ | -6.114 V to +6.114V | -5V to 5V | 3 mV | 2's Complement 12 Bits | 2 mV P-P | 12 Bits |
| $\begin{gathered} \text { Cells } \\ \text { HIRNG }=0 \end{gathered}$ | -3.072 V to +3.072V | -2.5 V to 2.5 V | 1.5 mV | 2's Complement 12 Bits | 1 mV P-P | 12 Bits |
| GPIOs | OV to +5.572V | OV to 5V | 1.5 mV | Binary 12 Bits Readings < OV Report OV | $1 \mathrm{mV} \mathrm{P}_{\text {- }}$ | 12 Bits |
| $\mathrm{V}^{+}$ | n/a | 4.5 V to 5.5 V | 1.875 mV | Binary 12 Bits Readings < OV Report OV | $2 \mathrm{~m} \mathrm{~V}_{\mathrm{P}-\mathrm{P}}$ | 9 Bits |
| Sum of Cells | OV to 150V | 10 V to 150V | 108mV | Binary 12 Bits Readings < OV Report OV | 144 mV P-P | 10 Bits |
| Internal Temperature | n/a | $-40^{\circ} \mathrm{C}$ to $130^{\circ} \mathrm{C}$ | 0.4 K | Binary 12 Bits Please See Measuring Internal Device Parameters (ADSTAT Command) for Scaling Equation | 0.3K | 9 Bits |

1. PRECISION RANGE is the range over which the $V_{p-p}$ noise is less than MAX NOISE.
2. EFFECTIVE RESOLUTION $=$ ROUND $\left(L O G\left[\frac{[P R E C I S I O N ~ R A N G E ~}{M A X N O I S E}\right] / L O G[2]\right)$.

## LTC6806

## operation

measuring the cells to cancel offset errors. Table 6 shows the conversion times for the ADCV command measuring all 36 cells. Figure 5 illustrates the timing of the ADCV
command as it measures one cell. Table 7 shows the conversion times for the ADCV command measuring one cell.


Figure 4. Timing for ADCV Command Measuring All 36 Cells
Table 6. Conversion Timing for ADCV Command Measuring All 36 Cells in Different Modes

| CONVERSION TIMING (in $\mu \mathrm{s}$ ) |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| MODE | $\mathrm{T}_{0}$ | Tc | $\mathrm{T}_{\mathrm{M} 1}$ | $\mathrm{T}_{\mathrm{M} 2}$ | $\mathrm{T}_{\text {M }}$ | $\mathrm{T}_{\text {M4 }}$ | $\mathrm{T}_{\text {M } 36}$ |
| Filtered | 0 | 1168 | $1168+1174$ | $1168+2 \cdot 1174$ | $1168+3 \cdot 1174$ | $1168+4 \cdot 1174$ | $1168+36 \cdot 1174$ |
| Alternate | 0 | 400 | $400+406$ | $400+2 \cdot 406$ | $400+3 \cdot 406$ | $400+4 \cdot 406$ | $400+36 \cdot 406$ |
| Normal | 0 | 272 | $272+278$ | $272+2 \cdot 278$ | $272+3 \cdot 278$ | $272+4 \cdot 278$ | $272+36 \cdot 278$ |
| Fast | 0 | 176 | 176+182 | $176+2 \cdot 182$ | $176+3 \cdot 182$ | $176+4 \cdot 182$ | $176+36 \cdot 182$ |



Figure 5. Timing for ADVC Command Measuring 1 Cell

Table 7. Conversion Times for ADCV Command Measuring 1 Cell in Different Modes

| CONVERSION TIMING (in $\boldsymbol{\mu}$ ) |  |  |  |
| :---: | :---: | :---: | :---: |
| MODE | $\mathbf{T}_{\mathbf{0}}$ | $\mathbf{T}_{\mathbf{C}}$ | $\mathbf{T}_{\mathbf{M}}$ |
| Filtered | 0 | 1168 | $1168+1174$ |
| Alternate | 0 | 400 | $400+406$ |
| Normal | 0 | 272 | $272+278$ |
| Fast | 0 | 176 | $176+182$ |

## OPERATION

## Under/Overvoltage Monitoring

Whenever the C inputs are measured, the results are compared to undervoltage and overvoltage thresholds stored in memory. A flag is set if the cell measurement is above the overvoltage limit. Similarly, a different flag is set if the cell measurement is below the undervoltage limit. In the MEASURE state (measurements are initiated by ADC commands), the undervoltage and overvoltage thresholds are applied with no hysteresis. When the LTC6806 is in the MONITOR state (continuous measurements), the thresholds are applied with $100.5 \mathrm{mV}(\mathrm{HIRNG}=0)$ or 201 mV (HIRNG = 1) of hysteresis. The hysteresis is activated when any one or more of the monitored cells goes beyond the stored threshold value. The overvoltage and undervoltage thresholds are stored in the Configuration Register Group. The flags are stored in the Status Register Group A and B.

## Auxiliary (GPIO) Measurements (ADAX Command)

The ADAX command initiates the measurement of the GPIO inputs. This command has options to select which GPIO input to measure (GPI01-6) and which ADC mode. The ADAX command also measures the $2^{\text {nd }}$ reference. There are options in the ADAX command to measure the $2^{\text {nd }}$ reference and each GPIO separately or to measure
the $2^{\text {nd }}$ reference and all six GPIOs in a single command. See the section on Commands for the ADAX command format. All auxiliary measurements are relative to the $\mathrm{V}^{-}$ pin voltage. This command can be used to read external temperature by connecting the temperature sensors to the GPIOs. These sensors can be powered from the $2^{\text {nd }}$ reference which is also measured by the ADAX command, resulting in precise ratiometric measurements. See Reading External Temperature Probes for more details.
Figure 6 illustrates the timing of the ADAX command as it measures all seven auxiliary channels. The ADC is calibrated before measuring the channels in order to cancel offset errors.

## Measuring Sum of Cells and GPIOs (ADAXSC Command)

The ADAXSC command measures GPI01, then sum of cells, then GPI02. If GPI01 and/or GPIO2 are used to measure a current sense element, then this command can be used for cell stack impedance measurements. The GPI01 measurement occurs before the sum of cells measurement and the GPI02 measurement occurs just after. If GPI01 and GPIO2 are connected to the same sense element, then this command will report the current just before and just after the reported stack voltage. The GPI01 and GPI02


Figure 6. Timing for ADAX Command Measuring All GPIOs and $2^{\text {nd }}$ Reference
Table 8. Conversion Times for ADAX Command Measuring All GPIOs and $2^{\text {nd }}$ Reference in Different Modes

| CONVERSION TIMING (in $\mu \mathbf{s})$ |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| MODE | $\mathbf{T}_{\mathbf{0}}$ | $\mathbf{T}_{\mathbf{C}}$ | $\mathbf{T}_{\mathbf{R}}$ | $\mathbf{T}_{\mathbf{G} 1}$ | $\mathbf{T}_{\mathbf{G} 2}$ | $\mathbf{T}_{\mathbf{G} 3}$ | $\mathbf{T}_{\mathbf{G} 6}$ |
| Filtered | 0 | 1104 | $1104+1109.5$ | $1104+2 \cdot 1109.5$ | $1104+3 \cdot 1109.5$ | $1104+4 \cdot 1109.5$ | $1104+7 \cdot 1109.5$ |
| Alternate | 0 | 336 | $336+341.5$ | $336+2 \cdot 341.5$ | $336+3 \cdot 341.5$ | $336+4 \cdot 341.5$ | $336+7 \cdot 341.5$ |
| Normal | 0 | 208 | $208+213.5$ | $208+2 \cdot 213.5$ | $208+3 \cdot 213.5$ | $208+4 \cdot 213.5$ | $208+7 \cdot 213.5$ |
| Fast | 0 | 112 | $112+117.5$ | $112+2 \cdot 117.5$ | $112+3 \cdot 117.5$ | $112+4 \cdot 117.5$ | $112+7 \cdot 117.5$ |

## LTC6806

## OPERATION



Figure 7. Timing for ADAXSC Command
Table 9. Conversion Times for ADAXSC Command in Different Modes

| CONVERSION TIMING (in $\mu \mathbf{s})$ |  |  |  |  |  |
| :--- | :---: | :---: | :---: | :---: | :---: |
| MODE | $\mathbf{T}_{\mathbf{0}}$ | $\mathbf{T}_{\mathbf{C}}$ | $\mathbf{T}_{\mathbf{G} 1}$ | $\mathbf{T}_{\mathbf{S}}$ | $\mathbf{T}_{\mathbf{G} 2}$ |
| Filtered | 0 | 1104 | $1104+1109.5$ | $1104+2 \cdot 1109.5$ | $1104+3 \cdot 1109.5$ |
| Alternate | 0 | 336 | $336+341.5$ | $336+2 \cdot 341.5$ | $336+3 \cdot 341.5$ |
| Normal | 0 | 208 | $208+213.5$ | $208+2 \cdot 213.5$ | $208+3 \cdot 213.5$ |
| Fast | 0 | 112 | $112+117.5$ | $112+2 \cdot 117.5$ | $112+3 \cdot 117.5$ |

results can then be averaged by the host to estimate the current during the sum of cells measurement.
Figure 7 illustrates the timing of ADAXSC command. The ADC is calibrated before measuring the cells in order to cancel offset errors.

## CONTINUOUS MONITORING (MONITOR STATE)

The LTC6806 can be configured to continuously monitor two GPIO pins and a selected number of cell channels for specified fault conditions and issue interrupts on three of the GPIO pins. The IC will perform internal calibrations during each monitor cycle to cancel offsets. Monitoring is enabled by writing the MMD bits in the configuration register group to a non-zero value. The value of the MMD bits determines the ADC mode in which monitoring is
performed. ADC commands are ignored while the IC is in the MONITOR state. Table 10 shows the available ADC modes for monitoring.
Table 10. ADC Modes for Monitoring

| MMD <br> BITS | ADC MODE | CYCLE TIME FOR MONITORING ALL CELLS <br> PLUS GPIO1 AND GPIO2 |
| :---: | :--- | :--- |
| 00 | N/A | Monitoring Is Disabled |
| 01 | Normal | 11.2 ms |
| 10 | Alternate | 16.4 ms |
| 11 | Filtered | 47.9 ms |

While the LTC6806 is operating in the MONITOR state, the GPIO pins operate with fixed functions and the values stored in the GPIO[6:1] bits of the Configuration Register Group are ignored.

## OPERATION

Table 11. GPIO Pin Functions for Monitoring

| PIN | DIRECTION | PURPOSE |
| :--- | :--- | :--- |
| GPIO1 | Analog Input | Monitoring an NTC thermistor for <br> undertemperature faults. |
| GPI02 | Analog Input | Monitoring an NTC thermistor for <br> overtemperature faults. |
| GPI03 | Digital Input | 1 -> Enables the sleep timer. <br> $0->$ Disables the sleep timer (prevents sleep <br> timeout). |
| GPI04 | Digital Output | Outputs logic low when a temperature fault is <br> detected on GPIO1 or GPIO2. External pull-up is <br> required to indicate logic high. |
| GPI05 | Digital Output | Outputs logic low when an undervoltage fault <br> is detected on a cell that is being monitored. <br> External pull-up is required to indicate logic high. |
| GPI06 | Digital Output | Outputs logic low when an overvoltage fault <br> is detected on a cell that is being monitored. <br> External pull-up is required to indicate logic high. |

## Cell Monitoring

While operating in the MONITOR state, the host can limit which cells are to be monitored by writing the FCELL bits in the Configuration Register Group. The value of FCELL specifies the first cell in the stack to be monitored. The LTC6806 will begin monitoring from the FCELL channel and continue up through cell channel 36. Any system that uses fewer than 36 cells per LTC6806 should populate the highest cell channels and write the lowest populated cell count into the FCELL bits (see ). The valid range of FCELL is $0 \times 01$ through $0 \times 24$ (decimal 1 through 36). If the FCELL value is outside of that range, the LTC6806 will monitor all 36 cells in the MONITOR state.

The cell measurements will be compared against the overvoltage and undervoltage thresholds, stored in the Configuration Register Group. If these comparisons indicate a fault condition, the fault will be indicated in the OV/UV bits in the Status Register Group A or B, and the GPIO5 or GPI06 output will be asserted to logic low to indicate the fault. A hysteresis of 67LSBs is applied. This represents 100.5 mV of hysteresis if HIRNG $=0$ or 201 mV of hysteresis if HIRNG $=1$. Table 12 summarizes the MONITOR state fault indications.

## Thermistor Monitoring

While operating in the MONITOR state, after measuring the selected cells, the LTC6806 will measure $V_{\text {REF2, }}$, GPI01 and GPI02. If the GPI01 measurement is greater than half of the $\mathrm{V}_{\text {REF2 }}$ measurement, a fault will be indicated in the UT bit in the Status Register Group B and the GPIO4 output will be asserted to logic low. If the GPIO2 measurement is less than half of the $V_{\text {REF2 }}$ measurement, then the fault will be indicated in the OT bit in the Status Register Group B and the GPIO4 output will be asserted to logic low. A hysteresis of 100.5 mV is applied. Table 12 summarizes the MONITOR state fault indications.

The thermal thresholds are designed so that GPI01 and/or GPIO2 may be used to measure an NTC thermistor that is biased from the $\mathrm{V}_{\text {REF2 }}$ pin. If GPI01 is used to measure a current sense element instead, then choose devices such that the GPI01 measurement will not be larger than half of the $V_{\text {REF2 }}$ measurement and the UT fault is not activated. Alternatively, choose a current sense element such that

Table 12. Fault Indications in the MONITOR State

| FAULT CONDITION | HYSTERESIS | FAULT INDICATION IN MEMORY | FAULT PIN INDICATION |
| :--- | :---: | :--- | :---: |
| Any Monitored Cell Voltage $\geq$ VOV | 100.5 mV if HIRNG $=0$ <br> 201 mV if HIRNG $=1$ | Respective OV Bit(s) in Status Register <br> Group A or B Is Set | GPIO6 = Low |
| Any Monitored Cell Voltage $\leq$ VUV | 100.5 mV if HIRNG $=0$ <br> 201 mV if HIRNG $=1$ | Respective UV Bit(s) in Status Register <br> Group A or B Is Set | GPIO5 = Low |
| GPI01 $\geq V_{\text {REF2 }} / 2$ | 100.5 mV | UT Bit in Status Register Group B Is Set | GPI04 = Low |
| GPIO2 < VREF2 $/ 2$ | 100.5 mV | OT Bit in Status Register Group B Is Set | GPIO4 = Low |

## operation

half of the $\mathrm{V}_{\text {REF2 }}$ voltage represents an appropriate overcurrent threshold. The GPI01 comparison can be disabled by pulling GPI01 to $\mathrm{V}^{-}$. The GPIO2 comparison can also be disabled by pulling GPIO2 to $\mathrm{V}_{\text {REF2 }}$.

The OT and UT bits in the Status Register Group B default to logic high when the LTC6806 is not in the MONITOR state. Upon entering the MONITOR state, the OT and UT bits will remain unchanged until the end of the first monitoring cycle at which point, they will be updated according to the measured results.

## Disabling the Sleep Timer in the MONITOR State

GPI03 may be used to enable or disable the sleep timer while the LTC6806 is in the MONITOR state. If GPIO3 is externally driven logic low while the IC is in the MONITOR state, the sleep timer will be disabled and the IC will not transition to the SLEEP state. If GPIO3 is externally pulled to logic high, the sleep timer will be enabled and the IC will transition to the SLEEP state after 1.5 seconds without receiving a WAKEUP signal.

## Register Handling While in the MONITOR State

The host should not modify the FCELL, VUV or VOV bits in the Configuration Register Group after the LTC6806 has entered the MONITOR state. The IC uses these values to control monitoring functions. If these values were written asynchronously, then the monitoring functions may operate incorrectly for the cycle during which the register was written.

The host should not read the cell voltage register groups or the Auxiliary Register Group A while the LTC6806 is in the MONITOR state. These registers contain multi-bit results which do not have double-buffers and arbitration to prevent collisions between result updates and read access. The host may instead read the flag values in Status Register Group A and B while the IC is in the MONITOR state to determine which type(s) of fault has occurred.

If the above types of memory access are required, terminate the MONITOR state, wait for monitoring to end, perform the needed memory access and then restart the monitoring.

## Terminating the MONITOR State

When monitoring is no longer desired, the host can terminate monitoring by either asserting GPIO3 and waiting for the duration of the Sleep Timeout, or by writing the MMD bits to 0 . After writing the MDD bits to 0 , the LTC6806 will complete the last monitoring cycle in progress before returning to the REFUP or STANDBY state. The host can use the PLADC command to determine when this last cycle has completed or wait the duration of one complete monitor cycle as shown in Table 10.

## DATA ACQUISITION SYSTEM DIAGNOSTICS

The fuel cell monitoring data acquisition system is comprised of the multiplexer, ADC, $1^{\text {st }}$ reference, digital filters and memory. To ensure long term reliable performance there are several diagnostic commands which can be used to verify the proper operation of these circuits.

## Measuring Internal Device Parameters (ADSTAT Command)

The ADSTAT command is a diagnostic command that measures the following internal device parameters: sum of cells (SC), internal die temperature (ITMP), and the $\mathrm{V}^{+}$ power supply pin $\left(\mathrm{V}^{+}\right)$. These parameters are described in the section below. All the 4 ADC modes described earlier are available for these conversions. See the section on Commands for the ADSTAT command format. Figure 8 illustrates the timing of the ADSTAT command measuring all the three internal device parameters. Table 13 shows the conversion time of the ADSTAT command measuring all the three internal parameters.
Sum of Cells Measurement:The sum of cells measurement is the voltage between C 36 and CO with a 72:1 attenuation.

## OPERATION



Figure 8. Timing for ADSTAT Command Measuring SC, ITMP, $\mathrm{V}^{+}$
Table 13. Conversion Times for ADSTAT Command Measuring SC, ITMP, $\mathrm{V}^{+}$

| CONVERSION TIMING (in $\boldsymbol{\mu s}$ ) |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
| MODE | T0 | $\mathbf{T}_{\mathbf{C}}$ | $\mathbf{T}_{\mathbf{M 1}}$ | $\mathbf{T}_{\mathbf{M} 2}$ | $\mathbf{T}_{\mathbf{M} 3}$ |
| Filtered | 0 | 1104 | $1104+1109.5$ | $1104+2 \cdot 1109.5$ | $1104+3 \cdot 1109.5$ |
| Alternate | 0 | 336 | $336+341.5$ | $336+2 \cdot 341.5$ | $336+3 \cdot 341.5$ |
| Normal | 0 | 208 | $208+213.5$ | $208+2 \cdot 213.5$ | $208+3 \cdot 213.5$ |
| Fast | 0 | 112 | $112+117.5$ | $112+2 \cdot 117.5$ | $112+3 \cdot 117.5$ |

The 12-bit ADC value of sum of cells measurement (SC) is stored in Status Register Group C. From the SC value, the voltage from the sum of cell measurement can be determined using the expression:

$$
\text { Sum of Cells }=S C \cdot 72 \cdot 1.5 \mathrm{mV}
$$

Internal Die Temperature: The ADSTAT command can measure the internal die temperature. The 12-bit ADC value of the die temperature measurement (ITMP) is stored in Status Register Group C. From ITMP, the actual die temperature can be determined using the expression:

Internal Die Temperature $\left({ }^{\circ} \mathrm{C}\right)=($ ITMP/4.65 $)-266 \mathrm{~K}$
Power Supply Measurement: The ADSTAT command is also used to measure the $\mathrm{V}^{+}$Supply Pin $\left(\mathrm{V}^{+}\right)$. The 12-bit ADC value of the analog power supply measurement (VA) is stored in Status Register Group C. The voltage from the power supply measurement can be determined using the expression:

Power Supply Measurement $=\mathrm{V}^{+} \bullet 1.875 \mathrm{mV}$

## All Cells Plus Sum of Cells Measurement

The ADCVSC command is a diagnostic command that measures all of the cell voltages and the sum of all cells in a single command. The sum of cells measurement is executed in the middle of the sequence, after Cell 18 and before cell 19 . This reduces latency between measurements compared to using the ADCV and ADSTAT commands separately. Note that in the ADCVSC timing diagram, the ADC performs a calibration every time there is a switch between cell conversions and SC conversions.

## Accuracy Check

Measuring an independent voltage reference is the best means to verify the accuracy of a data acquisition system. The LTC6806 contains a $2^{\text {nd }}$ reference for this purpose. The ADAX command will initiate the measurement of the $2^{\text {nd }}$ reference, and place the results in Auxiliary Register Group A. The acceptable range of results will depend on the accuracy of the $2^{\text {nd }}$ reference, which includes the thermal hysteresis and long term drift of the $2^{\text {nd }}$ reference. Readings outside of the specified $V_{\text {REF2 }}$ range indicate that the system is out of its specified tolerance.

## operation



Figure 9. Timing for ADCVSC Command
Table 14. Conversion Times for ADCVSC Command in Different Modes

| CONVERSION TIMING (in $\mu \mathrm{s}$ ) |  |  |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| MODE | $\mathrm{T}_{0}$ | $\mathrm{T}_{\mathrm{C} 1}$ | $\mathrm{T}_{\mathrm{M} 1}$ | $\mathrm{T}_{\mathrm{M} 2}$ | $\mathrm{T}_{\mathrm{M} 18}$ | $\mathrm{T}_{\mathrm{C} 2}$ | TS | $\mathrm{T}_{\text {C3 }}$ | $\mathrm{T}_{\mathrm{M} 19}$ | TM36 |
| Filtered | 0 | 1168 | $1168+1174$ | $1168+2 \cdot 1174$ | $1168+18 \cdot 1174$ | 23,410 | 24,519 | $24,519+1174$ | $24,519+2 \cdot 1174$ | $24,519+19 \cdot 1174$ |
| Alternate | 0 | 400 | $400+406$ | $400+2 \cdot 406$ | $400+18 \cdot 406$ | 8050 | 8391 | $8391+406$ | $8391+2 \cdot 406$ | $8391+19 \cdot 406$ |
| Normal | 0 | 272 | $272+278$ | $272+2 \cdot 278$ | $272+18 \cdot 278$ | 5490 | 5703 | $5703+278$ | $5703+2 \cdot 278$ | $5703+19 \cdot 278$ |
| Fast | 0 | 176 | $176+182$ | $176+2 \cdot 182$ | $176+18 \cdot 182$ | 3570 | 3687 | $3687+182$ | $3687+2 \cdot 182$ | 3687 + 19 •182 |

## MUX Decoder Check (DIAGN)

The diagnostic command DIAGN confirms the proper operation of each multiplexer channel. The command cycles through all channels and sets the MUXFAIL bit to 1 in the Configuration Register Group if any channel decoder fails. The MUXFAIL bit is set to 0 if the channel decoder passes the test. The MUXFAIL bit is also set to 1 upon power-up (POR) or after a CLRSTAT command.
The DIAGN command takes $\sim 600 \mu \mathrm{~s}$ to complete if the core is in REFUP state, and $\sim 7.6 \mathrm{~ms}$ to complete if the core is in STANDBY state. The polling methods described in the section Polling Methods can be used to determine the completion of the DIAGN command.

Digital Filter Check
The delta-sigma ADC is composed of a 1 -bit pulse density modulator followed by a digital filter. A pulse density modulated bit stream has a higher percentage of 1 s for higher analog input voltages. The digital filter converts this high frequency 1 -bit stream into a single 12 -bit word. This is why a delta-sigma ADC is often referred to as an oversampling converter.
The self-test commands verify the operation of the digital filters and memory. Figure 10 illustrates the operation of the ADC during self-test. The output of the 1 -bit pulse density modulator is replaced by a 1 -bit test signal. The test signal passes through the digital filter and is con-

PULSE DENSITY MODULATED BIT

STREAM



Figure 10. Operation of LTC6806 ADC Self-Test

## OPERATION

verted to a 12-bit value. The 1-bit test signal undergoes the same digital conversion as the regular 1-bit pulse from the modulator, so the conversion time for any selftest command is exactly the same as the corresponding regular ADC conversion command. The 12-bit ADC value is stored in the same register groups as the regular ADC conversion command. The test signals are designed to place alternating one-zero patterns in the registers. Table 15 provides a list of the self-test commands. If the digital filters and memory are working properly, then the registers will contain the values shown in Table 15. For more details see the section Commands.

## ADC Clear Commands

LTC6806 has three clearcommands-CLRCELL, CLRAUX and CLRSTAT. These commands clear the registers that store all ADC conversion results.

TheCLRCELL command clears CellVoltage RegisterGroup A, B, C, D, E, F, G, H and I. All bytes in these registers are set to OxFF by CLRCELL command.

The CLRAUX command clears Auxiliary Register Group A and B. All bytes in these registers are set to 0xFF by CLRAUX command.

The CLRSTAT command clears Status Register Group A, B and C except the OT and UT in Status Register Group B. All OV and UV flags, MUXFAIL bit, STXFF bit, STXFS bit,
and THSD bit in Status Register Group B are set to 1 by CLRSTAT command. The registers storing SC, ITMP and $\mathrm{V}^{+}$are all set to 0xFF by CLRSTAT command.

## Open Wire Check (ADOW Command)

The LTC6806 draws a bias current from each cell as it is measured. When the cell voltage is above $\mathrm{V}^{+}$, the ADC bias current is a positive current into the pin. When a $C$ pin is open, the open pin will be pulled down by the bias current to around 1.5 V below $\mathrm{V}^{+}$in REFUP/MEASURE/MONITOR modes. As a result of this bias current, an open wire on a majority of the $C$ pins will produce a negative full-scale reading on the open C pin channel and a positive full-scale reading on the next cell above the open channel. For mostC pins the combination of looking for a negative and positive full-scale measurement on the $C(N)$ and $C(N+1)$ pins is the best way to detect open wires. However, this detection method is insufficient if either the open wire impedance is too low or if the common mode voltage of the C pin is not high enough above $\mathrm{V}^{+}$to create negative/positive full-scale measurements. In these cases, the ADOW command is used to check for open wires.

This command performs ADC conversions on the C pin inputs identically to the ADCV command, except internal current sources sink current from all $C$ pins for a set period of time before and during the measurement. For C pins biased near ground, internal current sources will

Table 15. Self-Test Command Summary

| COMMAND | SELF-TEST OPTION | OUTPUT PATTERN IN DIFFERENT ADC MODES |  |  |  | RESULTS REGISTER GROUPS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Fast | Normal | Alternate | Filtered |  |
| CVST | ST[1:0] = 01 | 0x555 | 0x555 | 0x555 | 0x555 | C1V to C36V(CVA, CVB, CVC, CVD, CVE, CVF, CVG, CVH, CVI) |
|  | ST[1:0] = 10 | 0xAAA | OxAAA | 0xAAA | 0xAAA |  |
| AXST | ST[1:0] = 01 | 0x554 | 0x555 | 0x555 | 0x555 | G1V to G6V, REF (AUXA, AUXB) |
|  | ST[1:0] = 10 | 0xAA8 | OxAAA | 0xAAA | 0xAAA |  |
| STATST | ST[1:0] = 01 | 0x554 | 0x555 | 0x555 | 0x555 | $\begin{gathered} \text { SC, ITMP, } \mathrm{V}^{+} \\ \text {(STATC) } \end{gathered}$ |
|  | ST[1:0] = 10 | 0xAA8 | 0xAAA | OxAAA | 0xAAA |  |

## OPERATION

instead source current into the pin. The pull-up (PUP) bit of the ADOW command determines whether the current sources are sinking.

The open wire checks should be run on an operating fuel cell stack.

The following simple algorithm can be used to check for an open wire on any of the $36 C$ pins:

1) Run the 36 -cell command ADOW with PUP $=0$ once. Read the cell voltages for cells 1 to 36 and store them in array CELLPU(n).
2) Run the 36 -cell command ADOW with PUP $=1$ once. Read the cell voltages for cells 1 to 36 and store them in array $C_{E L L P D(n) .}$
3) Take the difference between the pull-up and pull-down measurements made in above steps for cells 1 to 36:
$C_{E L L}^{\Delta(n)}=C E L L_{P U(n)}-C E L L_{P D(n)}$.
4) For all values of $n$ from 1 to 36 : If CELL $_{\Delta(n+1)}<-200 \mathrm{mV}$ then C(n) is open. Additionally, if CELLPD(n) orCELLPU(n) has a positive or negative full-scale value, then either $C(n)$ or $C(n-1)$ is open.
The OWPCH bits in the configuration register group configure the amount of precharge time that is allowed for the $20 \mu \mathrm{~A}$ current sources to discharge pin capacitance on open cells before the ADC conversions begin. If the pin capacitance is large enough that 100 ms is insufficient to adequately discharge it, then the host can send multiple ADOW commands to achieve further discharge. Use Table 16 to determine which configuration to use.

Table 16. Open Wire Precharge Configurations

| EXTERNAL C PIN <br> CAPACITANCE | OWPCH | PRECHARGE TIME |
| :---: | :---: | :---: |
| $\leq 10 \mathrm{nF}$ | 01 | 1 ms |
| $\leq 100 \mathrm{nF}$ | 10 | 10 ms |
| $\leq 1 \mu \mathrm{~F}$ | 11 | 100 ms |
| $>1 \mu \mathrm{~F}$ | Use Multiple ADOW Commands |  |

A difference of more than 200 mV indicates an open wire. Adequate precharge time can be determined by using the following formula:

Precharge Time $\geq\left(\mathrm{C}_{\text {FILTER }} \bullet 200 \mathrm{mV} / 20 \mu \mathrm{~A}\right)=\mathrm{C}_{\text {FILTER }} \bullet 1 \mathrm{E}+4$

## Revision Code

The configuration register group contains a 4-bit revision code. If software detection of device revision is necessary, then contact the factory for details. Otherwise, the code can be ignored. In all cases, however the values of all bits must be used when calculating the packet error code (PEC) on data reads.

## SERIAL INTERFACE OVERVIEW

There are two types of serial ports on the LTC6806, a standard 4-wire serial peripheral interface (SPI) and a 2 -wire isolated interface (isoSPI). Pins 57 through 60 are configurable as a 2-wire or 4-wire serial port, based on the state of the ISOMD pin.

The state of the DCMD pin determines whether the pins 61 through 64 are a second 2 -wire serial port. Connecting DCMD to $\mathrm{V}^{+}$configures the LTC6806 for use in a serial daisy chain. Connecting DCMD to $\mathrm{V}^{-}$configures the LTC6806 for use in a parallel addressable bus. In parallel mode, pins 61 through 64 are tied externally to $\mathrm{V}^{-}$or $\mathrm{V}^{+}$ and set the address of the device.

OPERATION

## 4-WIRE SERIAL PERIPHERAL INTERFACE (SPI) PHYSICAL LAYER

## External Connections

Connecting ISOMD to $\mathrm{V}^{-}$configures serial port A for 4 -wire SPI. The SDO pin is an open drain output which requires a pull-up resistor tied to the appropriate supply voltage (Figure 11).

## Timing

The 4-wire serial port is configured to operate in a SPI system using CPHA = 1 and CPOL = 1 . Consequently, data on SDI must be stable during the rising edge of SCK. The timing is depicted in Figure 12. The maximum data rate is 1 Mbps ; however, the device is tested at a higher data rate in production in order to guarantee operation at the maximum specified data rate.


Figure 11. 4-Wire SPI Configuration


Figure 12. Timing Diagram of 4-Wire Serial Peripheral Interface

## operation

## 2-WIRE ISOLATED INTERFACE (IsoSPI) PHYSICAL LAYER

The 2-wire interface provides a means to interconnect LTC6806 devices using simple twisted pair cabling. The interface is designed for low packet error rates when the cabling is subjected to high RF fields. Isolation is achieved through an external transformer.
Standard SPI signals are encoded into differential pulses. The strength of the transmission pulse and the threshold level of the receiver are set by two external resistors. The values of the resistors allow the user to trade off power dissipation for noise immunity.

Figure 13 shows an equivalent circuit. A 2 V reference drives the IBIAS pin. External resistors $\mathrm{R}_{\mathrm{B} 1}$ and $\mathrm{R}_{\mathrm{B} 2}$ create the reference current $\mathrm{l}_{\mathrm{B}}$. This current sets the drive strength of the transmitter. $\mathrm{R}_{\mathrm{B} 1}$ and $\mathrm{R}_{\mathrm{B} 2}$ also form a voltage divider of the 2 V reference at the ICMP pin. The receiver circuit threshold is half of the voltage at the ICMP pin.

## External Connections

In daisy-chain mode, the LTC6806 has two serial ports which are called Port A and Port B. Port B is always configured as a 2-wire interface. Port A is either a 2-wire or 4 -wire interface, depending on the connection of the ISOMD pin.


Figure 13. isoSPI Interface

## operation

When Port A is configured as a 4-wire interface, Port A is always the SLAVE port and Port $B$ is the MASTER port. Communication is always initiated on Port A of the first device in the daisy-chain configuration. The final device in the daisy chain does not use Port B, and it should be terminated into $\mathrm{R}_{\mathrm{M}}$.
When Port A is configured as a 2-wire interface, communication can be initiated on either Port A or Port B. If communication is initiated on Port A, LTC6806 configures Port A as slave and Port B as master. Likewise, if communication is initiated on Port B, LTC6806 configures Port B as slave and Port A as master. See the section Reversible isoSPI for LTC6806 in daisy-chain mode for a detailed description on reversible isoSPI.

Figure 14 is an example of a robust interconnection of multiple identical PCBs, each containing one LTC6806 configured for operation in a daisy chain. The microprocessor is located on a separate PCB. To achieve 2-wire isolation between the microprocessor PCB and the $1^{\text {st }}$ LTC6806 PCB, use the LTC6820 support IC. The LTC6820 converts between SPI and isoSPI. In this example, communication is initiated on Port A. So LTC6806 configures Port A as slave and Port $B$ as master.

Figure 15 illustrates a daisy-chained configuration of LTC6806 using reversible isoSPI. Two LTC6820s are connected on either side of the daisy chain. Both LTC6820s


Figure 14. Simplified Transformer-Isolated Daisy Chain Configuration

## LTC6806

## operation

are configured as Master and share the same SPI interface to connect to the MPU. The MPU uses two different CS signals to talk to one of the two LTC6820s.

For example, in Figure 15, if the bottom LTC6820 is addressed, then LTC6806 DEV A becomes the first device in the stack followed by DEV B and DEV C. Port A of each LTC6806 is configured as the slave and Port B is configured as the Master. On the other hand, if the top LTC6820 is
addressed, then LTC6806 DEV C becomes the first device in the stack followed by DEV B and DEV A. Port B of each LTC6806 is configured as slave and Port A is configured as Master.

The reversible isoSPI provides a redundant communication path in the event of a single point failure in the 2-wire interface.


Figure 15. Simplified Transformer Isolated Daisy Chain Configuration with Reversible isoSPI

## OPERATION

The LTC6806 in Parallel Mode has a single serial port (Port A) which can be 2-wire or 4-wire, depending on the state of the ISOMD pin. When configured for 2-wire communications, several devices can be connected in a multi-drop configuration, as shown in Figure 16. The

LTC6820 IC is used to interface the MPU (master) to the LTC6806s (slaves).


Figure 16. Simplified Multi-Drop Configuration

## LTC6806

## operation

## Selecting Bias Resistors

The adjustable signal amplitude allows the system to trade power consumption for communication robustness and the adjustable comparator threshold allows the system to account for signal losses.

The isoSPI transmitter drive current and comparator voltage threshold are set by a resistor divider $\left(\mathrm{R}_{\text {BIAS }}=\mathrm{R}_{\mathrm{B} 1}\right.$ $+\mathrm{R}_{\mathrm{B} 2}$ ) between the IBIAS and $\mathrm{V}^{-}$. The divided voltage is connected to the ICMP pin which sets the comparator threshold to $1 / 2$ of this voltage ( $\mathrm{V}_{\text {ICMP }}$ ). When either isoSPI interface is enabled (not IDLE) IBIAS is held at 2 V , causing a current $\mathrm{I}_{\mathrm{B}}$ to flow out of the IBIAS pin. The IP and IM pin drive currents are $20 \cdot \mathrm{I}_{\mathrm{B}}$.

As an example, if divider resistor $R_{B 1}$ is $2.8 \mathrm{k} \Omega$ and resistor $R_{B 2}$ is $1.21 \mathrm{k} \Omega$ (so that $R_{\text {BIAS }}=4 \mathrm{k} \Omega$ ), then:

$$
\begin{aligned}
& I_{B}=\frac{2 V}{R_{B 1}+R_{B S}}=0.5 \mathrm{~mA} \\
& I_{D R V}=I_{I P}=I_{I M}=20 \cdot I_{B}=10 \mathrm{~mA} \\
& V_{I C M P}=2 \mathrm{~V} \cdot \frac{R_{B 2}}{R_{B 1}+R_{B 2}}=I_{B} \cdot R_{B 2}=603 \mathrm{mV} \\
& V_{T C M P}=0.5 \cdot V_{I C M P}=302 \mathrm{mV}
\end{aligned}
$$

In this example, the pulse drive current $I_{\text {DRV }}$ will be 10 mA and the receivercomparators will detect pulses with IP-IM amplitudes greater than $\pm 302 \mathrm{mV}$.
If the isolation barrier uses 1:1 transformers connected by a twisted pair and terminated with $120 \Omega$ resistors on each end, thenthe transmitted differential signal amplitude $\pm \pm$ will be:

$$
V_{A}=I_{D R V} \cdot \frac{R_{M}}{2}=0.6 \mathrm{~V}
$$

(This result ignores transformer and cable losses, which may reduce the amplitude).

## isoSPI Pulse Detail

Two LTC6806 devices can communicate by transmitting and receiving differential pulses back and forth through an isolation barrier. The transmitter can output three logic levels: $+V_{A}, 0 V$ and $-V_{A}$. A positive output results from

IP sourcing current and IM sinking current across load resistor $R_{M}$. A negative voltage is developed by IP sinking and IM sourcing. When both outputs are off, the load resistance forces the differential output to OV.

To eliminate the DC signal component and enhance reliability, the isoSPI uses two different pulse lengths. This allows for four types of pulses to be transmitted, as shown in Table 17. A -1 pulse will be transmitted as a negative pulse followed by a positive pulse. The duration of each pulse is defined as $t_{1 / 2 P W}$, since each is half of the required symmetric pair. (The total isoSPI pulse duration is $2 \cdot t_{1 / 2 \mathrm{PW}}$ ).
Table 17. isoSPI Pulse Types

| PULSE TYPE | $\left.\begin{array}{c}\text { FIRST LEVEL } \\ \left(t_{1} / \text { PW }\right.\end{array}\right)$ | SECOND LEVEL <br> $\left(t_{1} /\right.$ PW $)$ | ENDING LEVEL |
| :---: | :---: | :---: | :---: |
| Long +1 | $+V_{\mathrm{A}}(150 n \mathrm{n})$ | $-\mathrm{V}_{\mathrm{A}}(150 \mathrm{~ns})$ | 0 V |
| Long -1 | $-\mathrm{V}_{\mathrm{A}}(150 \mathrm{~ns})$ | $+\mathrm{V}_{\mathrm{A}}(150 \mathrm{~ns})$ | 0 V |
| Short +1 | $+\mathrm{V}_{\mathrm{A}}(50 \mathrm{~ns})$ | $-\mathrm{V}_{\mathrm{A}}(50 \mathrm{~ns})$ | 0 V |
| Short -1 | $-\mathrm{V}_{\mathrm{A}}(50 \mathrm{~ns})$ | $+\mathrm{V}_{\mathrm{A}}(50 \mathrm{~ns})$ | 0 V |

The receiver is designed to detect each of these isoSPI pulse types. For successful detection, the incoming isoSPI pulses (CSB or data) should meet the following requirements:

1. $t_{1 / 2 \mathrm{PW}}$ of incoming pulse $>\mathrm{t}_{\text {FILT }}$ of the receiver and
2. $\mathrm{t}_{\text {INV }}$ of incoming pulse < twndw of the receiver

The worst-case margin (margin 1) for the first condition is the difference between minimum $\mathrm{t}_{1 / 2 \mathrm{PW}}$ of the incoming pulse and maximum $t_{\text {FILT }}$ of the receiver. Likewise, the worst-case margin (margin 2) for the second condition is the difference between minimum twndw of the receiver and maximum $\mathrm{t}_{\text {INV }}$ of the incoming pulse. These timing relations are illustrated in Figure 18.
A host microprocessor does not have to generate isoSPI pulses to use this 2-wire interface. The first LTC6806 in the system can communicate to the microprocessor using the 4-wire SPI interface on its Port A, then daisy-chain to other LTC6806s using the 2-wire isoSPI interface on its Port B. Alternatively, the LTC6820 can be used to translate the SPI signals into isoSPI pulses.

## OPERATION

## LTC6806 Operation in Daisy-Chain with Port A Configured for SPI

If LTC6806 is operating in a daisy chain configuration (DCMD = High), Port A of the first device in the stack can be configured for SPI (ISOMD = Low) or isoSPI (ISOMD = High). If port A is configured for SPI (ISOMD = Low), the SPI detects one of four communication events: CSB falling, CSB rising, SCK rising with SDI $=0$, and SCK rising with SDI $=1$. Each event is converted into one of the four pulse types for transmission through the LTC6806 daisy chain. Long pulses are used to transmit CSB changes and short pulses are use to transmit data, as explained in Table 18.
Table 18. Port B (Master) isoSPI Port Function

| COMMUNICATION EVENT <br> (Port A SPI) | TRANSMITTED PULSE <br> (Port B isoSPI) |
| :--- | :---: |
| CSB Rising | Long +1 |
| CSB Falling | Long -1 |
| SCK Rising Edge, SDI $=1$ | Short +1 |
| SCK Rising Edge, SDI $=0$ | Short -1 |

Table 19. Port A (Slave) isoSPI Port Function

| RECEIVED PULSE <br> (Port A isoSPI) | INTERNAL SPI <br> PORT ACTION | RETURN PULSE |
| :--- | :--- | :--- |
| Long +1 | Drive CSB High | None |
| Long -1 | Drive CSB Low |  |
| Short +1 | 1. Set SDI $=1$ <br> 2. Pulse SCK | Short -1 Pulse if Reading a 0 Bit |
| Short -1 | 1. Set SDI $=0$ <br> 2. Pulse SCK | (No Return Pulse if Not in READ <br> Mode or if Reading a 1 Bit) |

## LTC6806 Operation in Daisy-Chain with Port A Configured for isoSPI

On the other side of the isolation barrier (i.e. at the other end of the cable), the $2^{\text {nd }}$ LTC6806 will have ISOMD $=\mathrm{V}^{+}$ so that its Port A is configured for isoSPI. The slave isoSPI port (Port A or B) receives each transmitted pulse and reconstructs the SPI signals internally, as shown in Table 19. In addition, during a READ command, this port may transmit return data pulses.
The slave isoSPI port never transmits long (CSB) pulses. Furthermore, a slave isoSPI port will only transmit short-1 pulses, never a +1 pulse. The master port recognizes a null response as a logic 1. This allows for multiple slave devices on a single cable without risk of collisions (Multi-drop).


Figure 17. Reversible isoSPI State Diagram

## LTC6806

## operation

## Reversible isoSPI for LTC6806 in Daisy-Chain Mode

When LTC6806 is operating in daisy-chain mode with Port A configured for isoSPI, communication can be initiated from either Port A or Port B. In other words, LTC6806 can configure either Port A or Port B as slave or master, depending on the direction of communication. The reversible isoSPI feature permits communication from both directions in a stack of daisy-chained devices. Figure 17 illustrates the operation of reversible isoSPI.

When LTC6806 is in SLEEP state, it will respond to a valid wake up signal on either Port A or Port B. This is true for all configurations of DCMD and ISOMD pins.

In daisy-chain configurations, if the wake up signal was sent on Port A, LTC6806 transmits a long +1 isoSPI pulse (CSB rising) on Port B after the isoSPI is powered up. If the wake up signal was sent on Port B, LTC6806 powers up the isoSPI but does not transmit a long +1 isoSPI pulse on Port A.
When LTC6806 is in READY state, communication can be initiated by sending a long -1 isoSPI pulse (CSB falling) on either Port A or Port B. The LTC6806 automatically
configures the port that receives the long - 1 isoSPI pulse as the slave and the other port is configured as the master. The isoSPI pulses are transmitted through the master port to the rest of the devices in the daisy chain.
In ACTIVE state, the LTC6806 is in the middle of communication and CSB of the internal SPI port is low. At the end of communication, a long +1 pulse (CSB rising) on the SLAVE port returns the part to the READY state. Although it is not part of a normal communication routine, the LTC6806 allows ports A and B to be swapped inside the ACTIVE state. This feature is useful for the master controller to reclaim control of the slave port of LTC6806 irrespective of the current state of the ports. This can be done by sending a long - 1 isoSPI pulse on the master port after a time delay of $\mathrm{t}_{\mathrm{BLOCk}}$ from the last isoSPI signal that was transmitted by the part. Any long isoSPI pulse sent to the master port inside $\mathrm{t}_{\text {BLock }}$ is rejected by the part. This ensures the LTC6806 cannot switch ports because of signal reflections from poorly terminated cables $(<100 \mathrm{~m}$ cable length).
+1 PULSE


Figure 18. isoSPI Pulse Detail

## OPERATION

## Timing Diagrams

Figure 19 shows the isoSPI timing diagram for a READ command to daisy-chained LTC6806 parts. The ISOMD pin is tied to $\mathrm{V}^{-}$on the bottom part so its Port A is configured as a SPI port (CSB, SCK, SDI and SDO). The isoSPI signals of three stacked devices are shown, labeled with the port (A or B) and part number. Note that ISO B1 and ISO A2 are actually the same signal, but shown on each end of the transmission cable that connects parts 1 and 2. Likewise, ISO B2 and ISO A3 are the same signal, but with the cable delay shown between parts 2 and 3 .

Bits $W_{n}-W_{0}$ refers to the 16-bit command code and the 16-bit PEC of a READ command. At the end of bit $W_{0}$ the three parts decode the READ command and begin shifting out data which is valid on the next rising edge of clock SCK. Bits Xn -X0 refer to the data shifted out by Part 1. Bits $Y_{n}-Y_{0}$ refer to the data shifted out by Part 2 and bits $Z_{n}-Z_{0}$ refer to the data shifted out by Part 3. All this data is read back from the SDO port on Part 1 in a daisy-chained fashion.


Figure 19. isoSPI Timing Diagram

## OPERATION

## Waking Up the Serial Interface

The serial ports (SPI or isoSPI) will enter the low power IDLE state if there is no activity on Port A or Port B for a time of tidLE. LTC6806 has two wake-up circuits monitoring pins CSB_IMA, SCK_IPA and pins IMB_A2, IPB_A3.
Differential activity on pins CSB_IMA, SCK_IPA or pins IMB_A2,IPB_A3 wakes up the serial interface. The LTC6806 will be ready to communicate when the isoSPI state changes to READY within twaKE or $t_{\text {READY }}$, depending on the core state (see LTC6806 Core State Descriptions for details.)
In daisy-chain mode (DCMD = High), ifthe LTC6806 wakes up due to differential activity on Port A, it sends a long +1 pulse on Port $B$ after it is ready to communicate. This pulse wakes up the next device in the stack which will, in turn, wake up the next device. If there are $N$ devices in the stack, all the devices are powered up within the time $\mathrm{N} \cdot$ $t_{\text {WAKE }}$ or $\mathrm{N} \bullet \mathrm{t}_{\text {READY }}$, depending on the core state. For large stacks, the time $\mathrm{N} \bullet$ twake $^{\text {may }}$ be equal to or larger than $t_{\text {IDLE }}$. In this case, after waiting longer than the time of $N$ - twaKe, the host may send another dummy byte and wait for the time $\mathrm{N} \bullet \mathrm{t}_{\text {READY }}$, in order to ensure that all devices are in the READY state.

If the LTC6806 wakes up due to differential activity on Port $B$, it will not send a long +1 pulse on Port $A$ after
it is ready. So, to wake up all devices in the stack, the host needs to send a series of wake-up pulses spaced no longer than $\mathrm{t}_{\text {IDLE }}$

Figure 20 illustrates the timing and the functionally equivalent circuit for the wake-up circuit on Port A. The wake-up circuit responds to the difference between CSB_IMA and SCK_IPA pins. Common mode signals will not wake up the serial interface. The interface is designed to wake up after receiving a large signal single-ended pulse, or a low amplitude symmetric pulse. The differential signal |SCK_IPA - CSB_IMA|, must be at least $V_{\text {WAKE }}=250 \mathrm{mV}$ for a minimum duration of $\mathrm{t}_{\text {DWELL }}=240 \mathrm{~ns}$ to qualify as a wake-up signal that powers up the serial interface. The wake-up detect circuit on Port $B$ is identical to this circuit with IPB_A3 and IMB_A2 as its inputs.

## DATA LINK LAYER

All data transfers on LTC6806 occur in byte groups. Every byte consists of 8 bits. Bytes are transferred with the most significant bit (MSB) first. CSB must remain low for the entire duration of a command sequence, including between a command byte and subsequent data. On a write command, data is latched in on the rising edge of CSB.


Figure 20. Wake-Up Detection and IDLE Timer

## OPERATION

## NETWORK LAYER

## Packet Error Code

The packet error code (PEC) is a 15-bit cyclic redundancy check (CRC) value calculated for all of the bits in a register group in the order they are passed, using the initial PEC value of 000000000010000 and the following characteristic polynomial: $X^{15}+X^{14}+X^{10}+X^{8}+X^{7}+X^{4}+X^{3}+1$. To calculate the 15 -bit PEC value, a simple procedure can be established:

1. Initialize the PEC to 000000000010000 (PEC is a 15-bit register group)
2. For each bit DIN coming into the PEC register group, set INO = DIN XOR PEC [14]

IN3 = INO XOR PEC [2]
IN4 = INO XOR PEC [3]
IN7 = INO XOR PEC [6]
IN8 = INO XOR PEC [7]
IN10 = INO XOR PEC [9]
IN14 = INO XOR PEC [13]
3. Update the 15 -bit PEC as follows

PEC [14] = IN14,
PEC [13] = PEC[12],
PEC [12] = PEC[11],
PEC [11] = PEC[10],
PEC [10] = IN10,
PEC [9] = PEC[8],
PEC [8] = IN8,
PEC [7] = IN7,
PEC [6] = PEC[5],
PEC [5] = PEC[4],
PEC [4] = IN4,
PEC [3] = IN3,
PEC[2] = PEC[1],
PEC[1] = PEC[0],
$\operatorname{PEC}[0]=\operatorname{INO}$.
4. Go back to Step 2 until all the data is shifted. The final PEC ( 16 bits) is the 15 -bit value in the PEC register with a 0 bit appended to its LSB.

$X$ PEC REGISTER BIT $X$


Figure 21. 15-Bit PEC Computation Circuit

## LTC6806

## operation

Figure 21 illustrates the algorithm described above. An example to calculate the PEC for a 16-bit word ( $0 \times 0001$ ) is listed in Table 20. The PEC for $0 \times 0001$ is computed as $0 \times 3 D 6 E$ after stuffing a 0 bit at the LSB. For longer data streams, the PEC is valid at the end of the last bit of data sent to the PEC register.

LTC6806 calculates PEC word for any command or data received and compares it with the PEC following the command or data. The command or data is regarded as valid only if the PEC matches. LTC6806 also attaches the calculated PEC word at the end of the data it shifts out. Table 21 shows the format of PEC while writing to or reading from LTC6806.

Table 20. PEC Calculation for $0 \times 0001$

| PEC[14] | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 1 | 1 | 0 | 0 | $\mathbf{0}$ |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| PEC[13] | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 1 | 1 | 0 | $\mathbf{0}$ |
| PEC[12] | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 1 | 1 | 0 | 1 | $\mathbf{1}$ |
| PEC[11] | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 1 | 1 | 0 | 1 | 1 | $\mathbf{1}$ |
| PEC[10] | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 1 | 1 | 0 | 1 | 1 | 1 | $\mathbf{1}$ |
| PEC[9] | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 1 | $\mathbf{1}$ |
| PEC[8] | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 1 | 0 | $\mathbf{0}$ |
| PEC[7] | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 0 | 1 | 1 | $\mathbf{1}$ |
| PEC[6] | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | $\mathbf{0}$ |
| PEC[5] | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 1 | $\mathbf{1}$ |
| PEC[4] | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 1 | 1 | $\mathbf{1}$ |
| PEC[3] | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 0 | 0 | 0 | $\mathbf{0}$ |
| PEC[2] | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 1 | $\mathbf{1}$ |
| PEC[1] | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 1 | 1 | $\mathbf{1}$ |
| PEC[0] | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 1 | 1 | 1 | $\mathbf{1}$ |
| IN14 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 1 | 1 | 0 | 0 |  | $\mathbf{0}$ |
| IN10 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 1 | 1 | 0 | 1 | 1 | 1 |  | PEC Word |
| IN8 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 1 | 0 |  |  |
| IN7 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 0 | 1 | 1 |  |  |
| IN4 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 1 | 1 |  |  |
| IN3 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 0 | 0 | 0 |  |  |
| IN0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 1 | 1 | 1 |  |  |
| DIN | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 |  |  |
| CIock Cycle | 0 | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 | 14 | 15 | 16 |  |

Table 21. Write/Read PEC Format

| NAME | RD/WR | Bit $\mathbf{7}$ | Bit $\mathbf{6}$ | Bit $\mathbf{5}$ | Bit $\mathbf{4}$ | Bit $\mathbf{3}$ | Bit $\mathbf{2}$ | Bit $\mathbf{1}$ | Bit $\mathbf{0}$ |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| PEC0 | RD/WR | PEC[14] | PEC[13] | PEC[12] | PEC[11] | PEC[10] | PEC[9] | PEC[8] | PEC[7] |
| PEC1 | RD/WR | PEC[6] | PEC[5] | PEC[4] | PEC[3] | PEC[2] | PEC[1] | PEC[0] | 0 |

## OPERATION

While writing any command to LTC6806, the command bytes CMD0 and CMD1 (see Table 28 and Table 29) and the PEC bytes PECO and PEC1 are sent on Port A in the following order:

## CMD0, CMD1, PECO, PEC1

After a broadcast write command to daisy-chained LTC6806 devices, data is sent to each device followed by the PEC. For example, when writing the configuration register group to two daisy-chained devices (primary device P, stacked device $S$ ), the data will be sent to the primary device on Port A in the following order:

CFGRO(S), ..., CFGR5(S), PECO(S), PEC1(S), CFGR0(P), ..., CFGR5(P), PEC0(P), PEC1(P)

After a READ command for daisy-chained devices, each device shifts out its data and the PEC that it computed for its data on Port A followed by the data received on Port B. For example, when reading Status Register Group B from two daisy-chained devices (primary device P, stacked device S), the primary device sends out data on Port A in the following order:

STBR0(P), STBR1(P), ...,STBR5(P), PECO(P),PEC1(P), STBRO(S), STBR1(S), ..., STBR5(S), PECO(S),PEC1(S)

## Broadcast Commands

A broadcast command is one to which all devices on the bus will respond, regardless of device address. This command can be used with in either daisy-chained or parallel modes. See Bus Protocols for broadcast command format. With broadcast commands, all devices can be sent commands simultaneously.

In parallel configurations, this is useful for ADC conversion and polling commands. It can also be used with write commands when all parts are being written with the same data. Broadcast read commands should not be used in the parallel configuration.

Daisy-chained configurations only support broadcast commands. All devices in the chain receive the command bytes simultaneously. For example, to initiate ADC conversions in a stack of devices, a single ADCV command is sent, and all devices will start conversions at the same time. For read and write commands, a single command is sent, and then the stacked devices effectively turn into a cascaded shift register, in which data is shifted through each device to the next device in the stack. See the Serial Programming Examples section.

## Address Commands

An address command is one in which only the addressed device on the bus responds. Address commands are used only with LTC6806 configured in parallel mode. See Bus Protocols for address command format.

## Automatic Incrementing for Address commands

When using an address read command (RDCVA, RDCVB, RDCVC, RDCVD, RDCVE, RDCVF, RDCVG, RDCVG, RDCVH, RDCVI, RDAUXA, RDAUXB, RDSTATA, RDSTATB, RDSTATC), the LTC6806 will send the requested register group data and PEC, then automatically increment to the next related register group. In this way, the host may, for instance, send a RDCVA command and read through all of the cell voltage register groups in a single command. After sending the Cell Voltage Register Group I data and PEC, the LTC6806 will send all 1's.

## Polling Methods

The simplest method to determine ADC completion is for the controller to start an ADC conversion and wait for the specified conversion time to pass before reading the results.

In parallel configurations that communicate in SPI mode (ISOMD pin tied low), there are two methods of polling. The first method is to hold CSB low after an ADC conversion command is sent. After entering a conversion command, the SDO line is driven low when the device is busy performing conversions (Figure 22). SDO is pulled high

## operation

whenthe device completes conversions. However, the SDO will also go back high when CSB goes high even if the device has not completed the conversion. An addressed device drives the SDO line based on its status alone. A problem with this method is that the controller is not free to do other serial communication while waiting for ADC conversions to complete. The next method overcomes this limitation. The controller can send an ADC start command, perform other tasks, and then send a poll ADC converter status(PLADC) command to determine the status of the ADC conversions (Figure 23). After entering the PLADC command, SDO will golow if the device is busy performing conversions. SDO is pulled high at the end of conversions. However, the SDO will also go high when CSB goes high even if the device has not completed the conversion. See

Programming Examples on how to use the PLADC command with devices in parallel configuration.
In parallel configurations that communicate in isoSPI mode, the low side port transmits a data pulse only in response to a master isoSPI pulse received by it. So, after entering the command in either method of polling described above, isoSPI data pulses are sent to the part to update the conversion status. These pulses can be sent using LTC6820 by simply clocking its SCK pin. In response to this pulse, the device sends back an isoSPI pulse if it is still busy performing conversions and does not return a pulse if it has completed the conversions. If a CSB high isoSPI pulse is sent to the device, it exits the polling command.


Figure 22. SDO Polling After an ADC Command


Figure 23. SDO Polling Using PLADC Command

## OPERATION

In a daisy-chained configuration of N stacked devices, the same two polling methods can be used. If the bottom device communicates in SPI mode, the SDO of the bottom device indicates the conversion status of the entire stack i.e. SDO will remain low until all the devices in the stack have completed the conversions. In the first method of polling, after an ADC conversion command is sent, clock pulses are sent on SCKI while keeping CSBI Iow. The SDO status becomes valid only at the end of $N$ clock pulses on SCKI and gets updated for every clock pulse that follows (Figure 24). In the second method, the PLADC command is sent followed by clock pulses on SCKI while keeping CSBI Iow. Similar to the first method, the SDO status is valid only after N clock cycles on SCKI and gets
updated after every clock cycle that follows (Figure 25). See Programming Examples on how to use the PLADC command with N stacked devices.

If the bottom device communicates in isoSPI mode, isoSPI data pulses are sent to the device to update the conversion status. Using LTC6820, this can be achieved by just clocking its SCK pin. The conversion status is valid only after the bottom LTC6806 device receives N isoSPI data pulses and the status gets updated for every isoSPI data pulse that follows. The device returns a low data pulse if any of the devices in the stack is busy performing conversions and returns a high data pulse if all the devices are free.


Figure 24. SDO Polling After an ADC Command in a Daisy Chain


Figure 25. SDO Polling Using the PLADC Command in a Daisy Chain

## LTC6806

## OPERATION

## Bus Protocols

Protocol Format: The protocol formats for both broadcast and address commands are depicted in Table 23 through Table 27. Table 22 is the key for reading the protocol diagrams.
Table 22. Protocol Key

| CMD0 | First Command Byte (See Table 28 and Table 29) |
| :---: | :--- |
| CMD1 | Second Command Byte (See Table 28 and Table 29) |
| PECO | First PEC Byte (See Table 21) |
| PEC1 | Second PEC Byte (See Table 21) |
| n | Number of Bits |
| $\ldots$ | Continuation of Protocol |
|  | Master to Slave |
|  | Slave to Master |

Table 23. Broadcast/Address Poll Command

| 8 | 8 | 8 | 8 |  |
| :---: | :---: | :---: | :---: | :---: |
| CMD0 | CMD1 | PEC0 | PEC1 | Poll Data |

Table 24. Broadcast Write Command

|  |  |  |  | Data to Device N |  |  |  |  |  | Data to Device 1 |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 8 | 8 | 8 | 8 | 8 |  | 8 | 8 | 8 |  | 8 |  | 8 | 8 | 8 |
| CMDO | CMD1 | PECO | PEC1 | Data Byte Low | $\ldots$ | Data Byte High | PECO | PEC1 | $\ldots$ | Data Byte Low | $\cdots$ | Data Byte High | PECO | PEC1 |

Table 25. Address Write Command

| 8 | 8 | 8 | 8 | 8 |  | 8 | 8 | 8 |
| ---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CMD0 | CMD1 | PECO | PEC1 | Data Byte Low | $\ldots$ | Data Byte High | PECO | PEC1 |

Table 26. Broadcast Read Command

|  |  |  |  |  |  |  |  |  |  | Data from Device 1 |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 8 | 8 | 8 | 8 | 8 |  | 8 | 8 | 8 |  | 8 |  | 8 | 8 | 8 |
| CMD0 | CMD1 | PECO | PEC1 | Data Byte <br> Low | $\ldots$ | Data Byte <br> High | PEC0 | PEC1 | $\ldots$ | Data Byte <br> Low | $\ldots$ | Data Byte <br> High | PECO | PEC1 |

Table 27. Address Read Command

| 8 | 8 | 8 | 8 | 8 |  | 8 | 8 | 8 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CMD0 | CMD1 | PEC0 | PEC1 | Data Byte Low | $\ldots$ | Data Byte High | PEC0 | PEC1 |

OPERATION

Command Format: The formats for the broadcast and address commands are shown in Table 28 and Table 29 respectively. The 11-bit command code CC[10:0] is the same for a broadcast or an address command. A list of all the command codes is shown in Table 30. A broadcast command has a value 0 for CMD0[7] through CMDO[3]. An address command has a value 1 for CMDO[7] followed
by the 4-bit address of the device ( $\mathrm{a} 3, \mathrm{a} 2, \mathrm{a} 1, \mathrm{a} 0$ ) in bits CMDO[6:3]. An addressed device will respond to an address command only if the physical address of the device on pins A3 to A0 match the address specified in the address command. The PEC for broadcastand address commands must be computed on the entire 16-bit command (CMDO and CMD1).

Table 28. Broadcast Command Format

| NAME | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CMD0 | WR | 0 | 0 | 0 | 0 | 0 | CC[10] | CC[9] | CC[8] |
| CMD1 | WR | $\mathrm{CC}[7]$ | $\mathrm{CC}[6]$ | $\mathrm{CC}[5]$ | $\mathrm{CC}[4]$ | $\mathrm{CC}[3]$ | $\mathrm{CC}[2]$ | $\mathrm{CC}[1]$ | $\mathrm{CC}[0]$ |

Table 29. Address Command Format

| NAME | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CMD0 | WR | 1 | $\mathrm{a3}^{*}$ | $\mathrm{a} 2^{*}$ | $\mathrm{a} 1^{*}$ | $\mathrm{a} 0^{*}$ | $\mathrm{CC}[10]$ | $\mathrm{CC}[9]$ | $\mathrm{CC}[8]$ |
| CMD 1 | WR | $\mathrm{CC}[7]$ | $\mathrm{CC}[6]$ | $\mathrm{CC}[5]$ | $\mathrm{CC}[4]$ | $\mathrm{CC}[3]$ | $\mathrm{CC}[2]$ | $\mathrm{CC}[1]$ | $\mathrm{CC}[0]$ |

*ax is Address Bit x

## Commands

Table 30 lists all the commands and their options for the LTC6806.
Table 30. Command Codes

| COMMAND DESCRIPTION | NAME | 11 BIT COMMAND CODE |  |  |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| Write Configuration Register Group | WRCFG | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 |
| Read Configuration Register Group | RDCFG | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 |
| Read Cell Voltage Register Group A | RDCVA | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 |
| Read Cell Voltage Register Group B | RDCVB | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 1 |
| Read Cell Voltage Register Group C | RDCVC | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 0 |
| Read Cell Voltage Register Group D | RDCVD | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 |
| Read Cell Voltage Register Group E | RDCVE | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 |
| Read Cell Voltage Register Group F | RDCVF | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 1 |
| Read Cell Voltage Register Group G | RDCVG | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 1 | 0 |
| Read Cell Voltage Register Group H | RDCVH | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 1 | 1 |

## LTC6806

## operation

Table 30. Command Codes

| COMMAND DESCRIPTION | NAME | 11 BIT COMMAND CODE |  |  |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| Read Cell Voltage Register Group I | RDCVI | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 0 | 0 |
| Read Auxiliary Register Group A | RDAUXA | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 |
| Read Auxiliary Register Group B | RDAUXB | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 1 |
| Read Status Register Group A | RDSTATA | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 1 | 0 | 0 |
| Read Status Register Group B | RDSTATB | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 1 | 0 | 1 |
| Read Status Register Group C | RDSTATC | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 1 | 1 | 0 |
| Start Cell Voltage ADC Conversion and Poll Status | ADCV | 1 | 0 | 0 | $\begin{aligned} & \hline \mathrm{MD} \\ & {[1]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \hline \text { MD } \\ & {[0]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \hline \mathrm{CH} \\ & {[5]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \mathrm{CH} \\ & {[4]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \mathrm{CH} \\ & {[3]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \mathrm{CH} \\ & \text { [2] } \\ & \hline \end{aligned}$ | $\begin{aligned} & \hline \mathrm{CH} \\ & \text { [1] } \\ & \hline \end{aligned}$ | $\begin{aligned} & \mathrm{CH} \\ & {[0]} \\ & \hline \end{aligned}$ |
| Start Open Wire ADC Conversion and Poll Status | ADOW | 1 | 1 | PUP | $\begin{aligned} & \mathrm{MD} \\ & {[1]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \mathrm{MD} \\ & {[0]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \hline \mathrm{CH} \\ & {[5]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \hline \mathrm{CH} \\ & {[4]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \hline \mathrm{CH} \\ & {[3]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \mathrm{CH} \\ & {[2]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \mathrm{CH} \\ & \text { [1] } \\ & \hline \end{aligned}$ | $\begin{aligned} & \mathrm{CH} \\ & {[0]} \\ & \hline \end{aligned}$ |
| Start Cell Voltage Plus Sum of Cells ADC Conversion and Poll Status | ADCVSC | 1 | 0 | 0 | $\begin{gathered} \hline \mathrm{MD} \\ {[1]} \end{gathered}$ | $\begin{aligned} & \hline \text { MD } \\ & {[0]} \end{aligned}$ | 1 | 1 | 0 | 0 | 0 | 0 |
| Start Self-Test Cell Voltage Conversion and Poll Status | CVST | 1 | $\begin{aligned} & \hline \text { ST } \\ & {[1]} \end{aligned}$ | $\begin{aligned} & \hline \text { ST } \\ & {[0]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \hline \text { MD } \\ & {[1]} \end{aligned}$ | $\begin{aligned} & \mathrm{MD} \\ & {[0]} \end{aligned}$ | 1 | 1 | 1 | 1 | 1 | 1 |
| Stat GPIOs ADC Conversion and Poll Status | ADAX | 0 | 1 | 1 | $\begin{aligned} & \text { MD } \\ & \text { [1] } \end{aligned}$ | $\begin{aligned} & \text { MD } \\ & {[0]} \end{aligned}$ | 1 | 0 | 0 | $\begin{aligned} & \mathrm{AX} \\ & {[2]} \end{aligned}$ | $\begin{aligned} & \mathrm{AX} \\ & {[1]} \end{aligned}$ | $\begin{aligned} & \mathrm{AX} \\ & {[0]} \end{aligned}$ |
| Start GPIOs Plus Sum of Cells ADC Conversion and Poll Status | ADAXSC | 0 | 1 | 1 | $\begin{aligned} & \text { MD } \\ & {[1]} \end{aligned}$ | $\begin{aligned} & \mathrm{MD} \\ & {[0]} \end{aligned}$ | 1 | 1 | 0 | 0 | 0 | 0 |
| Start Self-Test GPIOs Conversion and Poll Status | AXST | 0 | $\begin{aligned} & \hline \text { ST } \\ & {[1]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \text { ST } \\ & {[0]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \hline \mathrm{MD} \\ & {[1]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \hline \text { MD } \\ & {[0]} \\ & \hline \end{aligned}$ | 1 | 1 | 0 | 1 | 1 | 1 |
| Start Status Group ADC Conversion and Poll Status | ADSTAT | 0 | 1 | 1 | $\begin{aligned} & \hline \mathrm{MD} \\ & {[1]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \mathrm{MD} \\ & {[0]} \\ & \hline \end{aligned}$ | 1 | 0 | 1 | $\begin{gathered} \hline \text { CHST } \\ {[2]} \end{gathered}$ | $\begin{gathered} \text { CHST } \\ {[1]} \\ \hline \end{gathered}$ | $\begin{gathered} \hline \text { CHST } \\ {[0]} \end{gathered}$ |
| Start Self-Test Status Group Conversion and Poll Status | STATST | 0 | $\begin{aligned} & \hline \text { ST } \\ & {[1]} \end{aligned}$ | $\begin{aligned} & \hline \text { ST } \\ & {[0]} \\ & \hline \end{aligned}$ | $\begin{aligned} & \hline \text { MD } \\ & {[1]} \end{aligned}$ | $\begin{aligned} & \mathrm{MD} \\ & {[0]} \end{aligned}$ | 1 | 1 | 1 | 1 | 1 | 1 |
| Clear Cell Voltage Register Group | CLRCELL | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 0 | 0 | 1 |
| Clear Auxiliary Register Group | CLRAUX | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 0 | 1 | 0 |
| Clear Status Register Group | CLRSTAT | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 0 | 1 | 1 |
| Poll ADC Conversion Status | PLADC | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 0 | 0 |
| Diagnose MUX and Poll Status | DIAGN | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 0 | 1 |

## OPERATION

Table 31. Command Bit Descriptions

| NAME | DESCRIPTION | VALUES |  |
| :---: | :---: | :---: | :---: |
| MD[1:0] | ADC Mode | MD |  |
|  |  | 00 | Fast Mode |
|  |  | 01 | Normal Mode |
|  |  | 10 | Alternate Mode |
|  |  | 11 | Filtered Mode |
| $\mathrm{CH}[5: 0]$ | Cell Selection for ADC Conversion | CH |  |
|  |  | 000000 | All Cells |
|  |  | 000001 | Cell 1 |
|  |  | *** |  |
|  |  | 100100 | Cell 36 |
|  |  | > 100100 | Invalid Selection |
| PUP | Pull-Up/Pull-Down Current for Open Wire Conversions | PUP |  |
|  |  | 1 | Pull-Down Current |
|  |  | 0 | Pull-Up Current |
| ST[1:0] | Self-Test Mode Selection | ST |  |
|  |  | 01 | Self-Test 1 |
|  |  | 10 | Self-Test 2 |
| AX[2:0] | AUX Channel Selection | AX |  |
|  |  | 000 | 2 ${ }^{\text {nd }}$ Reference + GPI01 - GPI06 |
|  |  | 001 | $2{ }^{\text {nd }}$ Reference |
|  |  | 010 | GPI01 |
|  |  | 011 | GPI02 |
|  |  | 100 | GPI03 |
|  |  | 101 | GPI04 |
|  |  | 110 | GPI05 |
|  |  | 111 | GPI06 |
| CHST[2:0] | Status Group Channel Selection | CHST |  |
|  |  | 000 | SC + ITMP + $\mathrm{V}^{+}$ |
|  |  | 001 | SC (Sum of Cells Measurement) |
|  |  | 010 | ITMP (Internal Temperature) |
|  |  | 011 | $\mathrm{V}^{+}$(5V Power Supply) |
|  |  | >011 | Invalid Selection |

## LTC6806

## OPERATION

## Memory Map

Table 32. Configuration Register Group

| REGISTER | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CFGR0 | RD/WR | RSVD | RSVD | GPI06 | GPI05 | GPI04 | GPI03 | GPI02 | GPI01 |
| CFGR1 | RD/WR | HIRNG | REFON | OWPCH[1] | OWPCH[0] | REV[3] | REV[2] | REV[1] | REV[0] |
| CFGR2 | RD/WR | MMD[1] | MMD[0] | FCHNL[5] | FCHNL[4] | FCHNL[3] | FCHNL[2] | FCHNL[1] | FCHNL[0] |
| CFGR3 | RD/WR | $\mathrm{VUV[11]}$ | $\mathrm{VUV[10]}$ | $\mathrm{VUV[9]}$ | $\mathrm{VUV[8]}$ | $\mathrm{VUV[7]}$ | $\mathrm{VUV[6]}$ | $\mathrm{VUV[5]}$ | $\mathrm{VUV[4]}$ |
| CFGR4 | $\mathrm{RD} / \mathrm{WR}$ | $\mathrm{VUV[3]}$ | $\mathrm{VUV[2]}$ | $\mathrm{VUV[1]}$ | $\mathrm{VUV[0]}$ | $\mathrm{VOV[11]}$ | $\mathrm{VOV[10]}$ | $\mathrm{VOV[9]}$ | $\mathrm{VOV[8]}$ |
| CFGR5 | $\mathrm{RD} / W R$ | $\mathrm{VOV[7]}$ | $\mathrm{VOV[6]}$ | $\mathrm{VOV}[5]$ | $\mathrm{VOV[4]}$ | $\mathrm{VOV[3]}$ | $\mathrm{VOV[2]}$ | $\mathrm{VOV[1]}$ | $\mathrm{VOV[0]}$ |

Table 33. Cell Voltage Register Group A

| REGISTER | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CVARO | RD | C1V[11] | C1V[10] | C1V[9] | C1V[8] | C1V[7] | C1V[6] | C1V[5] | C1V[4] |
| CVAR1 | RD | C1V[3] | C1V[2] | C1V[1] | C1V[0] | C2V[11] | C2V[10] | C2V[9] | C2V[8] |
| CVAR2 | RD | C2V[7] | C2V[6] | C2V[5] | C2V[4] | C2V[3] | C2V[2] | C2V[1] | C2V[0] |
| CVAR3 | RD | C3V[11] | C3V[10] | C3V[9] | C3V[8] | C3V[7] | C3V[6] | C3V[5] | C3V[4] |
| CVAR4 | RD | C3V[3] | C3V[2] | C3V[1] | C3V[0] | C4V[11] | C4V[10] | C4V[9] | C4V[8] |
| CVAR5 | RD | C4V[7] | C4V[6] | C4V[5] | C4V[4] | C4V[3] | C4V[2] | C4V[1] | C4V[0] |

Table 34. Cell Voltage Register Group B

| REGISTER | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CVBRO | RD | C5V[11] | C5V[10] | C5V[9] | C5V[8] | C5V[7] | C5V[6] | C5V[5] | C5V[4] |
| CVBR1 | RD | C5V[3] | C5V[2] | C5V[1] | C5V[0] | C6V[11] | C6V[10] | C6V[9] | C6V[8] |
| CVBR2 | RD | C6V[7] | C6V[6] | C6V[5] | C6V[4] | C6V[3] | C6V[2] | C6V[1] | C6V[0] |
| CVBR3 | RD | C7V[11] | C7V[10] | C7V[9] | C7V[8] | C7V[7] | C7V[6] | C7V[5] | C7V[4] |
| CVBR4 | RD | C7V[3] | C7V[2] | C7V[1] | C7V[0] | C8V[11] | C8V[10] | C8V[9] | C8V[8] |
| CVBR5 | RD | C8V[7] | C8V[6] | C8V[5] | C8V[4] | C8V[3] | C8V[2] | C8V[1] | C8V[0] |

Table 35. Cell Voltage Register Group C

| REGISTER | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CVCRO | RD | C9V[11] | C9V[10] | C9V[9] | C9V[8] | C9V[7] | C9V[6] | C9V[5] | C9V[4] |
| CVCR1 | RD | C9V[3] | C9V[2] | C9V[1] | C9V[0] | C10V[11] | C10V[10] | C10V[9] | C10V[8] |
| CVCR2 | RD | C10V[7] | C10V[6] | C10V[5] | C10V[4] | C10V[3] | C10V[2] | C10V[1] | C10V[0] |
| CVCR3 | RD | C11V[11] | C11V[10] | C11V[9] | C11V[8] | C11V[7] | C11V[6] | C11V[5] | C11V[4] |
| CVCR4 | RD | C11V[3] | C11V[2] | C11V[1] | C11V[0] | C12V[11] | C12V[10] | C12V[9] | C12V[8] |
| CVCR5 | RD | C12V[7] | C12V[6] | C12V[5] | C12V[4] | C12V[3] | C12V[2] | C12V[1] | C12V[0] |

## OPERATION

Table 36. Cell Voltage Register Group D

| REGISTER | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CVDR0 | RD | C13V[11] | C13V[10] | C13V[9] | C13V[8] | C13V[7] | C13V[6] | C13V[5] | C13V[4] |
| CVDR1 | RD | C13V[3] | C13V[2] | C13V[1] | C13V[0] | C14V[11] | C14V[10] | C14V[9] | C14V[8] |
| CVDR2 | RD | C14V[7] | C14V[6] | C14V[5] | C14V[4] | C14V[3] | C14V[2] | C14V[1] | C14V[0] |
| CVDR3 | RD | C15V[11] | C15V[10] | C15V[9] | C15V[8] | C15V[7] | C15V[6] | C15V[5] | C15V[4] |
| CVDR4 | RD | C15V[3] | C15V[2] | C15V[1] | C15V[0] | C16V[11] | C16V[10] | C16V[9] | C16V[8] |
| CVDR5 | RD | C16V[7] | C16V[6] | C16V[5] | C16V[4] | C16V[3] | C16V[2] | C16V[1] | C16V[0] |

Table 37. Cell Voltage Register Group E

| REGISTER | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CVERO | RD | C17V[11] | C17V[10] | C17V[9] | C17V[8] | C17V[7] | C17V[6] | C17V[5] | C17V[4] |
| CVER1 | RD | C17V[3] | C17V[2] | C17V[1] | C17V[0] | C18V[11] | C18V[10] | C18V[9] | C18V[8] |
| CVER2 | RD | C18V[7] | C18V[6] | C18V[5] | C18V[4] | C18V[3] | C18V[2] | C18V[1] | C18V[0] |
| CVER3 | RD | C19V[11] | C19V[10] | C19V[9] | C19V[8] | C19V[7] | C19V[6] | C19V[5] | C19V[4] |
| CVER4 | RD | C19V[3] | C19V[2] | C19V[1] | C19V[0] | C20V[11] | C20V[10] | C20V[9] | C20V[8] |
| CVER5 | RD | C20V[7] | C20V[6] | C20V[5] | C20V[4] | C20V[3] | C20V[2] | C20V[1] | C20V[0] |

Table 38. Cell Voltage Register Group F

| REGISTER | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CVFR0 | RD | $\mathrm{C} 21 \mathrm{~V}[11]$ | $\mathrm{C} 21 \mathrm{~V}[10]$ | $\mathrm{C} 21 \mathrm{~V}[9]$ | $\mathrm{C} 21 \mathrm{~V}[8]$ | $\mathrm{C} 21 \mathrm{~V}[7]$ | $\mathrm{C} 21 \mathrm{~V}[6]$ | $\mathrm{C} 21 \mathrm{~V}[5]$ | $\mathrm{C} 21 \mathrm{~V}[4]$ |
| CVFR1 | RD | $\mathrm{C} 21 \mathrm{~V}[3]$ | $\mathrm{C} 21 \mathrm{~V}[2]$ | $\mathrm{C} 21 \mathrm{~V}[1]$ | $\mathrm{C} 21 \mathrm{~V}[0]$ | $\mathrm{C} 22 \mathrm{~V}[11]$ | $\mathrm{C} 22 \mathrm{~V}[10]$ | $\mathrm{C} 22 \mathrm{~V}[9]$ | $\mathrm{C} 22 \mathrm{~V}[8]$ |
| CVFR2 | RD | $\mathrm{C} 22 \mathrm{~V}[7]$ | $\mathrm{C} 22 \mathrm{~V}[6]$ | $\mathrm{C} 22 \mathrm{~V}[5]$ | $\mathrm{C} 22 \mathrm{~V}[4]$ | $\mathrm{C} 22 \mathrm{~V}[3]$ | $\mathrm{C} 22 \mathrm{~V}[2]$ | $\mathrm{C} 22 \mathrm{~V}[1]$ | $\mathrm{C} 22 \mathrm{~V}[0]$ |
| CVFR3 | RD | $\mathrm{C} 23 \mathrm{~V}[11]$ | $\mathrm{C} 23 \mathrm{~V}[10]$ | $\mathrm{C} 23 \mathrm{~V}[9]$ | $\mathrm{C} 23 \mathrm{~V}[8]$ | $\mathrm{C} 23 \mathrm{~V}[7]$ | $\mathrm{C} 23 \mathrm{~V}[6]$ | $\mathrm{C} 23 \mathrm{~V}[5]$ | $\mathrm{C} 23 \mathrm{~V}[4]$ |
| CVFR4 | RD | $\mathrm{C} 23 \mathrm{~V}[3]$ | $\mathrm{C} 23 \mathrm{~V}[2]$ | $\mathrm{C} 23 \mathrm{~V}[1]$ | $\mathrm{C} 23 \mathrm{~V}[0]$ | $\mathrm{C} 24 \mathrm{~V}[11]$ | $\mathrm{C} 24 \mathrm{~V}[10]$ | $\mathrm{C} 24 \mathrm{~V}[9]$ | $\mathrm{C} 24 \mathrm{~V}[8]$ |
| CVFR5 | RD | $\mathrm{C} 24 \mathrm{~V}[7]$ | $\mathrm{C} 24 \mathrm{~V}[6]$ | $\mathrm{C} 24 \mathrm{~V}[5]$ | $\mathrm{C} 24 \mathrm{~V}[4]$ | $\mathrm{C} 24 \mathrm{~V}[3]$ | $\mathrm{C} 24 \mathrm{~V}[2]$ | $\mathrm{C} 24 \mathrm{~V}[1]$ | $\mathrm{C} 24 \mathrm{~V}[0]$ |

Table 39. Cell Voltage Register Group G

| REGISTER | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CVGR0 | RD | C25V[11] | C25V[10] | $\mathrm{C} 25 \mathrm{~V}[9]$ | $\mathrm{C} 25 \mathrm{~V}[8]$ | $\mathrm{C} 25 \mathrm{~V}[7]$ | $\mathrm{C} 25 \mathrm{~V}[6]$ | $\mathrm{C} 25 \mathrm{~V}[5]$ | $\mathrm{C} 25 \mathrm{~V}[4]$ |
| CVGR1 | RD | $\mathrm{C} 25 \mathrm{~V}[3]$ | $\mathrm{C} 25 \mathrm{~V}[2]$ | $\mathrm{C} 25 \mathrm{~V}[1]$ | $\mathrm{C} 25 \mathrm{~V}[0]$ | $\mathrm{C} 26 \mathrm{~V}[11]$ | $\mathrm{C} 26 \mathrm{~V}[10]$ | $\mathrm{C} 26 \mathrm{~V}[9]$ | $\mathrm{C} 26 \mathrm{~V}[8]$ |
| CVGR2 | RD | $\mathrm{C} 26 \mathrm{~V}[7]$ | $\mathrm{C} 26 \mathrm{~V}[6]$ | $\mathrm{C} 26 \mathrm{~V}[5]$ | $\mathrm{C} 26 \mathrm{~V}[4]$ | $\mathrm{C} 26 \mathrm{~V}[3]$ | $\mathrm{C} 26 \mathrm{~V}[2]$ | $\mathrm{C} 26 \mathrm{~V}[1]$ | $\mathrm{C} 26 \mathrm{~V}[0]$ |
| CVGR3 | RD | $\mathrm{C} 27 \mathrm{~V}[11]$ | $\mathrm{C} 27 \mathrm{~V}[10]$ | $\mathrm{C} 27 \mathrm{~V}[9]$ | $\mathrm{C} 27 \mathrm{~V}[8]$ | $\mathrm{C} 27 \mathrm{~V}[7]$ | $\mathrm{C} 27 \mathrm{~V}[6]$ | $\mathrm{C} 27 \mathrm{~V}[5]$ | $\mathrm{C} 27 \mathrm{~V}[4]$ |
| CVGR4 | RD | $\mathrm{C} 27 \mathrm{~V}[3]$ | $\mathrm{C} 27 \mathrm{~V}[2]$ | $\mathrm{C} 27 \mathrm{~V}[1]$ | $\mathrm{C} 27 \mathrm{~V}[0]$ | $\mathrm{C} 28 \mathrm{~V}[11]$ | $\mathrm{C} 28 \mathrm{~V}[10]$ | $\mathrm{C} 28 \mathrm{~V}[9]$ | $\mathrm{C} 28 \mathrm{~V}[8]$ |
| CVGR5 | RD | $\mathrm{C} 28 \mathrm{~V}[7]$ | $\mathrm{C} 28 \mathrm{~V}[6]$ | $\mathrm{C} 28 \mathrm{~V}[5]$ | $\mathrm{C} 28 \mathrm{~V}[4]$ | $\mathrm{C} 28 \mathrm{~V}[3]$ | $\mathrm{C} 28 \mathrm{~V}[2]$ | $\mathrm{C} 28 \mathrm{~V}[1]$ | $\mathrm{C} 28 \mathrm{~V}[0]$ |

## LTC6806

## operation

Table 40. Cell Voltage Register Group H

| REGISTER | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CVHRO | RD | C29V[11] | C29V[10] | C29V[9] | C29V[8] | C29V[7] | C29V[6] | C29V[5] | C29V[4] |
| CVHR1 | RD | C29V[3] | C29V[2] | C29V[1] | C29V[0] | C30V[11] | C30V[10] | C30V[9] | C30V[8] |
| CVHR2 | RD | C30V[7] | C30V[6] | C30V[5] | C30V[4] | C30V[3] | C30V[2] | C30V[1] | C30V[0] |
| CVHR3 | RD | C31V[11] | C31V[10] | C31V[9] | C31V[8] | C31V[7] | C31V[6] | C31V[5] | C31V[4] |
| CVHR4 | RD | C31V[3] | C31V[2] | C31V[1] | C31V[0] | C32V[11] | C32V[10] | C32V[9] | C32V[8] |
| CVHR5 | RD | C32V[7] | C32V[6] | C32V[5] | C32V[4] | C32V[3] | C32V[2] | C32V[1] | C32V[0] |

Table 41. Cell Voltage Register Group I

| REGISTER | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CVIR0 | RD | $\mathrm{C} 33 \mathrm{~V}[11]$ | $\mathrm{C} 33 \mathrm{~V}[10]$ | $\mathrm{C} 33 \mathrm{~V}[9]$ | $\mathrm{C} 33 \mathrm{~V}[8]$ | $\mathrm{C} 33 \mathrm{~V}[7]$ | $\mathrm{C} 33 \mathrm{~V}[6]$ | $\mathrm{C} 33 \mathrm{~V}[5]$ | $\mathrm{C} 33 \mathrm{~V}[4]$ |
| CVIR1 | RD | $\mathrm{C} 33 \mathrm{~V}[3]$ | $\mathrm{C} 3 \mathrm{~V}[2]$ | $\mathrm{C} 33 \mathrm{~V}[1]$ | $\mathrm{C} 33 \mathrm{~V}[0]$ | $\mathrm{C} 34 \mathrm{~V}[11]$ | $\mathrm{C} 34 \mathrm{~V}[10]$ | $\mathrm{C} 34 \mathrm{~V}[9]$ | $\mathrm{C} 34 \mathrm{~V}[8]$ |
| CVIR2 | RD | $\mathrm{C} 34 \mathrm{~V}[7]$ | $\mathrm{C} 34 \mathrm{~V}[6]$ | $\mathrm{C} 34 \mathrm{~V}[5]$ | $\mathrm{C} 34 \mathrm{~V}[4]$ | $\mathrm{C} 34 \mathrm{~V}[3]$ | $\mathrm{C} 34 \mathrm{~V}[2]$ | $\mathrm{C} 34 \mathrm{~V}[1]$ | $\mathrm{C} 34 \mathrm{~V}[0]$ |
| CVIR3 | RD | $\mathrm{C} 35 \mathrm{~V}[11]$ | $\mathrm{C} 35 \mathrm{~V}[10]$ | $\mathrm{C} 35 \mathrm{~V}[9]$ | $\mathrm{C} 35 \mathrm{~V}[8]$ | $\mathrm{C} 35 \mathrm{~V}[7]$ | $\mathrm{C} 35 \mathrm{~V}[6]$ | $\mathrm{C} 35 \mathrm{~V}[5]$ | $\mathrm{C} 35 \mathrm{~V}[4]$ |
| CVIR4 | RD | $\mathrm{C} 35 \mathrm{~V}[3]$ | $\mathrm{C} 35 \mathrm{~V}[2]$ | $\mathrm{C} 35 \mathrm{~V}[1]$ | $\mathrm{C} 35 \mathrm{~V}[0]$ | $\mathrm{C} 36 \mathrm{~V}[11]$ | $\mathrm{C} 36 \mathrm{~V}[10]$ | $\mathrm{C} 36 \mathrm{~V}[9]$ | $\mathrm{C} 36 \mathrm{~V}[8]$ |
| CVIR5 | RD | $\mathrm{C} 36 \mathrm{~V}[7]$ | $\mathrm{C} 36 \mathrm{~V}[6]$ | $\mathrm{C} 36 \mathrm{~V}[5]$ | $\mathrm{C} 36 \mathrm{~V}[4]$ | $\mathrm{C} 36 \mathrm{~V}[3]$ | $\mathrm{C} 36 \mathrm{~V}[2]$ | $\mathrm{C} 36 \mathrm{~V}[1]$ | $\mathrm{C} 36 \mathrm{~V}[0]$ |

Table 42. Auxiliary Register Group A

| REGISTER | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| AVAR0 | RD | VREF2[11] | VREF2[10] | VREF2[9] | VREF2[8] | VREF2[7] | VREF2[6] | VREF2[5] | VREF2[4] |
| AVAR1 | RD | VREF2[3] | VREF2[2] | VREF2[1] | VREF2[0] | G1V[11] | G1V[10] | G1V[9] | G1V[8] |
| AVAR2 | RD | G1V[7] | G1V[6] | G1V[5] | G1V[4] | G1V[3] | G1V[2] | G1V[1] | G1V[0] |
| AVAR3 | RD | G2V[11] | G2V[10] | G2V[9] | G2V[8] | G2V[7] | G2V[6] | G2V[5] | G2V[4] |
| AVAR4 | RD | G2V[3] | G2V[2] | G2V[1] | G2V[0] | G3V[11] | G3V[10] | G3V[9] | G3V[8] |
| AVAR5 | RD | G3V[7] | G3V[6] | G3V[5] | G3V[4] | G3V[3] | G3V[2] | G3V[1] | G3V[0] |

Table 43. Auxiliary Register Group B

| REGISTER | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| AVBRO | RD | G4V[11] | G4V[10] | G4V[9] | G4V[8] | G4V[7] | G4V[6] | G4V[5] | G4V[4] |
| AVBR1 | RD | G4V[3] | G4V[2] | G4V[1] | G4V[0] | G5V[11] | G5V[10] | G5V[9] | G5V[8] |
| AVBR2 | RD | G5V[7] | G5V[6] | G5V[5] | G5V[4] | G5V[3] | G5V[2] | G5V[1] | G5V[0] |
| AVBR3 | RD | G6V[11] | G6V[10] | G6V[9] | G6V[8] | G6V[7] | G6V[6] | G6V[5] | G6V[4] |
| AVBR4 | RD | G6V[3] | G6V[2] | G6V[1] | G6V[0] | RSVD | RSVD | RSVD | RSVD |
| AVBR5 | RD | RSVD | RSVD | RSVD | RSVD | RSVD | RSVD | RSVD | RSVD |

## OPERATION

Table 44. Status Register Group A

| REGISTER | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| STAR0 | RD | C40V | C4UV | C30V | C3UV | C20V | C2UV | C10V | C1UV |
| STAR1 | RD | C80V | C8UV | C70V | C7UV | C60V | C6UV | C50V | C5UV |
| STAR2 | RD | C120V | C12UV | C110V | C11UV | C100V | C10UV | C90V | C9UV |
| STAR3 | RD | C160V | C16UV | C150V | C15UV | C140V | C14UV | C130V | C13UV |
| STAR4 | RD | C200V | C20UV | C190V | C19UV | C180V | C18UV | C170V | C17UV |
| STAR5 | RD | C240V | C24UV | C230V | C23UV | C220V | C22UV | C210V | C21UV |

Table 45. Status Register Group B

| REGISTER | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| STBR0 | RD | C280V | C28UV | C270V | C27UV | C260V | C26UV | C250V | C25UV |
| STBR1 | RD | C320V | C32UV | C310V | C31UV | C300V | C30UC | C290V | C29UV |
| STBR2 | RD | C360V | C36UV | C350V | C35UV | C340V | C34UV | C330V | C33UV |
| STBR3 | RD | RSVD | RSVD | RSVD | RSVD | RSVD | RSVD | RSVD | RSVD |
| STBR4 | RD | RSVD | RSVD | RSVD | RSVD | RSVD | RSVD | RSVD | RSVD |
| STBR5 | RD | 0T | UT | RSVD | RSVD | RSVD | STXFF | STXFS | MUXFAIL |

Table 46. Status Register Group C

| REGISTER | RD/WR | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| STCR0 | RD | SC[11] | SC[10] | SC[9] | SC[8] | SC[7] | SC[6] | SC[5] | SC[4] |
| STCR1 | RD | SC[3] | SC[2] | SC[1] | SC[0] | ITMP[11] | IMTP[10] | ITMP[9] | ITMP[8] |
| STCR2 | RD | ITMP[7] | ITMP[6] | ITMP[5] | ITMP[4] | ITMP[3] | ITMP[2] | ITMP[1] | ITMP[0] |
| STCR3 | RD | $\mathrm{V}+[11]$ | $\mathrm{V}+$ [10] | $\mathrm{V}+[9]$ | $\mathrm{V}^{+}[8]$ | V+[7] | $\mathrm{V}+[6]$ | $\mathrm{V}+5]$ | $\mathrm{V}+[4]$ |
| STCR4 | RD | $\mathrm{V}+3]$ | $\mathrm{V}^{+}[2]$ | $\mathrm{V}^{+}[1]$ | $\mathrm{V}^{+}[0]$ | RSVD | RSVD | RSVD | RSVD |
| STCR5 | RD | RSVD | RSVD | RSVD | RSVD | RSVD | RSVD | RSVD | RSVD |

## Table 47. Memory Bit Descriptions

| NAME | DESCRIPTION | VALUES |
| :--- | :--- | :--- |
| RSVD | Reserved Bit |  |
| GPIOx | GPIOx Pin Control | $x=1$ to 6 <br> Write: $0->$ GPIOx Pin Pull-Down ON; $1->$ GPIOx Pin Pull-Down OFF <br> Read: $0->$ GPIOx Pin at Logic $0 ; 1->$ GPIOx Pin at Logic 1 <br> Default: GPIOx $=1$ |
| HIRNG | Cell Measurement <br> Range Selection | $1->$ Cell Precision Range $=-5 \mathrm{~V}$ to 5 V <br> $0->$ Cell Precision Range $=-2.5 \mathrm{~V}$ to 2.5 V <br> Default: HIRNG $=0$ |
| REFON | Reference <br> Powered Up | $1->$ Reference Remains Powered <br> $0->$ Reference Shuts Down after Conversions <br> Default: REFON $=0$ |

## LTC6806

## operation

## Table 47. Memory Bit Descriptions

| NAME | DESCRIPTION | VALUES |
| :---: | :---: | :---: |
| OWPCH | Open Wire Precharge Time | $\begin{aligned} & 00->0.1 \mathrm{~ms} \\ & 01->1 \mathrm{~ms} \\ & 10->10 \mathrm{~ms} \\ & 11->100 \mathrm{~ms} \\ & \text { Default: OWPCH = } 00 \end{aligned}$ |
| REV | Revision Code | Device Revision Code |
| MMD | Monitor Mode Selection | 00 -> Monitoring Disabled <br> $01->$ Monitor in Normal ADC Mode <br> $10->$ Monitor in Alternate ADC Mode <br> $11->$ Monitor in Filtered ADC Mode <br> Default: MMD $=00$ |
| FCHNL | First Channel for Monitoring | Specifies First Cell Channel for Monitoring. During the monitor cycle the IC will monitor cell channels from FCHNL to 36, then V REF2 , GPIO1 and GPIO2 channels. <br> Valid Range $=1$ to 36 Else All Cell Channels Will Be Monitored <br> Default: FCHNL $=0 \times 00$ |
| VUV | Undervoltage Comparison Voltage* | Comparison Voltage $=$ VUV $\cdot 1.5 \mathrm{mV}$ when $\mathrm{HIRNG}=0$ Comparison Voltage $=\mathrm{VUV} \cdot 3 \mathrm{mV}$ when HIRNG $=1$ 100mV Hysteresis Is Applied During Monitoring Default: VUV = $0 \times 000$ |
| VOV | Overvoltage Comparison Voltage* | Comparison Voltage $=$ VUV $\bullet 1.5 \mathrm{mV}$, Cell Measurements with HIRNG $=0$ <br> Comparison Voltage $=\mathrm{VUV} \cdot 3 \mathrm{mV}$, Cell Measurements with HIRNG $=1$ 100 mV Hysteresis Is Applied During Monitoring <br> Default: VOV = 0x000 |
| CxV | Cell ' $x$ ' Voltage* | $\begin{array}{\|ll} x=1 \text { to } 36 & \text { 12-Bit ADC Measurement Value for Cell ' } x \text { ' } \\ & \text { Cell Voltage for Cell ' } x \text { ' }=\text { CxV } \bullet 1.5 \mathrm{mV}(\text { HIRNG }=0 \text { ) or } 3.0 \mathrm{mV}(\text { HIRNG }=1) \\ & \text { CxV Is Reset To OXFFF on Power-Up and After Clear Command } \end{array}$ |
| AxV | Auxiliary Channel ' $x$ ' Voltage* | $\begin{array}{\|ll} \hline \mathrm{x}=1 \text { to } 6 & \text { 12-Bit ADC Measurement Value for GPIO Channel ' } \mathrm{x} \text { ' } \\ & \text { Voltage for Aux Channel ' } \mathrm{x} \text { ' }=\mathrm{AxV} \bullet 1.5 \mathrm{mV} \\ & \text { AxV Is Reset to OxFFF on Power-Up and After Clear Command } \end{array}$ |
| REF | $2^{\text {nd }}$ Reference Voltage* | 12-Bit ADC Measurement Value for $2^{\text {nd }}$ Reference <br> Voltage for $2^{\text {nd }}$ Reference $=$ REF $\cdot 1.5 \mathrm{mV}$ <br> Normal Range Is Within 2.4V to 2.6 V <br> REF Is Reset to OxFFF on Power-Up and After Clear Command |
| CxOV | Cell 'x' Overvoltage Flag | $x=1$ to 36 Cell Voltage Compared to VOV Comparison Voltage <br> $0->$ Cell $x$ Not Flagged for Overvoltage Condition. 1 -> Cell x Flagged |
| CxUV | Cell 'x' Undervoltage Flag | $x=1$ to 36 Cell Voltage Compared to VUV Comparison Voltage <br> $0->$ Cell $x$ Not Flagged for Undervoltage Condition. 1 -> Cell x Flagged |
| OT | Over Temperature Flag | Read: 1 -> GPIO2 < V REF2 $^{2} / 2$ with 100 mV Hysteresis Read: 0 -> GPIO2 $\geq$ V $_{\text {REF2 }} / 2$ with 100 mV Hysteresis Defaults to 1 when Not Monitoring |
| UT | Under Temperature Flag | Read: 1 -> GPI01 $\geq$ V $_{\text {REF2 }} / 2$ with 100 mV Hysteresis Read: 0 -> GPI01 < V REF2/2 with 100 mV Hysteresis Defaults to 1 when Not Monitoring |
| STXFF | Serial Transfer Self-Test Flag | Read: 0 -> All Previous ADC Commands Since the Last DIAGN Command Have Passed the Serial Transfer Self-Test Read: $1->$ At Least One of the ADC Commands Since the Last DIAGN Command Has Failed the Serial Transfer Self-Test This bit can be asserted by sending the CLRSTAT command. |
| STXFS | Serial Transfer Self-Test Status | Read: 0 -> The Previous ADC Command Passed the Serial Transfer Self-Test Read: 1 -> The Previous ADC Command Failed the Serial Transfer Self-Test This bit can be asserted by sending the CLRSTAT command. |

## OPERATION

## Table 47. Memory Bit Descriptions

| NAME | DESCRIPTION | VALUES |
| :---: | :---: | :---: |
| MUXFAIL | Multiplexer Self-Test Result | Read: 0 -> Multiplexer Passed Self-Test Read: 1 -> Multiplexer Failed Self-Test |
| SC | Sum of Cells Measurement* | 12-Bit ADC Measurement Value of the Sum of All Cell Voltages Sum of All Cells Voltage $=\mathrm{SC} \bullet 1.5 \mathrm{mV} \bullet 72$ <br> SC Is Reset to OxFFF on Power-Up and After Clear Command |
| ITMP | Internal Die Temperature* | 12-Bit ADC Measurement Value of Internal Die Temperature Temperature Measurement $=\mathrm{ITMP} \bullet 1.5 \mathrm{mV} /(4.65 \mathrm{mV} / \mathrm{K})-266 \mathrm{~K}$ ITMP Is Reset to OxFFF on Power-Up and After Clear Command |
| $\mathrm{V}^{+}$ | 5V Power Supply Voltage* | 12-Bit ADC Measurement Value of 5V Power Supply Voltage Analog Power Supply Voltage $=\mathrm{V}^{+} \bullet 1.875 \mathrm{mV}$ Normal Range Is within 4.75 V to 5.5 V $\mathrm{V}^{+}$Is Reset to OxFFF on Power-Up and After Clear Command |

* Voltage equations use the decimal value of registers, 0 to 4095 for 12 bits.


## PROGRAMMING EXAMPLES

The following examples use a configuration of three stacked LTC6806 devices in daisy-chain mode : bottom (B), middle ( M ) and top ( T ). The low side port on the bottom device is configured in SPI mode.

## Write Configuration Registers

1. Pull CSBI low.
2. Send WRCFG command ( $0 \times 0001$ ) and its PEC word (0x3D6E).
3. Send CFGRO byte of top device, then CFGR1(T), ... CFGR5(T), PEC of CFGRO(T) to CFGR5(T).
4. Send CFGRO byte of middle device, then CFGR1 (M), ...CFGR5(M), PEC of CFGRO(M) to CFGR5(M).
5. Send CFGRO byte of bottom device, then CFGR1(B), $\ldots$ CFGR5(B), PEC of CFGRO(B) to CFGR5(B).
6. Pull CSBI high, data latched into all devices on rising edge of CSBI.
Calculation of serial interface time for sequence above:
Number of devices in stack $=\mathrm{N}$
Number of bytes in sequence (B):
Command: 2 (command byte) $+2($ command PEC $)=4$

Data: 6 (Data bytes) +2 (Data PEC) per device $=8$ per device
B $=4+8 \cdot N$
Serial port frequency per bit $=\mathrm{F}$
Time $=(1 / \mathrm{F}) \cdot \mathrm{B} \bullet 8$ bits/byte $=(1 / \mathrm{F}) \bullet[4+8 \bullet \mathrm{~N}] \bullet 8$
Time for 3 cell example above, with 1 MHz serial port $=$ $(1 / 1 e 6) \cdot(4+8 \cdot 3) \cdot 8=224 \mu \mathrm{~s}$
Note: This time will remain the same for all write and read commands.

## Read Cell Voltage Register Group A

1. Pull CSBI low.
2. Send RDCVA command ( $0 x 0004$ ) and its PEC word (0x07C2).
3. Read CVARO byte of bottom device, then CVAR1(B), ... CVAR5(B), PEC of CVARO(B) to CVAR5(B).
4. Read CVARO byte of middle device, then CVAR1 (M), ...CVAR5(M), PEC of CVARO(M) to CVAR5(M).
5. Read CVARO byte of top device, then CVAR1(T), ... CVAR5(T), PEC of CVARO(T) to CVAR5(T).
6. Pull CSBI high.

## LTC6806

## operation

## Start Cell Voltage ADC Conversion

(All cells, normal mode and poll status)

1. Pull CSBI low.
2. Send ADCV command with MD $=1$ and i.e. $0 \times 0440$ and its PEC word (0xEDBO).
3. SDO output of the bottom device is pulled for the duration of the conversion ( $\sim 10.3 \mathrm{~ms}$ ).
4. SDO output goes high indicating conversions are complete for all devices in the daisy chain.
5. Pull CSBI high to exit polling.

## Clear Cell Voltage Registers

1. Pull CSBI Iow.
2. Send CLRCELL command ( $0 \times 0011$ ) and its PEC word (0x6640).
3. Pull CSBI high.

## Poll ADC Status

(Daisy-chained configuration, 3 stacked devices)

1. Pull CSBI low.
2. Send PLADC command ( $0 \times 001 \mathrm{C}$ ) and its PEC word (0xB4E2).
3. Continue to send clock pulses on SCK.
4. SDO output of bottom device is valid after the 3rd clock pulse (for 3 stacked devices).
5. SDO is updated after every clock pulse after the 3rd pulse.
6. SDO is low if ADC conversions are not complete and goes high if conversions are complete for all devices in the daisy chain.
7. Pull CSBI high to exit polling.

## Poll ADC Status

(Parallel configuration)
This example uses an addressed LTC6806 device with address A [3:0] = 0011.

1. Pull CSBI low.
2. Send PLADC command ( $0 \times 981 \mathrm{C}$ ) and its PEC word (0x5BC6).
3. SDO output is pulled low if the device is busy.
4. SDO output is high if the device has completed conversions.
5. Pull CSBI high to exit polling.

## APPLICATIONS INFORMATION

## PROVIDING DC POWER

## Power Supply Connections

The LTC6806 draws its power from the $\mathrm{V}^{+}$pin. 4.75 V to 5.5 V should be supplied to $\mathrm{V}^{+}$. A DC to DC converter can drive $\mathrm{V}^{+} . \mathrm{V}^{-}$and $\mathrm{V}^{-*}$ pins should be shorted together externally. $\mathrm{V}^{+}$should be bypassed by a quality $1 \mu \mathrm{~F}$ capacitor, located close to the supply pins of the IC.
When using the 4 -wire SPI mode, port A may be connected directly to a microprocessor. This connection will require that the processor share its logic ground with the $\mathrm{V}^{-}$of the LTC6806, and pass its 5 V power to $\mathrm{V}^{+}$. This is not an isolated circuit, so the processor will operate at
the potential of the cell group, possibly at a dangerous potential. In many cases the processor is powered and interfaced to other equipment with isolated circuitry that can make this a safe practice.

## Generating an Isolated Supply

A DC to DC converter and a data isolator can be used in the SPI path to the microprocessor as shown in Figure 26, which features the integrated power and data isolation $\mu$ Module ${ }^{\circledR}$, the LTC2883-5S. This arrangement allows the microprocessor to operate at a safe potential and avoid ground noise coupling as well. Note that the 4 -wire SPI is not intended for transmission over a significant distance, so it is best for circuits that share a circuit board.


Figure 26. Providing Fully Isolated Power and 4-Wire SPI Communication.

## APPLICATIONS INFORMATION

Designs that use the isoSPI interface will need to implement an isolated supply to power the LTC6806. Figure 27 shows an example of a fully isolated power supply that can be used. The isolated power supply uses a no-opto isolated flyback converter that requires only a single 210k resistor to program the output voltage. on the isolated side,
a Zener diode is required to regulate the supply voltage in low load situations, such as when the LTC6806 is in STANDBY or IDLE mode. For the lowest power consumption, the isolated supply can be disabled either by removing the $7 \mathrm{~V}-12 \mathrm{~V}$ supply or disabling the part via the EN pin.


Figure 27. Providing Fully Isolated Data Link and Power Over Long Interconnections.

## DIGITAL COMMUNICATIONS

## PEC Calculation

The Packet Error Code(PEC) provides confidence that the serial data read from the LTC6806 is valid and has not been corrupted by any external noise source. This checking feature is critical for reliable communication; the part requires that a PEC be calculated for all data being read from and written to the LTC6806. For this reason it is important to have an efficient method for calculating the PEC. The C code below demonstrates a simple implementation of a lookup table derived PEC
calculation method. There are two functions. The first function init_PEC15_Table() should only be called once when the microprocessor starts; the function will initialize a PEC15 table array called pec15Table[]. This table will be used in all future PEC calculations. The PEC15 table can also be hard coded into the microprocessor rather than running the init_PEC15_Table() function at startup. The pec15() function calculates the PEC and will return the correct 15-bit PEC for byte arrays of any given length.

APPLICATIONS INFORMATION

```
/*****************************************
Copyright 2012 Linear Technology Corp. (LTC)
Permission to freely use, copy, modify, and distribute this software for any
purpose with or without fee is hereby granted, provided that the above
copyright notice and this permission notice appear in all copies:
THIS SOFTWARE IS PROVIDED "AS IS" AND LTC DISCLAIMS ALL WARRANTIES
INCLUDING ALL IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS. IN NO
EVENT SHALL LTC BE LIABLE FOR ANY SPECIAL, DIRECT, INDIRECT, OR CONSEQUENTIAL
DAMAGES OR ANY DAMAGES WHATSOEVER RESULTING FROM ANY USE OF SAME, INCLUDING
ANY LOSS OF USE OR DATA OR PROFITS, WHETHER IN AN ACTION OF CONTRACT, NEGLIGENCE
OR OTHER TORTUOUS ACTION, ARISING OUT OF OR IN CONNECTION WITH THE USE OR
PERFORMANCE OF THIS SOFTWARE.
*******************************************************************/
int16 pec15Table[256];
int16 CRC15 POLY = 0x4599;
void init_PE\overline{C15_Table()}
{
    for (int i = 0; i < 256; i++)
    {
        remainder = i << 7;
        for (int bit = 8; bit > 0; --bit)
        {
            if (remainder & 0x4000)
            {
                remainder = ((remainder << 1));
                        remainder = (remainder ^ CRC15_POLY)
            }
            else
            {
                                    remainder = ((remainder << 1));
                            }
        }
    pec15Table[i] = remainder&0xFFFF;
    }
}
unsigned int16 pec15 (char *data , int len)
{
    int16 remainder,address;
    remainder = 16;//PEC seed
    for (int i = 0; i < len; i++)
    {
        address = ((remainder >> 7) ^ data[i]) & 0xff;//calculate PEC table address
        remainder = (remainder << 8 ) ^ pec15Table[address];
    }
    return (remainder*2);//The CRC15 has a 0 in the LSB so the final value must be multiplied by 2
}
```


## APPLICATIONS INFORMATION

## CONFIGURING isoSPI HARDWARE

## isoSPI IBIAS and ICMP Setup

The LTC6806 allows the isoSPI links of each application to be optimized for power consumption or for noise immunity. The power and noise immunity of an isoSPI system is determined by the programmed $\mathrm{I}_{\mathrm{B}}$ current, which controls the isoSPI signaling currents. Bias current $I_{B}$ can range from $100 \mu A$ to 1 mA . Internal circuitry scales up this bias current to create the isoSPI signal currents equal to be $20 \cdot I_{B}$. A low $I_{B}$ reduces the isoSPI power consumption in the READY and ACTIVE states, while a high $I_{B}$ increases the amplitude of the differential signal voltage $\mathrm{V}_{\mathrm{A}}$ across the matching termination resistor, $\mathrm{R}_{\mathrm{M}}$. The $I_{B}$ current is programmed by the sum of the $\mathrm{R}_{\mathrm{B} 1}$ and $\mathrm{R}_{\mathrm{B} 2}$ resistors connected between the 2V IBIAS pin and GND as shown in Figure 28. The receiver input threshold is set by the ICMP voltage that is programmed with the resistor divider created by the $\mathrm{R}_{\mathrm{B} 1}$ and $\mathrm{R}_{\mathrm{B} 2}$ resistors. The receiver differential threshold will be half of the voltage present on the ICMP pin.

The following guidelines should be used when setting the bias current ( $100 \mu \mathrm{~A}$ to 1 mA ) $\mathrm{I}_{\mathrm{B}}$ and the receiver comparator threshold voltage $\mathrm{V}_{\mathrm{ICMP}} / 2$ :
$\mathrm{R}_{\mathrm{M}}=$ Transmission Line Characteristic Impedance $\mathrm{Z}_{0}$
Signal Amplitude $\mathrm{V}_{\mathrm{A}}=\left(20 \cdot \mathrm{I}_{\mathrm{B}}\right) \cdot\left(\mathrm{R}_{\mathrm{M}} / 2\right)$
$V_{\text {TCMP }}$ (Receiver Comparator Threshold) $=K \bullet V_{A}$
$V_{\text {ICMP }}$ (Voltage on ICMP pin) $=2 \bullet V_{\text {TCMP }}$

$$
\begin{aligned}
& \mathrm{R}_{\mathrm{B} 2}=\mathrm{V}_{\text {ICMP }} / I_{\mathrm{B}}=20 \cdot \mathrm{~K} \cdot \mathrm{R}_{\mathrm{M}} \\
& \mathrm{R}_{\mathrm{B} 1}=\left(2 / \mathrm{I}_{\mathrm{B}}\right)-\mathrm{R}_{\mathrm{B} 2}
\end{aligned}
$$

Select $I_{B}$ and $K$ (ratio of Receiver Comparator to Signal Amplitude $\mathrm{V}_{\mathrm{A}}$ ) according to the application:

For lower power links: $\mathrm{I}_{\mathrm{B}}=0.5 \mathrm{~mA}$ and $\mathrm{K}=0.5$
For full power links: $I_{B}=1 \mathrm{~mA}$ and $K=0.5$
For long links $(>50 \mathrm{~m})$ : $\mathrm{I}_{\mathrm{B}}=1 \mathrm{~mA}$ and $K=0.25$
For addressable multidrop: $I_{B}=1 \mathrm{~mA}$ and $K=0.4$
For applications with little system noise, setting $\mathrm{I}_{\mathrm{B}}$ to 0.5 mA is a good compromise between power consumption and noise immunity. Using this $I_{B}$ setting with a $1: 1$ transformer and $R_{M}=100 \Omega, R_{B 1}$ should be set to 3.01 k and $R_{B 2}$ set to 1k. With typical CAT5 twisted pair, these settings will allow for communication up to 50 m . Applications in very noisy environments or with cables longer than 50 m should increase the $\mathrm{I}_{\mathrm{B}}$ to 1 mA . Higher drive current compensates for the increased insertion loss in the cable and provides high noise immunity. When using cables over 50 m and a transformer with a $1: 1$ turns ratio and $R_{M}=100 \Omega, R_{B 1}$ would be 1.5 k and $\mathrm{R}_{\mathrm{B} 2}$ would be $499 \Omega$.
The length of the cable determines the maximum clock rate of an isoSPI link. For cables 10 meters or less, the maximum $1 \mathrm{MHz} \mathrm{SPI} \mathrm{clock} \mathrm{frequency} \mathrm{is} \mathrm{possible}$. length of the cable increases, the maximum possible SPI clock rate decreases. This dependence is a result of the increased propagation delays that can create possible timing violations. Figure 29 shows how the maximum data rate reduces as the cable length increases when using a CAT5 twisted pair.


Figure 28. isoSPI Circuit

## APPLICATIONS INFORMATION



Figure 29. Data Rate vs Cable Length
Cable delay affects three timing specifications, $\mathrm{t}_{\text {LLK }}$, t 6 and t 7 . In the Electrical Characteristics table, each is derated by 100 ns to allow for 50 ns of cable delay. For longer cables, the minimum timing parameters obey the following relationship:

$$
\mathrm{t}_{\mathrm{CLK}}, \mathrm{t}_{6} \text { and } \mathrm{t}_{7}>0.9 \mu \mathrm{~s}+2 \bullet \mathrm{t}_{\text {CABLE }}(0.2 \mathrm{~m} \text { per ns })
$$

## Implementing a Modular isoSPI Daisy Chain

The hardware design of a daisy-chain isoSPI bus is identical for each device in the network due to the daisy-chain point to point architecture. Basic circuitry in Figure 28 shows
a nominally functional, but not optimized configuration. The termination resistor $\mathrm{R}_{\mathrm{M}}$ should be split and bypassed with a capacitor as shown in Figure 30. This change provides both a differential and common mode termination, and as such increases the system noise immunity. The use of cables between fuel cell modules, particularly in automotive applications, can lead to increased noise susceptibility in the communication lines. For high levels of electromagnetic interference (EMC), additional filtering is recommended. The circuit example in Figure 30 shows the use of common-mode chokes (CMC). The CMC provides the best common-mode noise rejection from transients present on the lines. Center tapped transformers will also provide additional noise performance. A bypass capacitor connected to the center tap creates a low impedance to the common mode noise (Figure 30a). Typically, center tapped transformers are more expensive than transformers without a center tap. Noise rejection of transformers without a center tap can be enhanced by adding $\sim 100 \mathrm{pF}$ bypass capacitance at the IC (Figure 30b). Large center tap capacitors greater than 10 nF should be avoided as they may prevent the isoSPI common mode voltage from settling. Common mode chokes similar to what are used in Ethernet or CAN bus applications are recommended, with some particular types suggested in Table 49.

a)

b)

Figure 30. Daisy Chain Interface Components

## LTC6806

## APPLICATIONS InFORMATION



Figure 31. Daisy Chain Interface Components on Single Board

## APPLICATIONS INFORMATION

The other main design consideration for a daisy chain is the number of devices in the network. The length of the chain will determine the serial timing as well as affect the data latency and throughput of the isoSPI network. The number of devices in a daisy chain has no limit as long as all serial timing requirements are met. The main limitations are the serial read back times and increased current consumption. For a daisy chain, twotiming considerations for proper operation dominate (see Figure 19):

1. T6, the time between the last clock and the rising chip select must be long enough.
2. T5, the time between commands, so the time from a rising chip select to the next falling chip select must be long enough.

Both T5 and T6 must be lengthened as the number of LTC6806 devices in the daisy chain increase. The equations for these times are below:

$$
\begin{aligned}
& \text { T5 > (\#Devices • 70ns) + 900nS } \\
& \text { T6 > (\#Devices • 70ns })+950 n S
\end{aligned}
$$

## Connecting a MCU to an LTC6806 with an isoSPI Data Link

The LTC6820 will convert standard 4 -wire SPI into a 2-wire isoSPI link that can communicate directly with the LTC6806. An example is shown in Figure 32. The LTC6820 can be used in applications to provide isolation between the microprocessor and the stack of LTC6806s. The LTC6820 also enables system configurations that have the BMS controller at a remote location relative to the LTC6806 devices and the fuel cell pack.


Figure 32. Interfacing an LTC6806 with a $\mu$ P Using a LTC6820 for Isolated SPI Control

## APPLICATIONS INFORMATION

## Connecting Multiple LTC6806s on the Same PCB in a Daisy Chain

When connecting multiple LTC6806 devices on the same PCB, only a single transformer needs to connect LTC6806 daisy-chain isoSPI ports. The absence of the cable also reduces the noise levels on the communication lines and often only a split termination is required. Figure 31 shows an example application that has multiple LTC6806s on the same PCB with communication to the bottom MCUthrough a LTC6820 isoSPI driver. While no center tap is required, if a transformer with a center tap is being used, a capacitor can be added for better noise rejection. If additional noise
filtering is required, the noise filters shown in Figure 30 can be implemented and discrete common mode chokes can be added to either side of the single transformer.

On single board designs with low noise requirements, it is possible for a simplified capacitor-isolated coupling as shown in Figure 33 to replace the transformer. Dual Zeners are used at each IC to clamp the common mode voltage to stay within the receivers input range. The common mode choke (CMC) provides high frequency noise rejection with the split terminations. The $590 \Omega$ resistor serves to create a resistor divider with the termination resistors to attenuate low frequency common mode noise.


Figure 33. Capacitive Isolation Coupling for LTC6806s on the Same PCB.

## APPLICATIONS INFORMATION

Configuring the LTC6806 in a Multi-Drop isoSPI Link
The addressing feature of the LTC6806 allows multiple devices to be connected to a single isoSPI master by distributing them along one twisted pair, essentially creating a large parallel SPI network. Figure 34 shows a basic multidrop system with the twisted pair being terminated only at the beginning (master) and the end. In between, the additional LTC6806s connect to short stubs on the twisted pair. These stubs should be kept short, with as
little capacitance as possible, to avoid degrading the termination along the isoSPI wiring. When an LTC6806 is not addressed, it will not transmit data pulses. This scheme eliminates the possibility for collisions, as only the addressed device will ever be returning data to the master. Generally, multidrop systems are best confined to compact assemblies to avoid excessive isoSPI pulsedistortion and EMC pickup.


Figure 34. A Simplified Multi-Drop Implementation with a LTC6806 Array

## APPLICATIONS InFORMATION

## Basic Connection of the LTC6806 in a Multi-Drop Configuration

In a multi-drop isoSPI bus, placing the termination at the ends of the live transmission line will have the best performance (with $100 \Omega$ typically). Each of the LTC6806 and LTC6820 isoSPI ports should couple to the bus with through networks as shown in Figure 35. With center-tapped transformers, Figure 35 a offers the best performance; a common-mode-choke is increase the noise rejection further. Figure 35 also shows the used of an RC snubber at the IC connections as a means to suppress resonances (the IC capacitance provides sufficient out-of-band rejection). When using a non-center-tapped transformer, a virtual CT can be generated by connecting a CMC as a voltage-splitter as indicated in Figure 35b. In both configurations, series resistors are used to tap the actual isoSPI bus transmission lines to decouple the IC and board parasitic capacitances from the transmission line. Reducing parasitics on the transmission line minimizes reflections and pulse distortion. Note resistances and pin connections of the isoSPI programming resistors in this mode.

## Transformer Selection Guide

As shown in Figure 28, a transformer or pair of transformers isolate the isoSPI signals between two isoSPI ports. The isoSPI signals have programmable pulse amplitudes up to $1.6 \mathrm{~V}_{\text {P-p }}$ and pulse widths of 50 nS and 150 nS . To be able to transmit these pulses with the necessary fidelity, the system requires that the transformers have primary inductances above $60 \mu \mathrm{H}$ and a $1: 1$ turns ratio. It is also necessary to use a transformer with less than $2.5 \mu \mathrm{H}$ of leakage inductance. In terms of pulse shape the primary inductance mostly affects the pulse droop of the short isoSPI pulses. If the primary inductance is too low, the pulse amplitude will begin to droop and decay over the pulse period. When the pulse droop is severe enough, the effective pulse width seen by the receiver will drops substantially, reducing noise margin. Some droop is acceptable as long as it is a relatively small percentage of the total pulse amplitude. The leakage inductance primarily affects the rise and fall times of the pulses. Slower rise and fall times reduce the pulse width. Pulse width is determined by the receiver as the time the signal is above the threshold set by the ICMP pin. Slow rise and


Figure 35. Preferred isoSPI Bus Couplings for Use with LTC6806 and LTC6820

## APPLICATIONS INFORMATION

## Table 48. Recommended Transformers

| Supplier | Part Number | Temp Range | Vworking | Vhipot/60s | CT | CMC | H | L | W (w/ leads) | Pins | AEC-Q200 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Bourns | SM91501AL | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 1000V | 4.3 kVdc | $\bullet$ | $\bullet$ | 5.0 mm | 15.0 mm | 14.7 mm | 12SMT | $\bullet$ |
| Bourns | SM13105L (AS4562) | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 1600 V | 4.3 kVrms | $\bullet$ | $\bullet$ | 5.0 mm | 15.0 mm | 27.9 mm | 12SMT | - |
| Bourns | US4374 | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 950 V | 4.3 kVdc | $\bullet$ | $\bullet$ | 4.9 mm | 15.6 mm | 24.0 mm | 12SMT | $\bullet$ |
| Jingweida | S12502BA | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 1000 V | 4.3 kVdc | $\bullet$ | $\bullet$ | 5.0 mm | 14.8 mm | 14.8 mm | 12SMT | $\bullet$ |
| Halo | TG110-AE050N5LF | $\begin{aligned} & \hline-40^{\circ} \mathrm{C} \text { to } \\ & 85 / 125^{\circ} \mathrm{C} \end{aligned}$ | 60V (est) | 1.5 kVrms | $\bullet$ | $\bullet$ | 6.4 mm | 12.7 mm | 9.5 mm | 16SMT | $\bullet$ |
| Sumida | CLP178-C20114 | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 1000 V (est) | 3.75 kVrms | $\bullet$ | $\bullet$ | 9 mm | 17.5 mm | 15.1 mm | 12SMT | - |
| Sumida | CLP0612-C20115 |  | 600Vrms | 3.75 kVrms | $\bullet$ | - | 5.7 mm | 12.7 mm | 9.4 mm | 16SMT | - |
| Pulse | HM2100NL | $-40^{\circ} \mathrm{C}$ to $105^{\circ} \mathrm{C}$ | 1000V | 4.3kVdc | - | $\bullet$ | 3.5 mm | 14.7 mm | 15.0 mm | 10SMT | $\bullet$ |
| Pulse | HM2112ZNL | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 1600 V | 4.3 kVdc | $\bullet$ | $\bullet$ | 3.5 mm | 14.7 mm | 15.5 mm | 12SMT | $\bullet$ |
| Pulse | HX1188FNL | $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ | 60 V (est) | 1.5 kVrms | $\bullet$ | $\bullet$ | 6.0 mm | 12.7 mm | 9.7 mm | 16SMT | - |
| Pulse | HX0068ANL | $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ | 60 V (est) | 1.5 kVrms | $\bullet$ | $\bullet$ | 2.1 mm | 12.7 mm | 9.7 mm | 16SMT | - |
| Wurth | 7490140110 | $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ | 250Vrms | 4kVrms | $\bullet$ | $\bullet$ | 10.9 mm | 24.6 mm | 17.0 mm | 16SMT | - |
| Wurth | 7490140111 | $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$ | 1000 V (est) | 4.5 kVrms | $\bullet$ | - | 8.4 mm | 17.1 mm | 15.2 mm | 12SMT | - |
| Wurth | 749014018 | $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$ | 250Vrms | 4kVrms | $\bullet$ | $\bullet$ | 8.4 mm | 17.1 mm | 15.2 mm | 12SMT | - |

Recommended Single Transformers

| Supplier | Part Number | Temp Range | Vworking | Vhipot/60s | CT | CMC | H | L | W (w/ leads) | Pins | AEC-Q200 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Bourns | SM91502AL | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 1000 V | 4.3 kVdc | $\bullet$ | $\bullet$ | 6.5 mm | 8.5 mm | 8.9 mm | 6SMT | $\bullet$ |
| Bourns | SM13102AL (US4195) | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 800 V | 4kVrms | $\bullet$ | $\bullet$ | 3.8 mm | 11.6 mm | 21.1 mm | 6SMT | - |
| Halo | TD04-QXLTAW | $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ | 1000 V (est) | 5 kVrms | $\bullet$ | - | 8.6 mm | 8.9 mm | 16.6 mm | 6TH | - |
| Halo | TGR04-6506V6LF | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 300 V | 3kVrms | $\bullet$ | - | 10 mm | 9.5 mm | 12.1 mm | 6SMT | - |
| Halo | TGR04-A6506NA6NL | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 300 V | 3kVrms | $\bullet$ | - | 9.4 mm | 8.9 mm | 12.1 mm | 6SMT | $\bullet$ |
| Halo | TDR04-A550ALLF | $-40^{\circ} \mathrm{C}$ to $105^{\circ} \mathrm{C}$ | 1000 V | 5 kVrms | $\bullet$ | - | 6.4 mm | 8.9 mm | 16.6 mm | 6TH | $\bullet$ |
| Jingweida | S06107BA | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 1000 V (est) | 4.3 kVdc | $\bullet$ | $\bullet$ | 6.3 mm | 7.6 mm | 9.9 mm | 6SMT | - |
| Pulse | HM2101NL | $-40^{\circ} \mathrm{C}$ to $105^{\circ} \mathrm{C}$ | 1000 V | 4.3kVdc | - | $\bullet$ | 5.7 mm | 7.6 mm | 9.3 mm | 6SMT | - |
| Pulse | HM2113ZNL | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 1600 V | 4.3 kVdc | $\bullet$ | $\bullet$ | 3.5 mm | 9 mm | 15.5 mm | 6SMT | $\bullet$ |
| Sumida | CEEH96BNP-LTC6804/11 | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 600 V | 2.5 kVrms |  | - | 7 mm | 9.2 mm | 12.0 mm | 4SMT | - |
| Sumida | CEP99NP-LTC6804 | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 600 V | 2.5 kVrms | $\bullet$ | - | 10 mm | 9.2 mm | 12.0 mm | 8SMT | - |
| Sumida | ESMIT-4180/A | $-40^{\circ} \mathrm{C}$ to $105^{\circ} \mathrm{C}$ | 250 Vrms | 3kVrms | - | - | 3.5 mm | 5.2 mm | 9.1 mm | 4SMT | $\bullet$ |
| Sumida | ESMIT-4187 | $-40^{\circ} \mathrm{C}$ to $105^{\circ} \mathrm{C}$ | $>400 \mathrm{Vrms}$ (est) | 2.5 kVrms | - | - | 3.5 mm | 7.5 mm | 12.8 mm | 4SMT | $\bullet$ |
| TDK | VMT40DR-201S2P4 | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 600 V (est) | 3.4 kVdc | $\bullet$ | - | 4.0 mm | 8.5 mm | 13.8 mm | 6SMT | - |
| TDK | ALT4532V-201-T001 | $-40^{\circ} \mathrm{C}$ to $105^{\circ} \mathrm{C}$ | 80 V | $\sim 1 \mathrm{kV}$ | $\bullet$ | - | 2.9 mm | 3.2 mm | 4.5 mm | 6SMT | $\bullet$ |
| TDK | VGT10/9EE-204S2P4 | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 700V | 2.8 kVrms | $\bullet$ | - | 10.6 mm | 10.4 mm | 12.6 mm | 8SMT | $\bullet$ |
| Sunlord | ALTW0806C-C03 | $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | 300 V (est) | 3kVrms | $\bullet$ | - | 8.8 mm | 6.3 mm | 8.9 mm | 6SMT | $\bullet$ |
| Wurth | 750340848 | $-40^{\circ} \mathrm{C}$ to $105^{\circ} \mathrm{C}$ | 250 V | 3kVrms | - | - | 2.2 mm | 4.4 mm | 9.1 mm | 4SMT | - |
| XFMRS | XFBMC29-BA09 | $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ | 1600 V (est) | 2.9 kVrms | $\bullet$ | $\bullet$ | 5.0 mm | 10.0 mm | 19.5 mm | 6SMT | $\bullet$ |

## LTC6806

## APPLICATIONS INFORMATION

fall times cut into the timing margins. Generally it is best to keep pulse edges as fast as possible. When evaluating transformers, it is also worth noting the parallel winding capacitance. While transformers have very good CMRR at low frequency, this rejection will degrade at higher frequencies due to the winding to winding capacitance. When choosing a transformer, it is best to pick one with minimal winding capacitance.

When choosing a transformer, it is equally important to pick a part that has an adequate isolation rating for the application. The working voltage rating of a transformer is a key spec when selecting a part for an application. Interconnecting daisy-chain links between LTC6806 daisy-chain devices see <60V stress in typical applications; ordinary pulse and LAN type transformers will suffice. Multi-drop connections and connections to the LTC6820 in general may need much higher working voltage ratings for good long term reliability. Usually matching the working voltage to the voltage of the entire fuel cell stack is conservative. Unfortunately, transformer vendors often specify only one-
second HV testing. This rating is not equivalent to the long term (permanent) rating of the part. For example, according to most safety standards a 1.5 kV rated transformer is expected to handle 230 V continuously, and a 3 kV device is capable of 1100 V long term, though manufacturers may not always certify to those levels (refer to actual vendor data for specifics). Usually the higher voltage transformers are called high isolation or reinforced insulation types by the suppliers. Table 48 shows a list of transformers that have been evaluated in isoSPI links.

In most applications a common mode choke (CMC) is also necessary for noise rejection. Table 49 includes a list of suitable CMCs if the CMC is not already integrated into the transformer being used.

Table 49. Recommended Common Mode Chokes

| MANUFACTURER | PART NUMBER |
| :---: | :---: |
| TDK | ACT45B-101-2P |
| Murata | DLW43SH101XK2 |

## APPLICATIONS INFORMATION

## isoSPI Layout Guidelines

Layout of the isoSPI signal lines also plays a significant role in maximizing the noise immunity of a data link. The following layout guidelines are recommended:

1. The transformer should be placed as close to the isoSPI cable connector as possible. The distance should be kept less than 2 cm . The LTC6806 should be placed close to the transformer to minimize loss. However, leave at least 1 cm to 2 cm between the transformer and LTC6806 to isolate the IC from magnetic field coupling.
2. A $\mathrm{V}^{-}$ground plane should not extend under the transformer, the isoSPI connector, nor in between the transformer and the connector.
3. The isoSPI signal traces should be as direct as possible while isolated from adjacent circuitry by ground metal or space. No traces should cross the isoSPI signallines, unless separated by a ground plane on an inner layer.

## Calculating Serial Throughput

For any given LTC6806 the calculation to determine communication time is simple: it is the number of bits in the transmission multiplied by the SPI clock period being used. The control protocol of the LTC6806 can be organized in such as way that almost all commands can be categorized as a write, read or an operation. The tables below can be used to determine the number of bits in a given LTC6806 command. Table 50 can be used for daisy chains and Table 51 for multi-drop networks.

Table 50. Daisy-Chain Serial Equations

| COMMAND TYPE | CMD BYTES + CMD PEC | DATA BYTES <br> + DATA PEC PER IC | TOTAL BITS | COMMUNICATION TIME |
| :--- | :---: | :---: | :---: | :---: |
| Read | 4 | 8 | $(4+(8 \bullet \# I C s)) \bullet 8$ | Total Bits •Clock Period |
| Write | 4 | 8 | $(4+(8 \bullet \# I C s)) \bullet 8$ | Total Bits •Clock Period |
| Operation | 4 | 0 | $4 \bullet 8=32$ | $32 \bullet$ Clock Period |

Table 51. Multi-Drop Serial Time Equations

| COMMAND TYPE | CMD BYTES + CMD PEC | DATA BYTES <br> + DATA PEC PER IC | TOTAL BITS | COMMUNICATION TIME |
| :--- | :---: | :---: | :---: | :---: |
| Read | 4 | 8 | $((4+8) \bullet \# I C s) \bullet 8$ | Total Bits $\bullet$ Clock Period |
| Write | 4 | 8 | $((4+8) \bullet \# I C s) \bullet 8$ | Total Bits $\bullet$ Clock Period |
| Operation | 4 | 0 | $4 \bullet 8=32$ | $32 \bullet$ Clock Period |

## APPLICATIONS InFORMATION

## Protection Components Between the Cell Stack and the C Inputs

ESD protection in the LTC6806 on the cell channels arises from bidirectional SCR devices from each C pin directly to $\mathrm{V}^{-}$. The positive SCR voltages are graduated, starting at 80 V on the lower C inputs and rising to 150 V on the upper C inputs as shown in Figure 36. Negative SCR voltages vary, but are all in excess of the abs max rating of -20 V . Internal $150 \mathrm{k} \Omega$ series resistance between the C pins and internal circuitry provides robust ESD performance and limits input current.

System design must take into account the absolute maximum voltage ratings on each pin and provide external clamps and series resistance if there is a chance that electrical overstress above the absolute maximum ratings will be applied to any pin.

## FILTERING OF CELL AND GPIO INPUTS

The LTC6806 uses a delta-sigma ADC with a delta sigma modulator followed by a SINC2 finite impulse response (FIR) digital filter. This ADC method greatly reduces input filtering requirements. Furthermore, the programmable oversampling ratio allows the user to determine the best trade-off between measurement speed and filter cutoff frequency. Even with this high order low pass filter, however, fast transients can still induce some residual noise in measurements, especially in the faster conversion modes. Addition of an RC low pass filter at each ADC input can reduce noise sensitivity and help to reject potentially damaging high energy transients.


Figure 36. Internal ESD Protection Diagram

## APPLICATIONS InFORMATION

For applications that demand the highest level of voltage ripple rejection, grounded capacitor filtering is recommended. This configuration uses a series resistors and capacitors that decouple HF noise to V-. The capacitors in this circuit require adequate voltage rating inasmuch as they directly connect between C pins and ground.

In systems where noise is less periodic or higher oversample rates are in use, a differential capacitor filter structure is adequate. In this configuration, there are series resistors to each input, but the capacitors connect between the adjacent C pins. However, the differential capacitor sections interact. As a result, the filter response is less consistent and results in less attenuation than predicted by the RC, by approximately a decade. Note that the capacitors only see one cell of applied voltage (thus smaller and lower cost) and tend to distribute transient energy uniformly across the IC (reducing stress events on the internal protection structures).
The LTC6806 can accommodate a wide range of external filter components on both the C and GPIO pins if a few simple principles are followed.

## C Pins

Adjacent C pins combine to present approximately 300k differential resistance, and sink approximately $35 \mu$ A perpin when a cell voltage is being measured. When the device is in standby or sleep modes, C pins held at OV or higher common mode voltage will leak less than $1.6 \mu \mathrm{~A}$. C pins held below 0 V common mode may source up to $550 \mu \mathrm{~A}$ depending on the cell voltage and mode. Please refer to the $I_{L M}$ and $I_{\text {LO }}$ parameters in the specification table, and the graph showing LTC6806 Typical Input Current vs Cell Common Mode Voltage in the Typical Performance Characteristics section for more information.

The LTC6806 is designed to accommodate a wide range of series resistance between each fuel cell connection and the corresponding C pin for signal filtering and input protection. If values 1 k or greater are used, it may be necessary for the user to make an accuracy correction to the gain based on the voltage divider ratio $1+\mathrm{R}_{\text {IN }} / 150 \mathrm{k}$ where $R_{I N}$ is the differential resistance in series with the $C$ pin.

A capacitance of up to $1 \mu \mathrm{~F}$ may be used across adjacent C pins for noise filtering purposes. During Open Wire Detection, this capacitance must be charged in order to sense an open circuit, making it necessary to activate open wire detect for some time period before performing cell readings. With a $0.1 \mu \mathrm{~F}$ filter capacitor, this time is approximately 10 ms . Refer to Table 16 ( Open Wire Pre-charge Configurations ) as a guide for how much time should be chosen in open wire detection as a function of capacitance.
Input filter capacitance can also effect accuracy, depending on the RC time constant ( $t_{\text {RC }}$ ). Small input filter capacitance values where $t_{\mathrm{RC}}$ is significantly less than the sampling time will converge toward the calculated error factor. Larger input filter capacitance values where $t_{R C}$ is significantly larger than the sampling time will converge toward the uncorrected result.

## GPIO Pins

Because the GPIO pins are not measured during open wire detection, filter capacitance is not limited. There is an equivalent input impedance of about $600 \mathrm{k} \Omega$ when the GPIO pins are being read by the ADC. Accuracy depends on the source impedance of circuitry driving the GPIO pins in relation to 600k.

## Correcting Filter Resistor Induced Gain Error

RC filters connecting to $C$ pins are frequently used for noise rejection and overvoltage protection, as shown in Figure 37. Because LTC6806 sinks or sources currents from $C$ pins during cell measurement, the IR drops across the filter resistor will affect the system gain. The gain error introduced by the external resistor can be corrected by simply multiplying the cell measurement data with a gain correction factor:

$$
\mathrm{G}=\frac{150 \mathrm{k} \Omega+\mathrm{R}}{150 \mathrm{k} \Omega}
$$

where $R$ stands for the total resistance between a battery node and the $C$ pin the node connects to. For example, when choosing $1 \mathrm{k} \Omega$ filter resistor as shown in Figure 37, the gain correction factor will be:

## APPLICATIONS InFORMATION

$$
\mathrm{G}=\frac{150 \mathrm{k} \Omega+1 \mathrm{k} \Omega}{150 \mathrm{k} \Omega} \approx 1.0067
$$

The $150 \mathrm{k} \Omega$ represents the internal resistor connected to each $C$ pin. Notice that the gain error correcting scheme applies to both HiRng and LoRng mode. The above gain correction should be applied when using little or no filter capacitance at the $C$ pins. When using large filter capacitance, such as $\geq 22 \mathrm{nF}$, the error is negligible and gain correction may not be necessary.


Figure 37.

## Using the LTC6806 with Fewer than 36 Cells

The LTC6806 may be used with fewer than 36 inputs; however, care should be exercised to ensure that all cell pin voltage restrictions are followed. It is recommended that the upper $C$ pins should be populated and the unused C pins be shorted to $\mathrm{V}^{+}$.

The maximum voltage applied between the C pins and $\mathrm{V}^{-}$is graduated, with higher numbered $C$ pins having a higher limit. Please refer to the Electrical Characteristic table and Absolute Maximum Ratings tables for more information.
The LTC6806 measurement cycle will continue to measure voltages on the unused C pins; unused pins may NOT be left floating. In the MONITOR state the LTC6806 will start each monitor cycle by measuring the cell specified by FCHNL in the Configuration Register Group and continue measuring all cells up to cell 36.

## ENHANCED APPLICATIONS

## Reading External Temperature Probes

The $V_{\text {REF2 }}$ pin of the LTC6806 can be used to provide currents of up to 1 mA in order to drive thermistors or diodes used for external temperature sensing, which may then be monitored through the GPIO pins.
Because $V_{\text {REF2 }}$ is not as accurate as $V_{\text {REF1 }}$, these temperature measurements are most accurately made by reading both the GPIO pin and the internally monitored $V_{\text {REF2 }}$ voltage, and deriving the temperature reading from the ratio of the two measurements.

Figure 38 shows the typical biasing circuit for a negative-temperature-coefficient (NTC) thermistor. The $10 \mathrm{k} \Omega$ at $25^{\circ} \mathrm{C}$ is the most popular sensor value and the $\mathrm{V}_{\text {REF2 }}$ output stage is designed to provide the current required to bias several of these probes. The biasing resistor is selected to correspond to the NTC value so the circuit will provide 1.25 V at $25^{\circ} \mathrm{C}\left(\mathrm{V}_{\text {REF2 }}\right.$ is 2.5 V nominal). The overall circuit response is approximately $-1 \% /{ }^{\circ} \mathrm{C}$ in the range of typical cell temperatures, as shown in the chart of Figure 38.



Figure 38. Typical Temperature Probe Circuit and Relative Output

## APPLICATIONS INFORMATION

## Current Measurement with a Hall Effect Sensor

The LTC6806 auxiliary ADC inputs (GPIO pins) may be used for any analog signal measurement, including those from various active sensors that have 0 V to 5 V analog outputs. One classic example is sensing of fuel cell stack current. Hall-effect sensors are popular for measuring large currents since the technology provides an isolated, low power dissipation solution. Figure 39 shows schematically a typical Hall sensor that produces two outputs that proportion to the $\mathrm{V}_{C C}$ provided. The sensor in the figure has two bidirectional outputs centered at half of supply, CH 1 is a 0 A to 50 A low range and CH 2 is a 0 A to 200 A high range. The sensor is powered from a 5 V source and produces analog outputs that are connected to GPIO pins. The use of GPIO1 and GPIO2 as the ADC inputs has the possibility of being digitized within the same conversion sequence as the sum-of-cells (using the ADAXSC command), thus synchronizing cell voltage and cell current measurements.


Figure 39. Interfacing a Typical Hall-Effect Current Sensor to Auxiliary ADC Inputs

## Monitoring Multiple Fuel Cells on a Single Channel

The LTC6806 is capable of monitoring multiple fuel cells per cell channel. This capability allows the system to monitor more than 36 fuel cells per IC. Monitoring multiple fuel cells per channel reduces the system's ability to determine the exact voltage of the individual fuel cells. However, the system will still be able to determine whether any fuel cell is operating within its expected voltage range. The LTC6806 has two measurement ranges: a low range that measures from -2.5 V to 2.5 V and a high range that measures from -5 V to 5 V . In low range the LTC6806 is capable of monitoring up to two 1.2 V fuel cells, while in high range (HIRNG $=1$ ) the part is capable of monitoring up to four 1.2V fuel cells. Figure 40 show the LTC6806 monitoring 4 cells per channel. Setting the correct ADC measurement range is the only design action required. The $C$ pin filter and protection circuits are identical when monitoring single fuel cell or multiple fuel cells.


Figure 40. Monitoring Up to Four Cells per Channel

## APPLICATIONS Information

## Using the LTC6806 in Monitor Mode

The LTC6806 can be programmed to independently monitor the $C$ pins for under and overvoltage faults without constant interaction with the controlling MCU. In monitor mode GPI01 and GPIO2 can be used as general purpose analog fault flags. In the independent monitor mode, faults can be detected either by reading the device registers or
by monitoring the GPIO pins. Figure 41 shows the GPIOs interfacing with opto-couplers so that an isolated MCU can monitor the fuel cells state independently of the isoSPI port. Figure 41 also shows GPI01 and GPIO2 configured to monitor the fuel cell system for overtemperature conditions. Two standard 10k thermistors are used and the second resistor is chosen so that the voltage on the GPIO pin will be $\mathrm{V}_{\mathrm{REF}} / 2$ at the overtemperature threshold.


Figure 41. Monitor Mode Connections

## PACKAGG DESCRIPTION

LW Package
64-Lead Plastic LQFP ( $10 \mathrm{~mm} \times 10 \mathrm{~mm}$ )
(Reference LTC DWG \#05-08-1539 Rev Ø)


SECTION A - A
NOTE:

1. DIMENSIONS ARE IN MILLIMETERS

DIMENSIONS OF PACKAGE DO NOT INCLUDE MOLD FLASH MOL FLASH
PIN-1 INDENTIFIER IS A MOLDED INDENTATION, 0.50 mm DIAMETER
DIMENSIONS OF PACKAGE DO NOT INCLUDE MOLD FLASH. MOLD FLASH 4. DRAWING IS NOT TO SCALE SHALL NOT EXCEED 0.25 mm ON ANY SIDE. IF PRESENT

## RELATED PARTS

| PART NUMBER | DESCRIPTION | COMMENTS |
| :--- | :--- | :--- |
| LTC6810 | 4th Generation 6-Cell Battery Stack <br> Monitor and Balancing IC | Measures Cell Voltages for Up to 6 Series Battery Cells. The isoSPI Daisy-Chain <br> Capability Allows Multiple Devices to be Interconnected for Measuring Many Battery Cells <br> Simultaneously. The isoSPI Bus can Operate Up to 1MHz and can be Operated Bidirectionally <br> for Fault Conditions, such as a Broken Wire or Connector. Includes Internal Passive <br> CellBalancing Capability of up to 150mA. |
| LTC6811 | 4th Generation 12-Cell Battery Stack <br> Monitor and Balancing IC | Measures Cell Voltages for Up to 12 Series Battery Cells. The isoSPI Daisy-Chain <br> Capability Allows Multiple Devices to be Interconnected for Measuring Many Battery Cells <br> Simultaneously. The isoSPI Bus can Operate Up to 1MHz. Includes Internal Passive <br> CellBalancing Capability of up to 30mA. |
| LTC6812 | 4th Generation 15-Cell Battery Stack <br> Monitor and Balancing IC | Measures Cell Voltages for Up to 15 Series Battery Cells. The isoSPI Daisy-Chain <br> Capability Allows Multiple Devices to be Interconnected for Measuring Many Battery Cells <br> Simultaneously. The isoSPI Bus can Operate Up to 1MHz and can be Operated Bidirectionally <br> for Fault Conditions, such as a Broken Wire or Connector. Includes Internal Passive <br> CellBalancing Capability of up to 200mA. |
| LTC6813 | 4th Generation 18-Cell Battery Stack <br> Monitor and Balancing IC | Measures Cell Voltages for Up to 18 Series Battery Cells. The isoSPI Daisy-Chain <br> Capability Allows Multiple Devices to be Interconnected for Measuring Many Battery Cells <br> Simultaneously. The isoSPI Bus can Operate Up to 1MHz and can be Operated Bidirectionally <br> for Fault Conditions, such as a Broken Wire or Connector. Includes Internal Passive <br> CellBalancing Capability of up to 200mA. |
| LTC6820 | isoSPI Isolated Communications <br> Interface | Provides an Isolated Interface for SPI Communication Up to 100 Meters Using a Twisted Pair <br> Companion to the LTC6804 |

## X-ON Electronics

Largest Supplier of Electrical and Electronic Components
Click to view similar products for Power Management IC Development Tools category:
Click to view products by Analog Devices manufacturer:
Other Similar products are found below :
EVAL-ADM1168LQEBZ EVB-EP5348UI MIC23451-AAAYFL EV MIC5281YMME EV DA9063-EVAL ADP122-3.3-EVALZ ADP130-0.8-EVALZ ADP130-1.2-EVALZ ADP130-1.5-EVALZ ADP130-1.8-EVALZ ADP1714-3.3-EVALZ ADP1716-2.5-EVALZ ADP1740-1.5EVALZ ADP1752-1.5-EVALZ ADP1828LC-EVALZ ADP1870-0.3-EVALZ ADP1871-0.6-EVALZ ADP1873-0.6-EVALZ ADP1874-0.3EVALZ ADP1882-1.0-EVALZ ADP199CB-EVALZ ADP2102-1.25-EVALZ ADP2102-1.875EVALZ ADP2102-1.8-EVALZ ADP2102-2EVALZ ADP2102-3-EVALZ ADP2102-4-EVALZ ADP2106-1.8-EVALZ ADP2147CB-110EVALZ AS3606-DB BQ24010EVM BQ24075TEVM BQ24155EVM BQ24157EVM-697 BQ24160EVM-742 BQ24296MEVM-655 BQ25010EVM BQ3055EVM NCV891330PD50GEVB ISLUSBI2CKIT1Z LM2744EVAL LM2854EVAL LM3658SD-AEV/NOPB LM3658SDEV/NOPB LM3691TL$\underline{1.8 E V / N O P B}$ LM4510SDEV/NOPB LM5033SD-EVAL LP38512TS-1.8EV EVAL-ADM1186-1MBZ EVAL-ADM1186-2MBZ

